



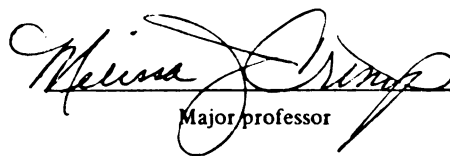


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Prediction of Colloidal Suspension Stability  
for SiC/Si<sub>3</sub>N<sub>4</sub> and FeAl/Al<sub>2</sub>O<sub>3</sub> Fiber Systems  
Using Material and System Parameters  
presented by

Brett Allen Wilson

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M.S. degree in Materials Science

  
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Prediction of Colloidal Suspension Stability  
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Using Material and System Parameters.

By

Brett Allen Wilson

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## ABSTRACT

### Prediction of Colloidal Suspension Stability for SiC/Si<sub>3</sub>N<sub>4</sub> and FeAl/Al<sub>2</sub>O<sub>3</sub> Fiber Systems Using Material and System Parameters.

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In this investigation a method to predict the stability of multicomponent colloidal suspensions at different pH values from system and material data such as particle size, volume fraction, electrolyte concentration, zeta potential verses pH, and Hamaker constant data was developed from an existing method. A computer program was written and used for a SiC/Si<sub>3</sub>N<sub>4</sub> powder system. The predictions of stability ranges were found to be within a half a pH unit of actual stability ranges as found from sedimentation results, but was dependent upon accurate zeta potential data. The dependency of the program on temperature variations, relative component volume fraction variations, and the accuracy of the input Hamaker constants was examined. For a FeAl/Al<sub>2</sub>O<sub>3</sub> fiber composite, the method the predicted ideal processing conditions when the components were mixed at pH 5 followed by an increase to pH 8, which would prevent differential separation of the components.

## DEDICATION

To my Mom and Dad  
without whom, for me, none of this would have been possible.

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## INTRODUCTION

Advanced ceramic materials are currently being used in an increasing number of different fields. Areas in which ceramics are presently found include electronics, dentistry, automotive engines, industrial tooling, and biological prostheses. Within these different fields ceramics are being used in a wider variety of applications. In electronics, for example, ceramic uses vary from electrical insulation to chip carriers and substrates to piezoelectrics to superconductors.

The vast majority of ceramic materials are made by the processing of raw material powders into a green body and subsequent heat treatment of the green body, which causes the elimination of pores, densification, and microstructural development. Uniformity in the green compact is very important since it governs the microstructures of the final sintered body, and the microstructure of the final body determine the resulting properties of the body, such as mechanical strength and various electrical and magnetic properties. Problems with advanced ceramics arise from difficulties in the ability to repeatedly process ceramics with identical microstructures and properties. The

formation of non-uniform ceramics is caused by inhomogeneities which are the result of unsuccessfully making a uniform green body. Agglomerates are one of the main causes of inhomogeneities since they tend to cause the formation of a non-uniform green body containing an uneven distribution of pores and a change in the pore size distribution due to resulting larger pores. The preparation of well dispersed, stable suspensions help alleviate the problems caused by agglomeration and lead to the formation of a uniform green body and consequently result in better sintered bodies. It therefore becomes important to increase control of the processing in order to reduce microstructural defects and to maximize reliability.

Processing of ceramics can be divided into three areas. First is powder formation, then dispersion of the powder, and finally powder packing during drying and compaction. The dispersion of the powder consists of two elements: dispersion of the powder into a suspension and the stability of the suspension. While ideally it is desirable to have a disperse, stable suspension in order to improve the final microstructure by removing agglomerates, new processing methods contain steps which call for switching from stable suspensions to unstable coagulated suspensions containing large loosely bound agglomerates and switching back to a stable suspension. Coagulated suspensions with loosely bound agglomerates prevent segregation of the different

system components and make it possible to remove excess salts and surfactants by washing. Due to the marked importance of preparing stable suspensions and the combined use of stable and unstable suspensions, the prediction of the stability of ceramic suspensions would be an important tool to aid in the control of processing advanced ceramics.

Pioneering work in this area was done in the 1940's and is known as DLVO theory. This theory describes the total interaction energy between particles in a single component suspension. From this information some insight into the stability behavior of the suspension can be inferred. However, with the increasing use of multi-component systems due to the addition of reinforcements and of processing additives (e.g. sintering aids, stabilizers, composites, etc.), it is necessary to develop a theory for the prediction of the stability of multi-component systems. While work has been done to develop theories to predict the stability behavior of two-component systems, the majority of the application and experimental verification of these theories has been done by colloid chemists with little work done with advanced ceramic systems. This demonstrates the need for further research in this area of ceramics.

The following work will investigate the stability behavior of multi-component ceramic systems. The prediction of their stability will be examined by inputting system and material data (such as pH, electrolyte concentration,

particle size, Hamaker constant, and zeta potential) into a computer program which uses a method that is an adaptation of a method originally developed by Healy, Hogg, and Fuerstenau from the pioneering DLVO theory, while experimental investigations will examine their actual stability states.



## LITERATURE REVIEW

The vast majority of ceramic materials are made by the processing of raw material powders into a green body, followed by subsequent heat treatment of the green body which causes the elimination of pores, densification, and microstructural developments (1). Uniformity in the green body is very important since it governs the microstructures of the final sintered body (2, 3), which in turn determines the resulting properties of the body, such as mechanical strength, and various electrical and magnetic properties (4-6). The formation of non-uniform ceramics is caused by inhomogeneities which are mainly the result of the formation of agglomerates of particles in the ceramic suspension (8, 9). New processing methods use temporary aggregation of the suspension in order to prevent segregation of the system components between processing steps (9-11). The prediction of the state of aggregation would therefore be an important tool in the control of processing advanced ceramics.

The knowledge gained in predicting the stability of ceramic suspensions may be readily applied to a wide variety of other applications where similar colloid theory is being

applied. Such applications include selective flocculation in waste treatment (12-15), biological/medical studies of blood coagulation (16) and cholesterol stability (17), paint stability (18) and retention (19), and deposition and adhesion of material coatings (20-22).

To understand colloidal suspension stability, it is first important to elaborate on what is a colloidal suspension. The first important characteristic of a colloidal suspension is the size of the particles. For the case of a ceramic colloidal suspension, which is a lyophobic solid in a liquid, the size of the solid particles should be large enough so that they are not considered to be in solution with the liquid and small enough so that they are affected by collisions with the liquid (23). There is no absolute size range for colloidal particles (23, 24); however, a range of 1 nm to 1  $\mu\text{m}$  is often regarded as the typical range for a colloidal suspension (15, 23, 24). Because of the small size of particles in a colloidal suspension another important characteristic of these suspensions is that the particles, because of their small size, have a large surface area when compared to their volume (23, 25).

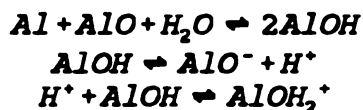
Another important characteristic of colloidal particles is that when the particles are put in the suspending liquid they develop a surface charge. There are several different ways in which this charge is developed which all depend on

the specific chemistry and thermodynamics of the system (the system includes the particle surface, the liquid, and any electrolytes that may be present in the liquid). One mechanism for surface charge generation is the creation of crystal lattice defects through the replacement of ions in the crystal lattice structure of the particle by ions of lower charge (25). This type of charge generation mechanism is seen most often in clay minerals where ions in the crystal lattice structure with a valence of three are substituted for by ions from the liquid with a valence of two causing a net charge on the surface (25).

If the colloidal particles have an ionic crystal structure then one mechanism for surface charge generation is the unequal dissociation and adsorption of oppositely charged ions from the particle surface (25, 26). This unequal dissociation and adsorption of surface ions results in a slight imbalance in the number of crystal cations (positively charged ions) and anions (negatively charged ions) which causes the development of a net positive or negative charge on the surface (25). The classic example of this is given in most colloid texts (15, 18, 25, 27, 28). This example is AgI which has  $\text{Ag}^+$  and  $\text{I}^-$  ions which dissociate from the surface in equal numbers according to equilibrium conditions determined by the solubility product (25). However, the iodine ions are preferentially adsorbed

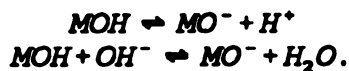
back onto the surface (compared to the silver ions) which results in the net surface charge.

Another mechanism for surface charge generation is the dissociation of ionic surface groups or the interaction of ionic surface groups with  $H^+$  and  $OH^-$  ions in water (25, 26). Hunter (25) notes that it is sometimes quite difficult to discern between the two because their net results are the same. For oxide particles in water the surfaces are hydroxylated and these hydroxyl groups can then undergo further ionization (29). An example of this is given by James and Parks for alumina (29):



where: Al = aluminum (III) ion on the surface  
 AlO = oxide ion bound to surface Al ion  
 AlOH = hydroxylated group  
 AlO<sup>-</sup> = ionized hydroxyl group  
 AlOH<sub>2</sub><sup>+</sup> = ionized hydroxyl group.

In a general form after hydroxylation this can be written as (25):



Extensive investigations and modeling have been done to describe this type of surface charge generation and charge generation from the dissociation of ionic surface groups (29-32).

It is important to point out what a potential determining ion is. A potential determining ion is an ion which helps determine the potential of a particle surface or as in the previous discussion helps generate charge on the particle surface. For the example mentioned earlier of AgI particles,  $\text{Ag}^+$  is a potential determining ion (28). For particles with surface charge generation resulting from the interaction of ionic surface groups with  $\text{H}^+$  and  $\text{OH}^-$  ions as was the case for alumina, the potential determining ions are  $\text{H}^+$  and  $\text{OH}^-$ . In this case adding more  $\text{H}^+$  and  $\text{OH}^-$  through the addition of an acid or base will change the concentration of potential determining ions which will change the degree of interaction of the potential determining ions with the ionic surface groups and consequently will change the charge on the particle surface. Similarly, changing the concentration of any potential determining ion will result in a net change of surface charge.

As a consequence of the characteristics described previously the interface between the solid particles and the liquid medium becomes tremendously important in the behavior of colloidal suspensions. This is why physical chemistry of surfaces and interfaces has become such an integral part of colloid chemistry.

From a physical standpoint, particles in a colloidal suspension are in continual motion due to a variety of different types of motion. Particle movement in the medium

is caused by collisions of the particles with the molecules of the medium, gravitational forces, and convection forces (23, 33). Movement caused by particle collisions with the suspending medium is termed Brownian motion (23). This motion is completely random with millions of changes in direction per second (34). As the particle size increases, compared to the size of the molecules of the liquid, the effects of Brownian motion are reduced (15). Gravitation movement is seen as sedimentation as the particles are slowly forced by gravity to 'fall' through the liquid medium. This gravitational movement is increased as the particle size is increased. Thermal movement is caused by convective forces resulting from thermal gradients through the liquid medium and rapidly decreases as particle size is increased. The net result of these different types of motion is that the particles in the suspension are in continual motion and will approach one another for collision. Collision, however, depends upon the forces interacting between colloidal particles.

Forces which are acting on approaching colloid particles are van der Waals forces, steric forces and repulsion forces which are the result of the electrical charges on particle surfaces. Steric forces are forces caused by co-polymers which are added to a colloidal suspension and which are adsorbed on the surfaces of particles (15). The work of this thesis will be for

suspensions which do not contain co-polymers so that steric repulsion forces will not be considered hereafter. Van der Waals forces are caused by three different types of attraction. The first type is called a Keesom interaction and is where a dipole molecule orients and attracts another dipole molecule. Another type is called a Debye interaction and is where a dipole molecule induces a dipole in a polarizable molecule and attracts it. The third type is called a London force and is where a fluctuation in a molecules' electron distribution results in an instantaneous dipole which causes a dipole in another molecule and so attracts this other molecule (35).

London forces are dominant in suspensions unless the materials are highly polar(15). Hamaker (36-38) calculated the force due to van der Waals attraction which results from London forces by using a simple pair-wise addition of atomic forces with the potential decreasing as the inverse of the sixth power of separation distance (39). Casimer and Polder (40-42) showed that for larger separations there was a retarding effect which made the potential decrease as the inverse of the seventh power of separation distance (33). This retarding effect results because, at larger separations, by the time the electric field from one dipole reaches and causes a dipole in another molecule; the electron distribution of the first molecule will have already changed (39). J. T. G. Overbeek notes, however,

that for most colloidal suspensions retardation effects are not important (33). Van der Waals attraction without retardation for two different interacting particles of radius,  $a_1$  and  $a_2$ , separated by a distance,  $H$ , can be represented by an expression derived by Hamaker (38):

$$V_A = -\frac{A}{12} \left[ \frac{y}{x^2+xy+x} + \frac{y}{x^2+xy+x+y} + 2 \log \frac{x^2+xy+x}{x^2+xy+x+y} \right] \quad [1]$$

where:  $A$  = Hamaker constant  
 $x = H / (a_1 + a_2)$   
 $y = a_1 / a_2$ .

The Hamaker constant,  $A$ , must be calculated in order to evaluate the force of attraction due to van der Waals forces. There are two methods for calculating the Hamaker constant. The first is a microscopic method which was developed by Hamaker. This method integrates over all pairs of atoms in order to get a total energy for the macroscopic body (43), but uses molecular constants for evaluation which are difficult to ascertain. The second method is a macroscopic method and was developed by Lifshitz (44, 45). This method uses macroscopic properties such as refractive index and dielectric constants in calculating the Hamaker constant. J. Gregory shows the following expression derived using the Lifshitz method (46):

$$A = 0.230 h \nu_v \frac{(\epsilon_0 - 1)^2}{(\epsilon_0 + 1)^{3/2} (\epsilon_0 + 2)^{1/2}} \quad [2]$$

where:  $\epsilon_0$  = limiting dielectric constant  
 $\epsilon_0 = n_0^2$   
 $n_0$  = limiting refractive index in visible region



h = Plank's constant  
 $\nu_v$  = characteristic dispersion frequency.

Bleier simplifies this expression to (47):

$$A_i(kT) = 113.7 \frac{(\epsilon_i - 1)^2}{(\epsilon_i + 1)^{3/2} (\epsilon_i + 2)^{1/2}} \quad [3]$$

The previous calculation determines the Hamaker constant for particles in a vacuum. Particle interactions in a medium are less than in vacuum due to the molecules of the medium being between the two interacting particles. To account for this an effective Hamaker constant is used. For two identical particles in a medium (15):

$$A_{eff} = (A_i^{1/2} - A_m^{1/2})^2 \quad [4]$$

where:  $A_{eff}$  = the effective Hamaker constant  
 $A_i$  = Hamaker constant of particle i in vacuum  
 $A_m$  = Hamaker constant of medium in vacuum.

For two different particles in a medium (15):

$$A_{eff} = (A_i^{1/2} - A_m^{1/2}) (A_j^{1/2} - A_m^{1/2}) \quad [5]$$

As stated previously, the repulsive forces in a colloidal suspension are due to electrical charge on the particle surfaces which is generated by the various methods described earlier. What transpires is that the charged particle surfaces attracts ions in the liquid to the particle surface. These attracted ions can be from the

liquid medium itself or from electrolytes in the medium. For a water medium, ions from the medium itself would be hydrogen and hydroxide ions since water dissociates into these two ions. The concentration of each of these ions is determined by the pH which is defined as the negative of the log of the hydrogen ion concentration. For example, at a pH of 7 the concentration of  $[H^+]$  and  $[OH^-]$  is  $10^{-7}$  M and for a pH of 4 the concentration of  $[H^+]$  and  $[OH^-]$  is  $10^{-4}$  M and  $10^{-10}$  M, respectively.

Electrolytes are materials which when added to the suspension which will go into solution with the liquid and are generally added in concentrations ranging from  $10^{-2}$  M to  $10^{-5}$  M. Common examples of electrolytes are potassium hydroxide (KOH), sodium chloride (NaCl), calcium carbonate ( $CaCO_3$ ), and magnesium chloride ( $MgCl_2$ ). KOH, NaCl and  $CaCO_3$  are called mono-valent electrolytes because when they go into solution each molecule forms the same number of cations as anions, while  $MgCl_2$  is called a di-valent electrolyte since one molecule will form an unequal number of cations compared to anions upon going into solution. KOH and NaCl are called monatomic electrolytes since both of the ions formed in solution ions have a valency of one, while  $CaCO_3$  is not a monatomic electrolyte since the ions formed upon solution have valencies of two.

As shown previously, the concentration of  $H^+$  and  $OH^-$  ions changes fairly dramatically with pH. Electrolytes are

added in order to overwhelm this effect and to keep a constant concentration of ions. An illustration of the reason for this can be found in the following example, for water at a pH of 7 with an electrolyte concentration of  $10^{-3}$  M the electrolyte ions are more dominant than the water since the concentration of ions in the water is  $10^{-7}$  M which means that the electrolyte ion concentration is 4 orders of magnitude greater. Now if the pH in this example is changed to 4 then the  $H^+$  ion concentration will change to  $10^{-4}$  M which is still an order of magnitude less than the electrolyte concentration.

Another important point about electrolytes is the concept of indifferent electrolytes as opposed to potential determining ions. As mentioned earlier, potential determining ions are specifically adsorbed (chemisorption) by the surface and result in surface charge generation. Indifferent ions, on the other hand, are not specifically adsorbed on the particle and result in no net surface charge generation. The adsorption of indifferent ions is merely attraction due to the charge of the ions and the charge of the particle surfaces (physisorption).

The particle surface attracts ions of opposite charge which are initially physically adsorbed to the surface. These ions are termed counter-ions since they are of opposite charge to the surface and counter the charge of the surface. The concentration of counter-ions is very high

close to the surface, but their concentration decreases as the distance from the surface is increased until the concentration is eventually the same as the concentration of the ions in the bulk liquid (15). The opposite is true for ions with the same charge as the surface. These ions are called co-ions and their concentration is very high at the surface, but increases as the distance from the surface is increased until the concentration eventually becomes the same as that in the bulk liquid (15). The distance where co-ions and counter-ions reach their bulk concentration is of the order of tens of nanometers (25).

Figure 1 illustrates this phenomenon. Figure 1a shows the particle surface as the vertical line with a positive surface charge shown to the left. To the right of the surface are the ions which have been attracted to the surface. The reason that the particle surface is shown as having no curvature is due to the extremely small size of the ions (on the order of a few tenths of a nanometer or less) compared to the amount of particle surface area (on the order of  $10^5$  square nanometers for a 0.1 micron particle (28)) which makes it such that as far as the ions are concerned, the particle surface is a big flat plate.

Figure 1b shows how the concentration of ions changes with distance away from the particle surface as previously explained. The distance  $1/\kappa$  shown in the figure is known as

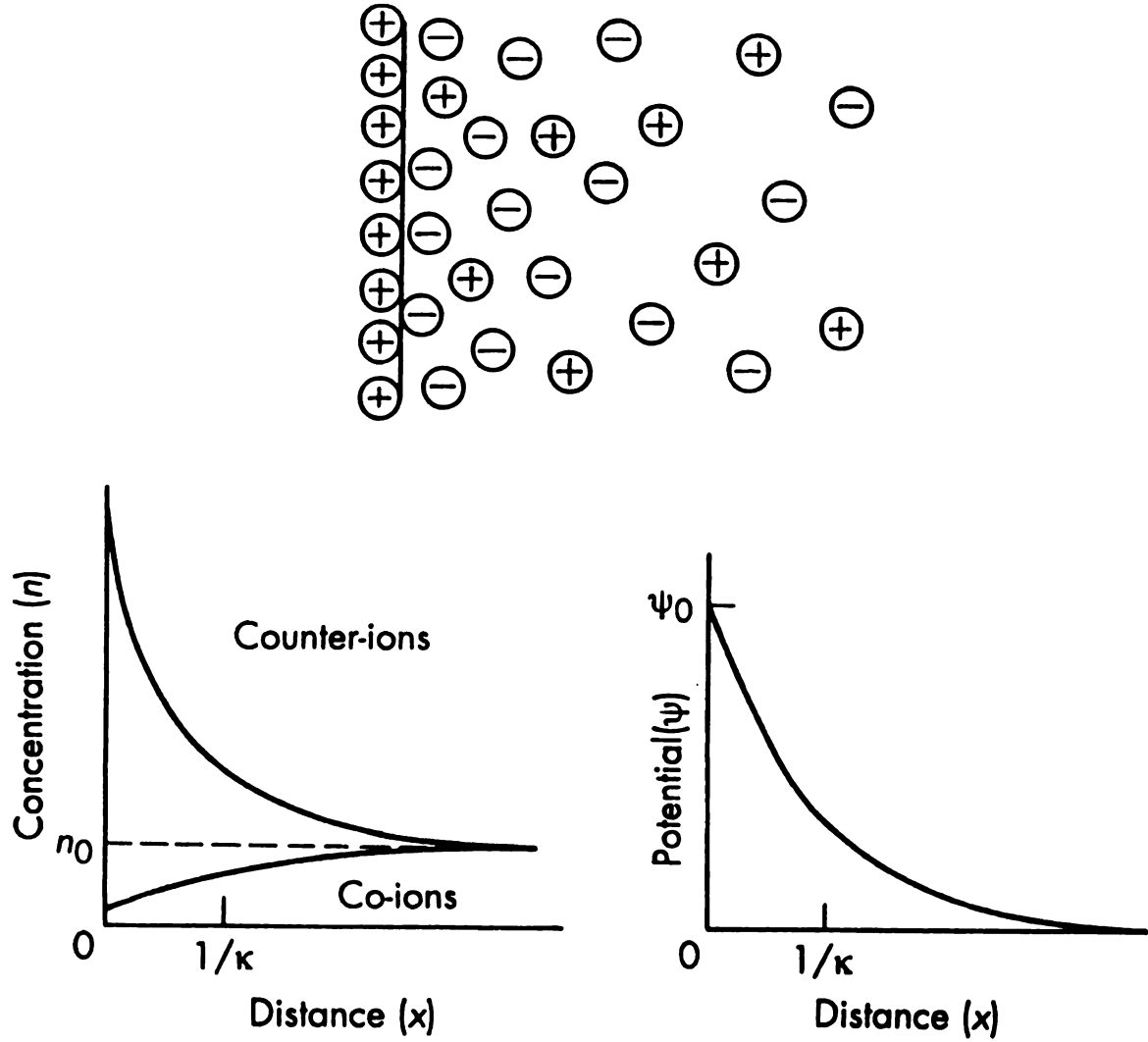


Figure 1 Illustration of a) the attraction of counter-ions to the surface of particles and the effects of distance from the surface on b) ion concentration and c) potential (taken from (15)).

the Debye length. The Debye length is used to characterize the size of the layer of adsorbed ions. The quantity  $\kappa$  is known as the Debye-Hückel parameter and is a function of concentration of ions in the bulk, the valency of those ions, and the temperature. An exact function for the Debye-Hückel parameter will be derived in more detail later.

Figure 1c shows how the potential changes with distance away from the particle surface. The figure shows how the potential begins at  $\psi_0$  due to the charge on the surface and decreases in magnitude as distance is increased due to the countering of the surface charge by the adsorbed counter-ions.

If an electrolyte is added to the medium of a colloidal suspension the concentration of the electrolyte in the medium is usually in the range of  $10^{-5}$  to  $10^{-2}$  M. As the concentration of ions in the liquid is increased through electrolyte addition, the distance from the particle surface to where the ion concentration reach its bulk value is decreased (23, 25), which as will seen later reduces the amount of interparticle repulsion. Adding an electrolyte which has ions with a valency of more than one (e.g. di-valent and tri-valent ions) will also cause a decrease in the distance from the particle surface where ion concentrations reach bulk values (23), which is why monatomic electrolytes are most often used.

Gouy and Chapman (48, 49) described this phenomenon of ion adsorption to charged particle surfaces by saying that particles in a medium have a double layer of charge which consists of two distinct layers of ions around the particle. The first layer is the compact inner layer of adsorbed counter-ions, which is often termed the Stern layer after O. Stern who later developed a model describing this layer in more detail (50). The second layer is a diffuse layer of both counter-ions and co-ions with a distribution which depends on electrical considerations and random thermal motion (15). Gouy and Chapman modeled this layer (48, 49). Their model assumes that the particle surfaces are flat (with respect to the ions) and uniformly charged, that the ions can be considered to be point charges from a symmetric electrolyte of charge  $z$ , that the distribution of the point charges is a Boltzmann distribution, and that the only influence of the medium is through the dielectric constant which does not vary in the liquid (15).

Figure 2 shows this phenomenon. Figure 2a shows the particle surface as the vertical line with positive surface charge to the left. The dotted vertical line closest to the surface is the Stern plane which is the outer boundary of the compact inner layer of adsorbed counter-ions (the Stern layer). The bumpy curved line which is the next furthest out from the particle surface is known as the surface of shear. This is the surface where if the particle itself

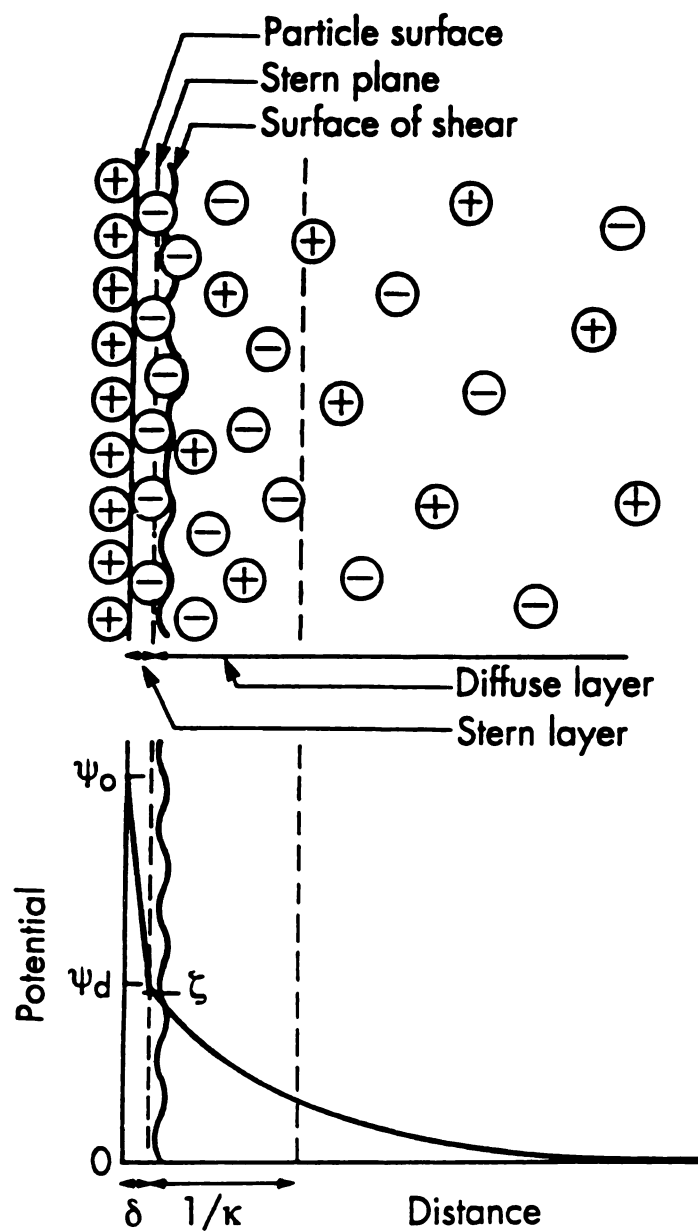


Figure 2 Illustration of a) the double layer surrounding a colloidal particle and b) the change of potential with distance from the particle surface (taken from (15)).



moves the ions inside this surface of shear move with the particle as if they were a part of the surface and those outside the surface of shear do not.

Figure 2b shows the potential as a function of distance from the surface. The potential begins with a value of  $\psi_0$  at the surface. The potential then decreases quickly to the value  $\psi_d$  at a distance of  $\delta$  which corresponds to the edge of the Stern layer. The potential decreases as a result of the specifically adsorbed counter-ions which counter the charge at the surface. The potential then decreases gradually in the second, diffuse layer also due to the counter-ions in this layer. The potential at the surface of shear is shown in Figure 2b to be equal to a value  $\zeta$  and is commonly referred to as the zeta potential. The zeta potential will be discussed in more detail later, especially with respect to ways of measuring the zeta potential and the difference (if any) between  $\zeta$  and  $\psi_d$ . The Debye length,  $1/\kappa$ , shown in Figure 2b is often called the double layer thickness, even though it is actually only an indication of the actual size of the double layer and not an absolute thickness (28).

The repulsive force upon particle interaction results from the energy of interaction of each particles' double layer as they begin to overlap. Consequently, the repulsive force is a function of the magnitude of the charge generated on the particle surface and the size of the double layer around the particle (25). An expression of this interaction

energy is extremely difficult to obtain. Derivations for an expression usually use the Poisson equation to describe the flow of the electric field in a dielectric medium and the Boltzmann equation to describe the charge distribution in the diffuse layer (51-63). Specific derivations of repulsive double layer interactions will be discussed extensively later.

Several interesting characteristics of colloidal particles with an electrical double layer are grouped together as electrokinetic phenomena. Generally, electrokinetics is the combination of particle electrical effects and particle motion (28). An important classical example of electrokinetics is electrophoresis in which motion of the particle in suspension is caused by the application of an external electric field (25). Actually in electrophoresis when the charged particle moves it takes with it some adsorbed ions (namely those inside the plane of shear) and this movement is relative to the medium which does not move (15). The velocity at which the particle moves is directly proportional to the magnitude of the applied electric field (25) and the constant of proportionality is called the electrophoretic mobility,  $\mu_e$ . (25). Microelectrophoresis is the experimental technique of using optical microscopy to visibly see the particle motion and measure its net velocity for a given electric field (15) in order to find the mobility,  $\mu_e$ .

As referred to earlier, the plane of shear separates the layer of ions which moves with the particle and the layer of ions which remains stationary with the liquid. The potential at this plane of shear is called the zeta potential,  $\zeta$ , and is determined by using the electrophoretic mobility. For particle suspensions where the particle radius is much larger than the size of its double layer (i.e. such that  $r/\kappa^{-1} \gg 1$ ), the equation to calculate the zeta potential is known as the Helmholtz-Smoluchowski equation (25):

$$\zeta = \frac{\mu_o \eta}{\epsilon_o \epsilon_r} \quad [6]$$

where:  $\epsilon_o$  = permittivity in a vacuum  
 $\epsilon_r$  = relative permittivity  
 $\eta$  = viscosity of liquid medium.

The Helmholtz-Smoluchowski equation is generally valid for aqueous suspensions. For particle suspensions where the particle radius is much less than the double layer thickness (i.e. such that  $r/\kappa^{-1} \ll 1$ ), the equation to calculate the zeta potential is known as the Hückel equation (15):

$$\zeta = \frac{1.5 \mu_E \eta}{\epsilon_o \epsilon_r} \quad [7]$$

The Hückel equation is generally valid for non-aqueous suspensions with low conductivity (15).

The potential at the plane of shear is often assumed to be equal to the potential at the outer edge of the stern layer (15, 64). Lyklema (64) reports in his investigations that within experimental error the zeta potential equals the potential at the Stern layer.

Other examples of electrokinetic phenomena are electroacoustic phenomena and are described in detail by O'Brien and Oja (65-67). The first of the two electrokinetic phenomena results from the application of an alternating pressure field in a colloidal suspension in the form of an acoustic wave. As a result of the density difference between the particles and the liquid there is a relative motion between the particles and the liquid. An alternating dipole is formed at the frequency of the acoustic wave as a result of the relative displacement of the particles and the oppositely charged particles in the double layer caused by the relative motion. The formation of this alternating dipole is termed the Ultrasonic Vibration Potential (UVP), and is measured as voltage per amplitude velocity of the acoustic wave applied.

The other electroacoustic phenomena results from the application of an alternating electric field to a colloidal suspension. An acoustic wave is generated by the particles as they move back and forth in the electric field due to their charge and a density difference between the particles and the liquid. The formation of this acoustic wave is

termed the Electrokinetic Sonic Amplitude (ESA) and is measured as pressure amplitude per unit electric field applied.

The dynamic mobility can be found for both these electroacoustic phenomena by using equations derived by O'Brien (65, 66):

$$\mu_d(\omega) = \frac{ESA(\omega)}{\Phi \Delta \rho c} \quad [8]$$

and

$$\mu_d(\omega) = \frac{UVP(\omega)}{\Phi \Delta \rho c} K^* \quad [9]$$

where:  $\mu_d$  = dynamic mobility  
 $\omega$  = angular frequency  
 $\Phi$  = volume fraction of particles  
 $\Delta \rho$  = density difference of particles and liquid  
 $c$  = velocity of sound in suspension  
 $ESA$  = pressure amplitude per unit electric field  
 $UVP$  = voltage per amplitude velocity of wave  
 $K^*$  = high frequency conductivity correction.

The zeta potential can be calculated using the mobility as in electrophoresis with the addition of a correction for the inertia of the particle in an alternating field since this reduces the velocity amplitude of particle motion. The equation to calculate the zeta potential was derived by O'Brien using the Helmholtz-Smoluchowski equation (65, 66):

$$\zeta = \frac{\mu_d \eta}{\epsilon_0 \epsilon_r} |G(\alpha)^{-1}| \quad [10]$$

$$|G(\alpha)^{-1}| = \sqrt{X^2 + Y^2} \quad [11]$$

W

a

p

s

d

b

t

a

p

T

to

se

W

$$X = \frac{1 + 2A^3B}{9(2A^2 + 2a + 1)} \quad [12]$$

$$Y = \frac{2A^2B(1+A)}{9(2A^2 + 2A + 1)} \quad [13]$$

$$A = \sqrt{\frac{\alpha}{2}} \quad [14]$$

$$B = \left(3 + 2 \frac{\Delta \rho}{\rho}\right) \quad [15]$$

$$\alpha = \frac{\omega a^2 \rho}{v} \quad [16]$$

where: a = particle radius.

The stability of a colloidal suspension refers to whether or not particles come together in clusters called agglomerates or whether particles stay as individual particles (25). Suspensions which are from agglomerates are said to have coagulated and are unstable. Suspensions which do not form agglomerates are said to be stable. It should be noted that contrary to popular usage in the literature the term flocculation refers to the formation of loose agglomerates formed as the result of polymers adsorbed onto particle surfaces and not just from normal coagulation (25). Therefore, in this thesis the term coagulation will be used to describe agglomeration and not flocculation since as mentioned before all suspension considered for this thesis will not contain polymers.

Colloidal suspensions, as Hunter points out (25), are thermodynamically metastable. This means that a stable suspension is only stable in a kinetic sense and that coagulation is a rate process. The study of colloidal stability predictions should therefore be more a study of the rate of these processes than the thermodynamics of them (33).

Pioneering work in describing particle interactions of single component colloid systems was done by Derjaguin, Landau, Verwey, Overbeek (51, 52). The compilation of their work is known as DLVO theory. DLVO theory describes the energy of interaction for identical particles in an electrolyte solution. In DLVO theory, the particles are treated as having a double layer of ions which surround them as described previously by Gouy and Chapman (48, 49). This double layer, as described earlier, consists of a diffuse layer in which ions are treated as point charges which can be described by a Boltzmann distribution, and a rigidly held inner layer of essentially adsorbed ions.

The interaction energy between two particles is described as a sum of the potential energy of attraction and repulsion energies:

$$V_t = V_A + V_R \quad [17]$$

where:  $V_t$  = total energy  
 $V_A$  = attractive energy  
 $V_R$  = repulsive energy.



The attraction energy is due to van der Waals attraction and is described by equations derived for two equal spheres by Hamaker (38):

$$V_A = -\left(\frac{Aa}{12H}\right) \quad [18]$$

where:  $H$  = interparticle separation distance  
 $a$  = particle radius  
 $A$  = Hamaker constant (from Equation [4]).

The repulsive energy during particle interaction is caused by the overlapping of particles' double layers. This repulsive interaction is described by the Poisson-Boltzmann equation:

$$\nabla^2 \psi = -\frac{1}{\epsilon_0 \epsilon_r} \sum_i n_i^0 z_i e \exp\left(-\frac{z_i e \psi}{kT}\right) \quad [19]$$

where:  $\nabla^2$  is the Laplacian operator  
 $\psi$  = particle surface potential  
 $\epsilon_0$  = permittivity in a vacuum  
 $\epsilon_0 = 8.854 \times 10^{-12} \text{ (C}^2/\text{J m)}$   
 $\epsilon_r$  = relative permittivity  
 $n_i$  = number of ions of type  $i$   
 $z_i$  = valence of ion  $i$   
 $e$  = electron charge  
 $e = 1.602 \times 10^{-19} \text{ (C)}$   
 $k$  = Boltzmann's constant  
 $k = 1.381 \times 10^{-23} \text{ (J/K)}$   
 $T$  = temperature (K).

This equation is the combination of the Poisson equation which describes the flow of the electric field in a dielectric medium as detailed by Hunter (25):

$$\nabla^2 \psi = -\frac{\rho}{\epsilon_0 \epsilon_r} \quad [20]$$

where:  $\rho$  = density of charges  
and the Boltzmann equation which described the distribution of charges in the diffuse double layer:

$$n_i = n_i^0 \exp\left(-\frac{\omega_i}{kT}\right) \quad [21]$$

where:  $n_i$  = number of ions of type  $i$  at the distance from the surface where the potential is  $\psi$   
 $n_{i0}$  = number of ions type  $i$  in the bulk  
 $\omega_i$  = work to bring ions from the bulk medium to this distance.

As an approximation  $\omega_i$  is assumed to be:

$$\omega_i = z_i e \psi \quad [22]$$

so that the density of charges becomes

$$\rho = \sum_i n_i^0 z_i e = \sum_i n_i^0 \exp\left(-\frac{z_i e \psi}{kT}\right) \quad [23]$$

which in combination with the Poisson equation results in the Poisson-Boltzmann equation [19] shown previously.

In DLVO to get an expression for the energy of repulsion the Poisson-Boltzmann equation was solved using the Debye-Hückel approximation. The Debye-Hückel approximation assumes that (28):

$$\begin{aligned} &|ze\psi| < kT \\ \text{or:} & \\ &\text{solving this for } \psi \text{ at} \\ &\text{room temperature (25}^\circ\text{C)} \\ &\psi < 25.7 \text{ mV.} \end{aligned} \quad [24]$$

This allows for the following simplification if only the first term of the series expansion is taken (15):

$$\exp\left(\frac{ze\psi}{kT}\right) \approx 1 + \frac{ze\psi}{kT}. \quad [25]$$

So that the Poisson-Boltzmann equation becomes:

$$\nabla^2 \psi = -\frac{1}{\epsilon_0 \epsilon_r} \left[ \sum_i n_i^0 z_i e - \sum_i \frac{z_i^2 e^2 n_i^0 \psi}{kT} \right]. \quad [26]$$

Due to the need for electroneutrality in the bulk medium the sum of the charges must equal zero, so (25):

$$\sum_i z_i e n_i = 0. \quad [27]$$

The Poisson-Boltzmann equation then simplifies to:

$$\nabla^2 \psi = \frac{1}{\epsilon_0 \epsilon_r} \left[ \sum_i \frac{z_i^2 e^2 n_i^0}{kT} \right] \psi \quad [28]$$

or:

$$\nabla^2 \psi = \kappa^2 \psi \quad [29]$$

where:  $\kappa$  = Debye-Hückel parameter

$$\kappa = \sqrt{\frac{e^2 \sum_i n_i^0 z_i^2}{kT}}. \quad [30]$$

The linear form of this equation becomes (28):

$$\frac{d^2 \psi}{dx^2} = \kappa^2 \psi. \quad [31]$$

The linear form of this equation is then solved in DLVO with the boundary conditions that (28):



$$\begin{aligned} \psi &\rightarrow \psi_0 \text{ as } x \rightarrow 0 \\ \text{and} \\ \psi &\rightarrow 0 \text{ as } x \rightarrow \infty \end{aligned} \quad [32]$$

where:  $x$  = distance from the surface.

The solution of which is (28):

$$\psi = \psi_0 \exp(-\kappa x). \quad [33]$$

The repulsion for identical spheres was then found by Derjaguin (68, 69) to be:

$$V_R = 2\epsilon_0\epsilon_R\psi^2 \ln[1 + \exp(-\kappa H_0)] \quad [34]$$

where:  $H_0$  = shortest distance between particle surfaces.

Now the total potential energy interaction as a function of interparticle distance can be calculated (and subsequently graphed) in the DLVO method by using Equation [34] and [18] to solve Equation [17] as a function of varying distance of particle separation,  $H$ . The graph of total potential energy versus particle separation is used to indicate the stability of a single component system and a maximum potential energy of 20  $kT$  is often noted to indicate that a suspension will be stable (25). However, this does not indicate the stability for multicomponent systems and does not address the kinetic aspect of stability at all.

Empirically, colloid experimentalists have noted that colloid suspensions which have room temperature zeta potential values above 25.7 mV generally will be stable (70). One way in which this empirical relationship would be

used would be for a system where  $H^+$  and  $OH^-$  ions are potential determining ions and the zeta potential would be measured over a range of pHs. Since changes in pH will change the concentration of potential determining ions, the magnitude of the surface charge generated will change and so the magnitude of the zeta potential will change.

Measurements of these changes in the potential will indicate the change in the repulsive force of particle interaction. The empirical theory then implies that if for any pH the zeta potential is greater than 25.7 mV then the suspension will be stable at that point. Again, however, this does not indicate stability for multicomponent systems and does not address the kinetic aspect of stability. A solution of the interparticle potentials for multicomponent systems is therefore needed together with a means of incorporating the kinetic aspect of stability.

For the case of nonidentical particles with varied potential, an exact solution of the Poisson-Boltzmann equation is extremely difficult or impossible (71). Consequently, approximate solutions of the Poisson-Boltzmann equation must be made for nonidentical particles. One of the first solutions for nonidentical particles was in the mid 1950's by Derjaguin (54) who extended DLVO theory to systems with nonidentical particles. Other extensions of the DLVO theory to systems with nonidentical particles were made by Bierman (61) and by Devereux and de Bruyn (55).

These solutions, however required extensive numerical or graphical iterations making them extremely difficult to apply to actual systems (53).

In the mid 1960's, Hogg, Healy, and Fuerstenau built upon DLVO theory to develop a quantitative kinetic stability theory for nonidentical particles which was more easily applied to actual systems (53). Their solution was for systems in which the particle potentials remain constant. Their theory has come to be known as HHF theory. HHF theory uses the same approach to describe the total potential energy of interaction as DLVO theory, but uses an expanded attraction and repulsion force equations in order to take into account the differences between the two different particle types. The attraction force equation then becomes:

$$V_A = -\frac{A a_1 a_2}{6 (a_1 + a_2) H} \quad [35]$$

where:  $H$  = interparticle distance  
 $A$  = Hamaker constant (from Equation [5])  
 $a_i$  = radius of particle of type  $i$ .

In developing an equation to describe the repulsive energy of interaction, the linear form of the Debye-Hückel form of the Poisson-Boltzmann equation (Equation [31]) is used just as in DLVO. In the development of the HHF theory, though, Hogg, et al. show that the approximation is good for  $\psi_1$  and  $\psi_2$  values of less than 50 to 60 mV as opposed to the less than 25 mV that is assumed in DLVO.

To solve Equation [31] in HHF the two different types of particles are treated as two plates separated by a distance,  $2d$ , with the boundary conditions:

$$\begin{aligned}\psi &= \psi_{\alpha_1} \text{ as } x \rightarrow 0 \\ \text{and} \\ \psi &\rightarrow \psi_{\alpha_2} \text{ as } x \rightarrow 2d.\end{aligned}$$

The solution then becomes:

$$\psi = \psi_{\alpha_1} \cosh(\kappa x) + \left( \frac{\psi_{\alpha_2} - \psi_{\alpha_1} \cosh(2\kappa d)}{\sinh(2\kappa d)} \right). \quad [36]$$

The energy of repulsion for HHF was then found using Derjaguin's method (68, 69), as in DLVO:

$$\begin{aligned}V_R &= \epsilon_0 \epsilon_R \pi \left( \frac{a_1 a_2}{(a_1 + a_2)} \right) (\psi_{\alpha_1}^2 + \psi_{\alpha_2}^2) * \\ &\quad \left[ \frac{2\psi_{\alpha_1} \psi_{\alpha_2}}{\psi_{\alpha_1}^2 + \psi_{\alpha_2}^2} \ln \left( \frac{1 + \exp(-\kappa H)}{1 - \exp(-\kappa H)} \right) + \ln(1 - \exp(-2\kappa H)) \right].\end{aligned} \quad [37]$$

The total potential energy as a function of interparticle distance for two nonidentical spherical particles is calculated by using Equation [35] and [37] to solve Equation [16] as a function of varying separation distance,  $H$ .

In order to better describe the effects of mutual agglomeration and to develop a quantitative theory for the overall kinetic stability of the system of nonidentical particles, Hogg et al. (53) develop a variable,  $W_t$ , which is similar to an equation by Fuchs (72):



$$W_t = \left[ \frac{n^2}{W_{11}} + \frac{(1-n)^2}{W_{22}} + \frac{2n(1-n)}{W_{12}} \right]^{-1} \quad [38]$$

where:  $n$  = overall proportion of particle type 1  
 $n^2$  = probability type 1 particles will encounter each other  
 $(1-n)$  = overall proportion of particle type 2 in the system.

The factor,  $W_t$ , is a factor by which rapid coagulation, as described by von Smoluchowski (73, 74), is slowed due to a potential barrier to coagulation caused by the repulsive potential energy of particle interactions (33, 34). This factor is called the stability ratio and is essentially the ratio of particle collisions to collisions resulting in coagulation (25). For identical particles with radius,  $a$ , and a distance of separation,  $r$ , (measured from particle center to particle center) Fuchs showed the stability ratio to be (34):

$$W = 2a \int_{2a}^{\infty} \exp\left(-\frac{V}{kt}\right) \frac{dr}{r^2}. \quad [39]$$

For two nonidentical particles of radius,  $a_1$  and  $a_j$ , the stability ratio becomes:

$$W_{1j} = (a_1 + a_j) \int_{a_1 + a_j}^{\infty} \exp\left(-\frac{V}{kt}\right) \frac{dr}{r^2}. \quad [40]$$

As previously stated the HHF solution of repulsive interparticle potential was for systems in which particle

potentials remain constant, Wiese and Healy later derived a similar solution with the same form as the constant potential form for systems with particle charges which remain constant (56):

$$V_R = \epsilon_0 \epsilon_R \pi \left( \frac{a_1 a_2}{a_1 + a_2} \right) (\psi^2_{a_1} + \psi^2_{a_2}) + \left[ \frac{2\psi_{a_1}\psi_{a_2}}{\psi^2_{a_1} + \psi^2_{a_2}} \ln \left( \frac{1 + \exp(-\kappa H)}{1 - \exp(-\kappa H)} \right) - \ln(1 - \exp(-2\kappa)) \right]. \quad [41]$$

Kar, Chander and Mika used an approach similar to the one used by Hogg, et al. and developed a solution for systems in which one of the components has constant charge and the other one has constant potential (75). Barouch and Matijević have done work with various others (57-60) to develop an extremely complex quantitative theory to describe the interaction potential for nonidentical particles that uses an approximate solution of the Poisson-Boltzmann equation in its two dimensional form by assuming constant potential.

In their work Barouch and Matijević (59) compare the results of their solution for the interaction potential with that of Hogg, Healy and Fuerstenau (53). The authors say that the two models agree fairly well for unlike particles with potentials of opposite sign and similar magnitudes, but claim that for particles with the same sign and different magnitudes the HHF equation overestimates the interparticle repulsion. However, the model developed by Barouch,

Matijević et al. is extremely complex mathematically and its solution is quite complicated involving intricate use of various algorithms as the authors acknowledge (60).

With all of these different models of the repulsive interaction for unlike particles the HHF method, though, still remains as the only quantitative theory for the overall stability of a system of nonidentical particles. This overall method is therefore best suited for use in prediction of suspension stability. Another advantage of this method is that various different adjustments can be made within the model to help improve the fit of the method's stability prediction. One of the first adjustments which could be made would be to use zeta potential data for the particle potential,  $\psi$ , instead of using point of zero charge data to calculate a surface potential, as was done originally by Hogg, et al (53). This would be an improvement since calculation of the surface charge from point of zero charge data requires use of a model for surface charge generation which requires considerable knowledge of ion groups present on the particle surface and how these groups react with the medium to generate charge. Zeta potential, on the other hand, is simply an experimental measurement which requires little knowledge about the particle, other than particle size and density (67), has recently become a more common measurement technique and has recently become a much easier measurement than in the past

(67, 70). Other adjustments which could be made would be alternate expressions for attraction and repulsion potential as well as alternate methods for calculating the Hamaker constant.

## EXPERIMENTAL PROCEDURE

A model was used to predict the stability of suspensions over a given pH range which was an adaptation of a method originally developed by Hogg, Healy and Fuerstenau (53). The adaptation included several changes or adjustments to the original method. The first of these was the use of zeta potential vs. pH data for the potential,  $\psi$ , instead of using a surface potential calculated at the given pH, a calculation which relies on models for surface charge generation and point of zero charge data. Another change or adjustment was the use of an effective Hamaker constant (Equation [5]) instead of just using an in vacuo Hamaker constant. This allows the effect of the medium to be taken into account in reducing interparticle attraction. Along with this is the addition of the Lifshitz method for calculating Hamaker constants (Equation [3]) since a method for their calculation was not addressed by the original theory.

Another change was the use of an expanded expression for the potential of interparticle attraction (Equation [1]) instead of the equation used in the original method (Equation [35]) which is a simplification of Equation [1]

which assumes small particle separation. For the potential of interparticle repulsion the original HHF equation (Equation [37]) was used although, the constant charge solution of Wiese and Healy (Equation [41]) (56) was used in some cases.

The repulsion equation was not changed for several reasons. The first reason was that the equation was reported to be accurate in many cases (59). The second was that use of this constant potential equation made substitution of a constant charge solution (namely that of Wiese and Healy) quite simple due to the almost identical nature of the two equations. Another reason was that other solutions for interparticle repulsion which are reported to be more accurate (59), require very elaborate calculation schemes which would have required much more calculation time than needed with the HHF equation. The final reason was that even if the equation proved unsatisfactory it could easily be substituted for in later versions of this adapted method.

The equation for total overall kinetic stability (Equation [38]) and the equation for the stability factor (Equation [40]) were used as in the original method. However, instead of using the overall relative proportion of particles of type 1 in the system,  $n$ , as a system input as in the original method, a relationship was derived which related the relative volume fraction of particle of type 1

to type 2 and the particle radii to the overall number proportion,  $n$ . This derivation which can be found in appendix A allowed use of the relative volume fraction of components as an input. This was an improvement since, from an experimental viewpoint, volume fraction is a much more realistic and useful quantity than number fraction.

With the adapted method described, the total overall kinetic stability at a certain pH was calculated by solving Equation [38]. For the equation  $n$  was found by using input values for particle radii and relative component volume fraction to solve Equation [A11] and was  $W_{1j}$  found by solving Equation [40]. The solution of Equation [40] was found by using particle radii, the input temperature and total interparticle potential vs. separation distance to integrate from a minimum separation distance ( $a_i + a_j$ ) to an infinite separation distance. The interparticle potential was found using the solutions for the attractive potential described by Equation [1] and the repulsive interaction potential described by Equation [37] (or Equation [41]) to solve Equation [16] for different separation distances. Solving Equation [1] required particle radii input data and effective Hamaker constants which were found by solving Equation [5] using input Hamaker constants. The input Hamaker constants were either calculated values found by using dielectric constant data to solve Equation [3] or were values found in the literature. Solving Equation [37] (or

Equation [41]) required use of input particle radii and zeta potential versus pH data along with the Debye-Hückel parameter. The value for this parameter is calculated by using the input bulk monatomic ion concentration and temperature data to solve Equation [30] All electrolytes, acids and bases are assumed to be monatomic with this method, but this assumption could be eliminated in future versions.

The input data necessary for using this method were in vacuo Hamaker constants, particle radii, relative component volume fraction, concentration of monatomic electrolyte, temperature, zeta potential data as a function of pH, and finally the pH range where stability calculations were performed. A computer program was necessary to perform these calculations since, to calculate the total overall stability ratio at just one pH, it would be necessary to calculate the stability ratio,  $W_{1j}$ , for each of the three different types of particle interactions (i.e.  $W_{11}$ ,  $W_{12}$ ,  $W_{22}$ ). Theoretically, this would require integration to infinity and evaluation of the attractive and repulsive interactions to infinity. This would have to be repeated for each pH.

The computer program was written in Fortran code for use on a PC. The program code was edited using Personal Editor (version 4.21) and was compiled using Microsoft Fortran Compiler (version 5.00.03). The program consisted of a main program and ten separate subroutines. Computer



flow diagrams can be found in Figures 3 through 11 and list files of the code can be found in appendix B. The program was run from a DOS operating system batch file which allowed the program to run many times successively with different input data without requiring the operator to wait for one program run to end in order to input new data as normal program lasted anywhere from 30 minutes to 2 hours.

The program starts with the main program, STABILITY PREDICTION. The input data is read into the program from a file by the subroutine FDATA INPUT. The subroutine CALCZP calculates the total overall stability ratio at each pH using zeta potential data. Subroutine WKO finds the stability ratio for each of the possible interaction types and at each pH writes the interparticle potential vs. separation distance data for each of the different interactions to an ASCII data file. The subroutine WC actually calculates the stability ratio for a given interaction and returns the value to subroutine WKO. Integrating to infinity was accomplished by integrating in interval steps to avoid integrating infinity. When integration passed a minimum limit of integration, it was allowed to stop before infinity if the area added by a certain interval steps of integration was smaller than a specified tolerance. This decreased program time with the introduction of minimal error. The actual integration was done using Simpson's rule in subroutine SI. The values for

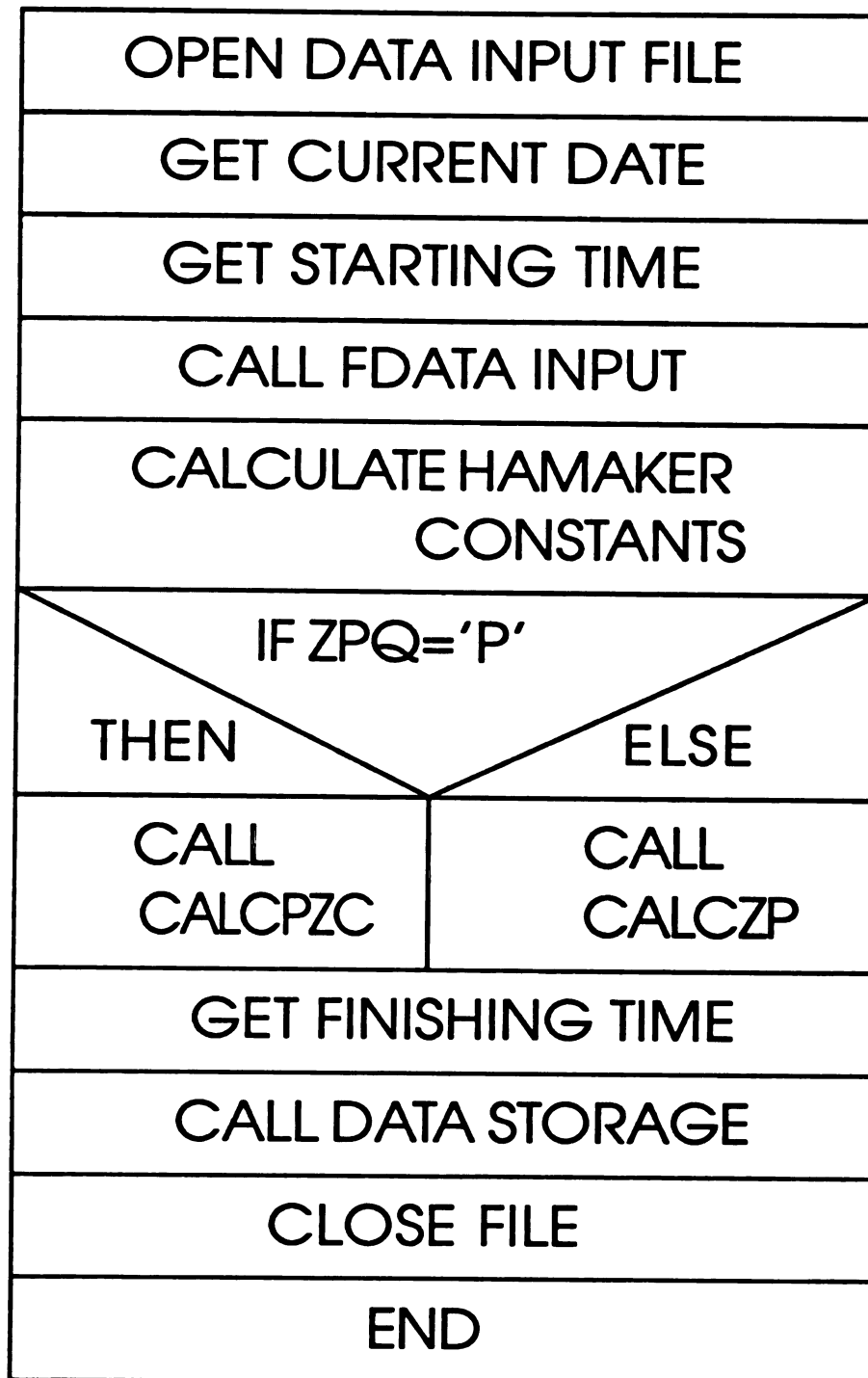


Figure 3 Computer flow diagram for main program STABILITY PREDICTION.

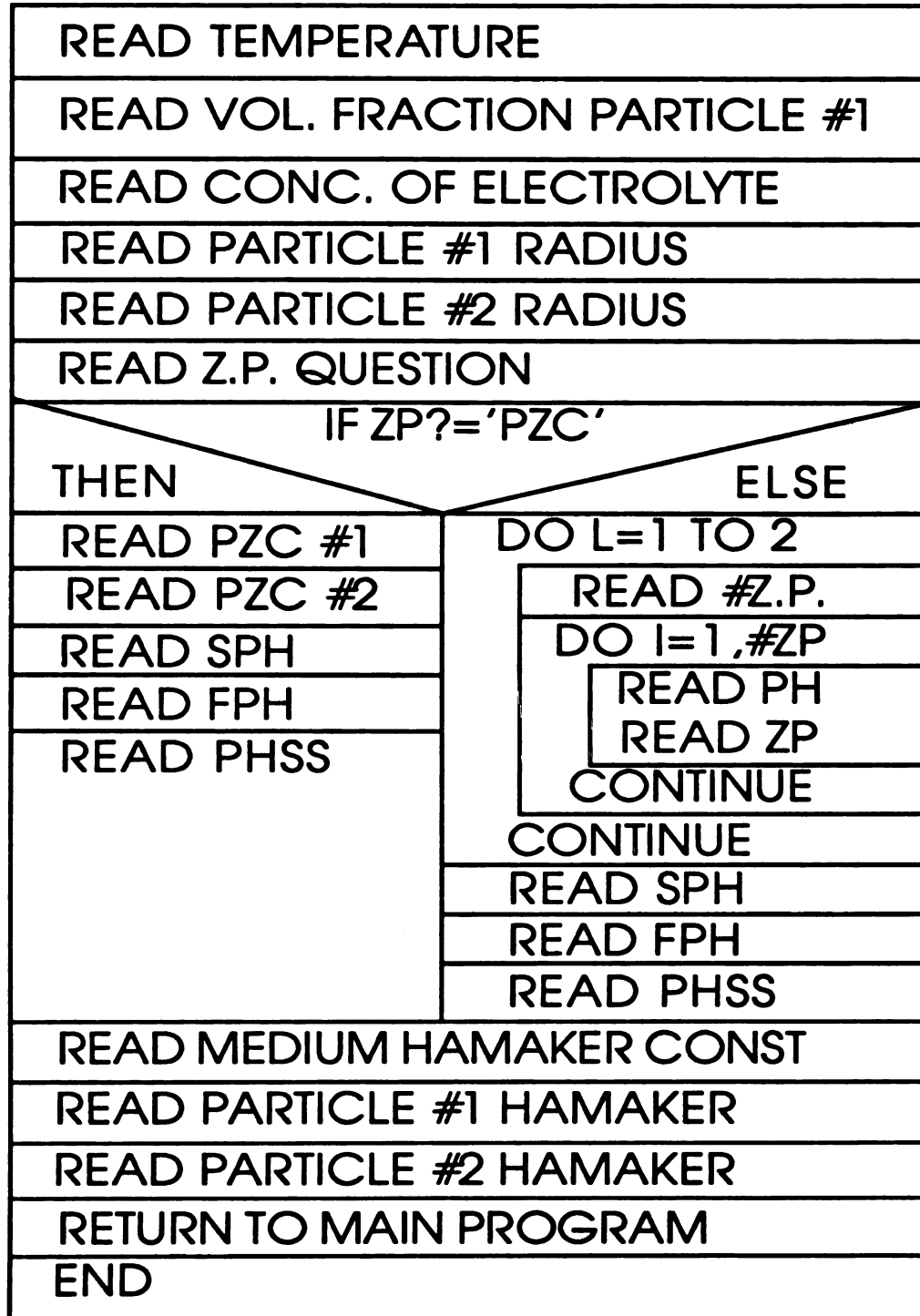


Figure 4 Computer flow diagram for subroutine FDATA INPUT.

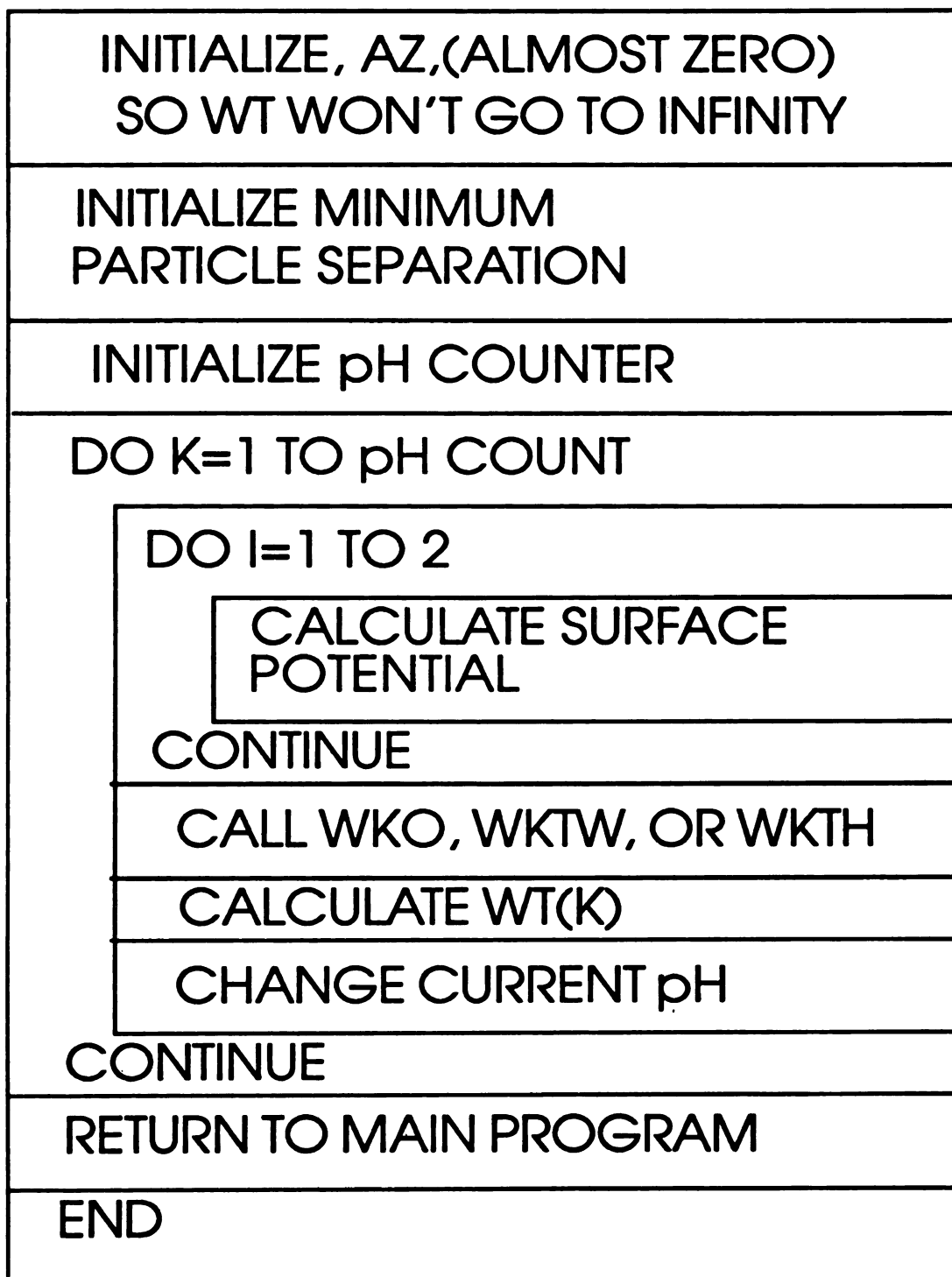


Figure 5 Computer flow diagram for subroutine CALCPZC.

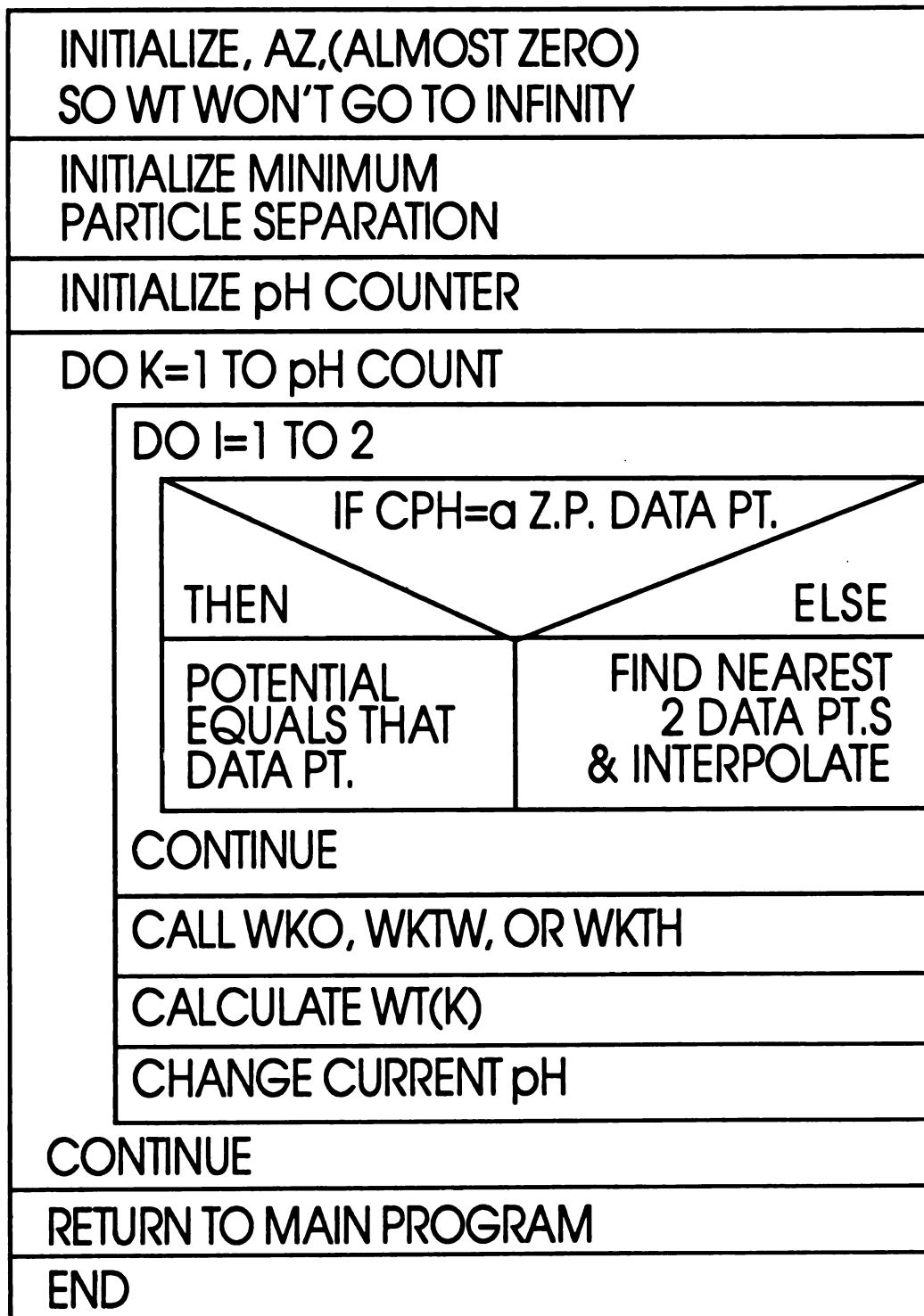


Figure 6 Computer flow diagram for subroutine CALCZP.

INTERACTION TYPE 1:1
CALL WC
WOO(K)=WCALC
INTERACTION TYPE 1:2
CALL WC
WOT(K)=WCALC
INTERACTION TYPE 2:2
CALL WC
WTT(K)=WCALC
STORE V DATA TO FILE
RETURN TO CALCPZC OR ZP
END

Figure 7 Computer flow diagram for subroutine WK0.

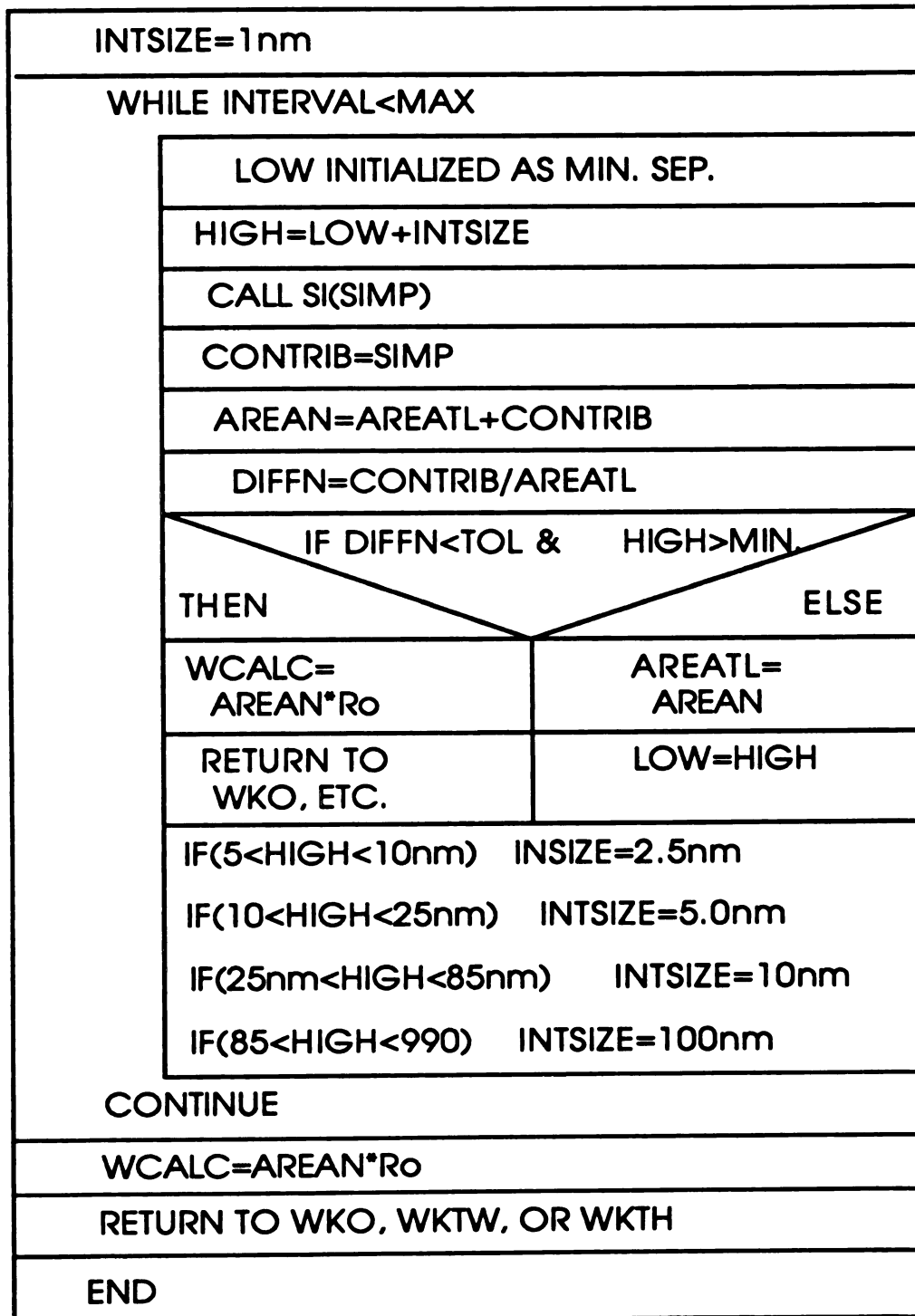


Figure 8 Computer flow diagram for subroutine WC.

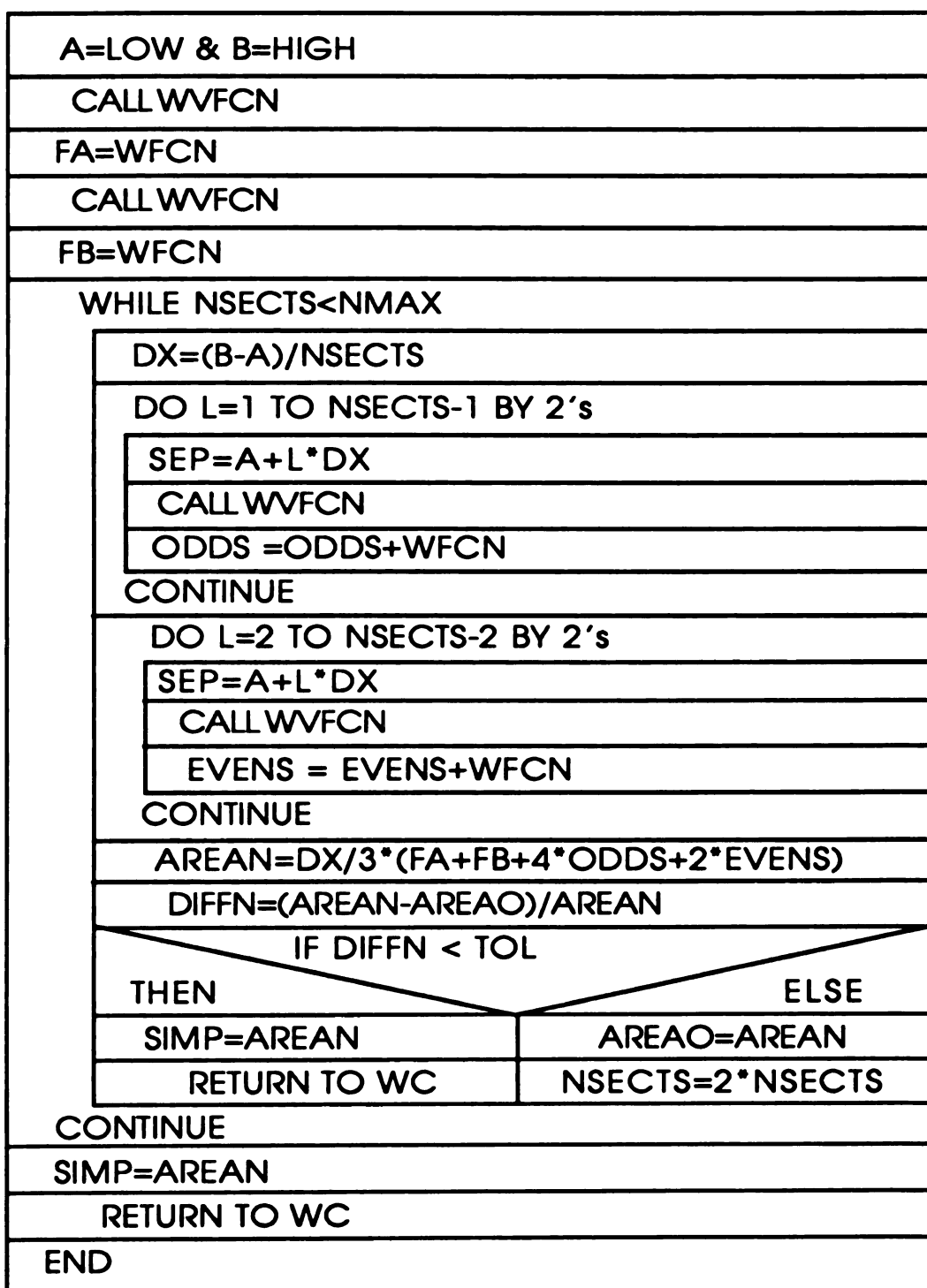


Figure 9 Computer flow diagram for subroutine SI.



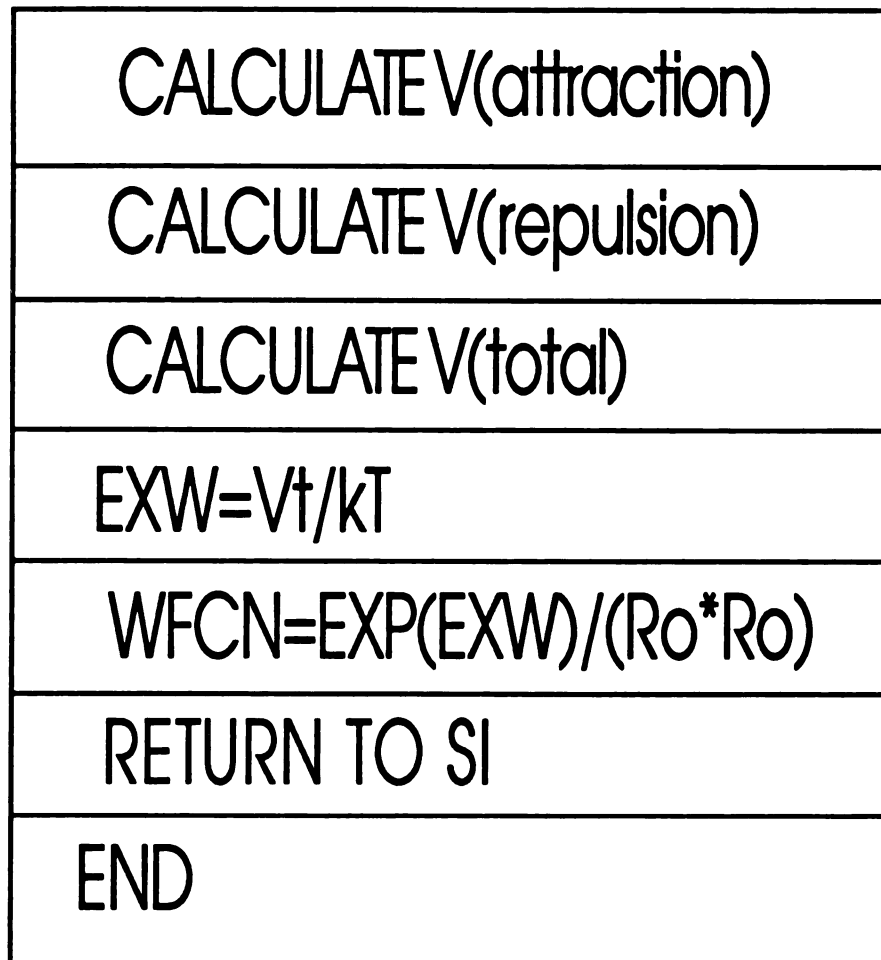


Figure 10 Computer flow diagram for subroutine WFCN.

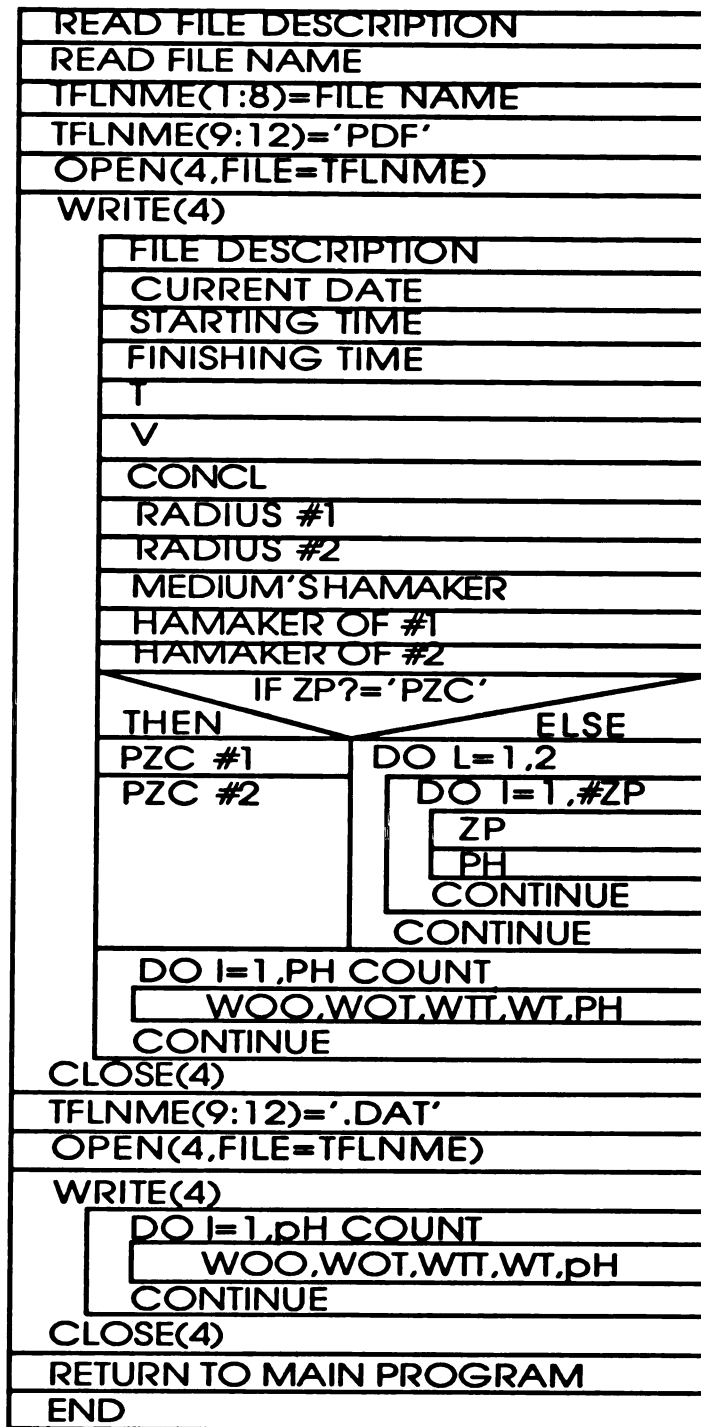


Figure 11 Computer flow diagram for subroutine DATA STORAGE.

the evaluation of the integral were calculated by the subroutine WVFCN.

Much care in writing the program was taken since values for the variables used in the program often approached zero or infinity leading to fatal math overflow errors and premature termination of the program. Checks and corrections for values which were becoming too large or small in magnitude were written into most of the subroutines. Once all the calculations were made the data was then stored in ASCII data files by subroutine DATA STORAGE. This ASCII data was later imported into a plotting program, Harvard Graphics (version 3.0), in order to plot the data. This allowed for more flexibility for the final graphical form of the data than if the data were plotted directly in the Fortran program itself.

Systems for which the program was applied were the SiC powder/Si<sub>3</sub>N<sub>4</sub> powder system and the FeAl powder/Al<sub>2</sub>O<sub>3</sub> fiber system. Extensive work was done with the SiC/Si<sub>3</sub>N<sub>4</sub> system since much was known about the colloidal and surface characteristics of the system due extensive investigations of this system by Crimp (76, 77). For this system there were three different SiC powders used, all of which were  $\alpha$ -SiC and manufactured by Lonza Inc. The three types used were LS-5, UF-10 and UF-15 for which the manufacturer reported 50% cumulative mass percent of particles with diameters finer than 5.5, 1.8, and 0.8 microns,

respectively. The  $\text{Si}_3\text{N}_4$  used was an  $\alpha$ - $\text{Si}_3\text{N}_4$  manufactured by UBE. The type used was SN-E10 which the manufacture reports has an average particle diameter of 0.5 microns.

This system was suspended in deionized water which had a variable indifferent electrolyte concentration of  $10^{-2}$  M,  $10^{-3}$  M and  $10^{-5}$  M. The indifferent electrolyte used was  $\text{KNO}_3$  and the bulk of the work was carried out with an electrolyte concentration of  $10^{-3}$  M. The pH was varied for this system by the addition of  $\text{HNO}_3$  and  $\text{KOH}$ . The systems were dispersed using an ultrasonic probe which would eliminate previous particle agglomeration.

The zeta potential data used in this investigation was of two different types. The first was microelectrophoresis zeta potential data previously collected by Crimp (70) using a PEN-KEM SYSTEM 3000 automated electrokinetics analyzer. These data were collected for the SN-E10  $\text{Si}_3\text{N}_4$  and the UF-10  $\text{SiC}$  at all three different electrolyte concentrations mentioned above. These data is shown in Figures 12 and 13. The data shown in Figure 13 stop at pH 5 since the zeta potential values level off (70) at this point. A logarithmic regression was done in order to extend this data to higher pHs using the standard logarithmic regression program of a HP-11C calculator and is shown in Figure 14. The other type of data used was Electrokinetic Sonic Amplitude (ESA) zeta potential data collected in this investigation using a Matec ESA-8000 system. ESA zeta

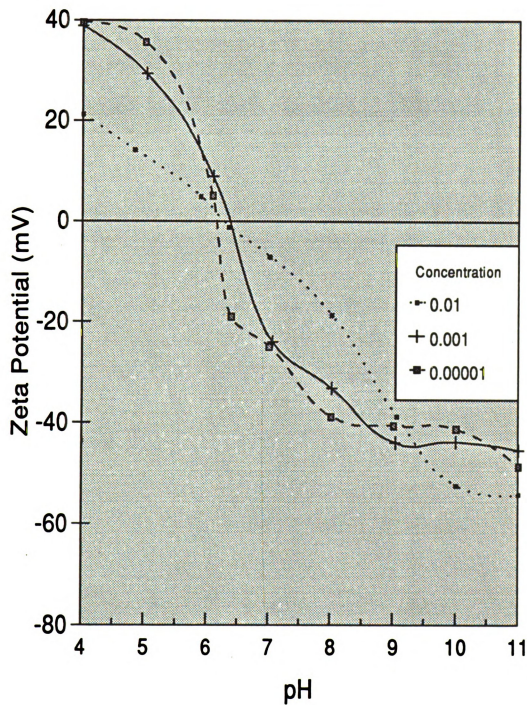


Figure 12 Electrophoretic zeta potential measurements for SN-E10  $\text{Si}_3\text{N}_4$  at varying electrolyte concentrations (M).

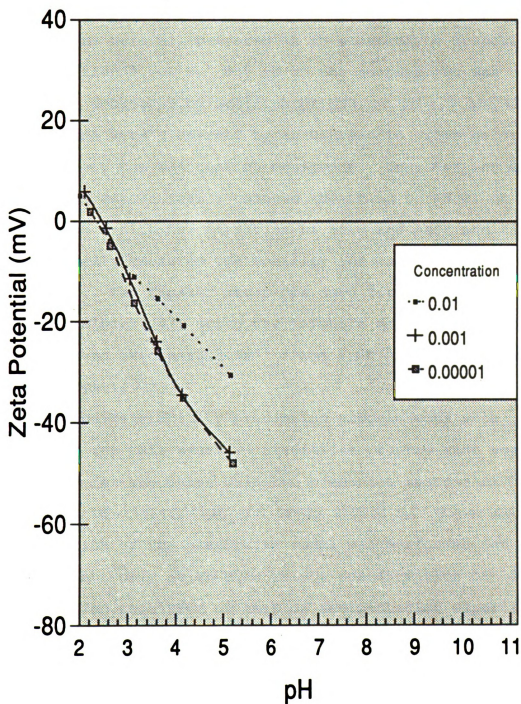


Figure 13 Electrophoretic zeta potential measurements for UF-10 SiC at varying electrolyte concentrations (M).

potential measurements were performed on all of the different types of SiC powders and on the Si<sub>3</sub>N<sub>4</sub> powder. The suspensions were all prepared in an electrolyte solution of concentration 0.001 M. The pH of the suspensions was initially decreased by addition of HNO<sub>3</sub> to pH 4.0 and the suspensions were dispersed by an ultrasonic probe before loading into the ESA testing equipment. Once testing began, the system automatically changed the pH up to pH 11 or back down to pH 4 with the titration of acid and base and also automatically measured the mobility and calculated the zeta potential. The Hamaker constants used for this system were found by Bleier (47) using the Lifshitz method. The values reported and used were  $3.0\text{E}^{-19}$  J and  $1.6\text{E}^{-19}$  J for SiC and Si<sub>3</sub>N<sub>4</sub>, respectively.

Extensive stability prediction program runs were performed for this system. Predictive program runs were performed for the three main two component systems of LS-5 SiC/Si<sub>3</sub>N<sub>4</sub>, UF-10 SiC/Si<sub>3</sub>N<sub>4</sub> and UF-15 SiC/Si<sub>3</sub>N<sub>4</sub>. Experimental verification of the predictive model was performed for these systems, but only at an electrolyte concentration of  $10^{-3}$  M. Verification consisted of sets of sedimentation experiments. Sedimentation experiments were performed for single component suspensions of each of the four powder types as well as for suspension of each of the three main two component systems listed above which were done with equal relative volume for each of the components. One more two

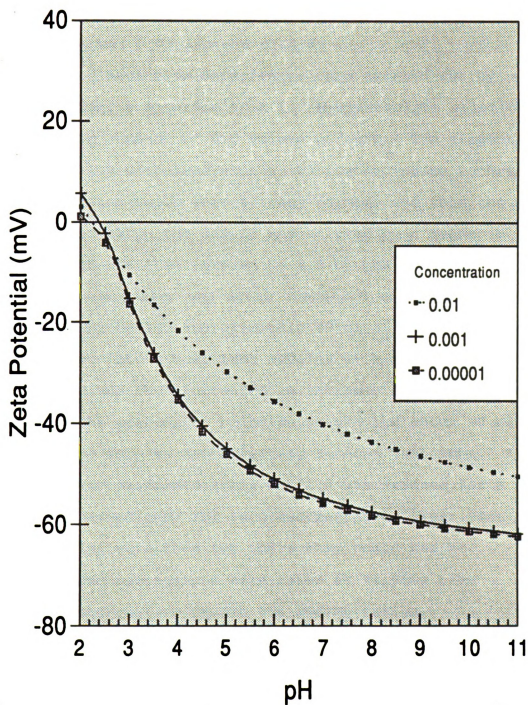


Figure 14 Electrophoretic zeta potential measurements for UF-10 SiC at varying electrolyte concentrations (M) with regression analysis.



component sedimentation experiment was performed for the UF-10 SiC/Si<sub>3</sub>N<sub>4</sub> system in which the relative volume fraction of SiC to Si<sub>3</sub>N<sub>4</sub> was 0.75 instead of 0.5.

The sedimentation experiments were carried out by making a 500ml suspension in a 10<sup>-3</sup> M electrolyte solution with a solid content of 0.5 volume percent. The suspensions were initially dispersed with an ultrasonic probe to break up agglomerates which were already formed, and then the pH was measured while the sample was stirred by a magnetic stir bar. The pH was then lowered to 4.0 by the addition of HNO<sub>3</sub>. The suspension was again dispersed with the ultrasonic probe and approximately 40 ml of the suspension being poured into a test tube labeled with the appropriate pH. The pH was then increased in increments of half of a pH unit with the suspension being sonicated and about 40 ml being poured into an appropriately labeled test tube. This procedure was performed until pH 11.0 was reached for a total of 15 specimens for each sedimentation experiment set. These samples were then set where they would not be disturbed and photographs were taken at varying time intervals in order to record the sedimentation.

The other system of FeAl/Al<sub>2</sub>O<sub>3</sub> fiber was investigated in only a preliminary manner in order to predict the ideal pH for processing at which the individual components would be stable, but at which heterocoagulation occurs (i.e. where the powder and fiber are attracted to each other, but not to

themselves). The FeAl powder used was AMDRY FeAl and was manufactured by Alloy Metals, Inc. The as received powder had a particle size range of 177 microns down to tenths of microns. The powder was sedimented down to a size range of 10 microns to tenths of microns through the efforts of Jeff Bajt and Chris Suydam. The average particle diameter was determined to be 7 microns, and a SEM micrograph of this sedimented powder can be seen in Figure 15. The  $\text{Al}_2\text{O}_3$  fiber was manufactured by DuPont and is a continuous, pure alumina fiber of type Fiber FP. The average fiber diameter was reported by the manufacturer to be 25 to 30 microns which was confirmed by SEM observations. The fibers were chopped up and ground to smaller lengths with mortar and pestle. A SEM micrograph of the chopped fiber can be seen in Figure 16.

This system was also suspended using a  $\text{KNO}_3$  electrolyte solution in deionized water and pH changes were made with  $\text{HNO}_3$  and  $\text{KOH}$  as with the previous system, but only a  $\text{KNO}_3$  concentration of  $10^{-3}$  M was used. The zeta potential data used for this system was collected in this investigation using the Matec ESA-8000 system. The Hamaker constant for the alumina fiber was calculated from refractive index data (78) using the Lifshitz method (Equation [3]) and found to be  $1.1\text{E}^{-19}$  J. Since no refractive index or dielectric constant data could be found for the FeAl, the Hamaker constant used was a value for metals given by Shaw (15) to

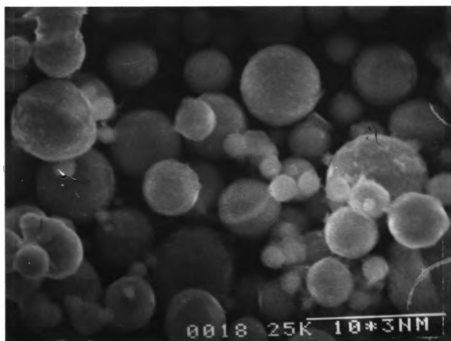


Figure 15 SEM micrograph of sedimented FeAl powder.

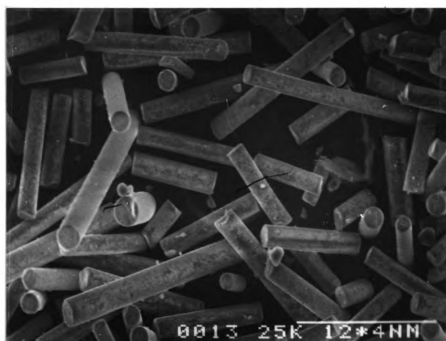


Figure 16 SEM micrograph of chopped Al<sub>2</sub>O<sub>3</sub> fiber.

be  $2.2E^{-19}$  J.

Three different predictive program runs were performed for the FeAl/Al<sub>2</sub>O<sub>3</sub> fiber system. The first was performed using the particle size data mentioned earlier (i.e. particle diameters of 7 microns and 30 microns for the FeAl and alumina fiber, respectively). The other two predictive runs used increasing FeAl particle size to see if larger FeAl particle sizes would also be possible to get the ideal processing conditions of individual component stability coupled with heterocoagulation.

## RESULTS

The results for the acoustophoresis (ESA) measurement data for LS-5 SiC, UF-10 SiC, UF-15 SiC and the SN-E10 Si<sub>3</sub>N<sub>4</sub> can be seen in Figures 17, 18 19, and 20, respectively. Predictive program runs were performed for the three main two component systems of LS-5 SiC/Si<sub>3</sub>N<sub>4</sub>, UF-10 SiC/Si<sub>3</sub>N<sub>4</sub>, and UF-15 SiC/Si<sub>3</sub>N<sub>4</sub>. The first of these experimental runs was performed using the constant potential repulsive equation and electrophoretic zeta potential data at a concentration of  $10^{-3}$  M. The results of this data run are shown in Figure 21. Another of these experimental runs was performed using the constant potential repulsive equation along with ESA zeta potential data at a concentration of  $10^{-3}$  M. The results of these data run are shown in Figure 22. The constant charge form of the repulsive potential equation was used along with electrophoretic data for an electrolyte concentration  $10^{-3}$  M for the third run for these systems. These results are shown in Figure 23. The interparticle potential vs. interparticle separation distance for each pH of the first data run (i.e. Figure 21) is plotted in Figure 24. A fourth program run was performed which used the constant potential form for the repulsive potential equation

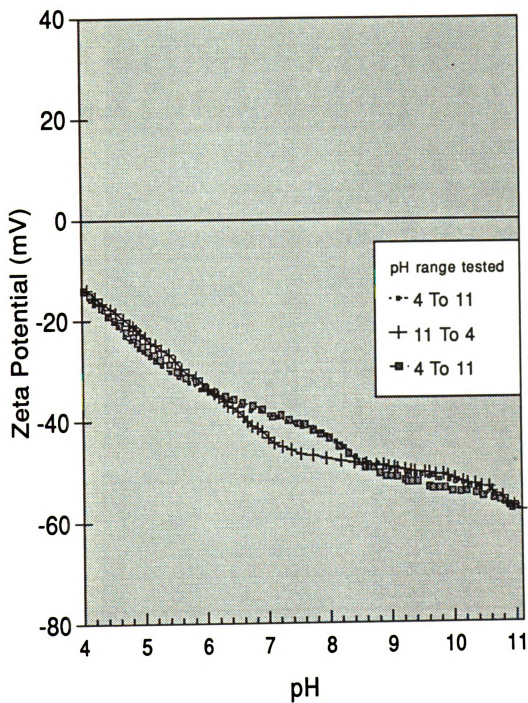


Figure 17 ESA zeta potential measurements for LS-5 SiC at an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$ .

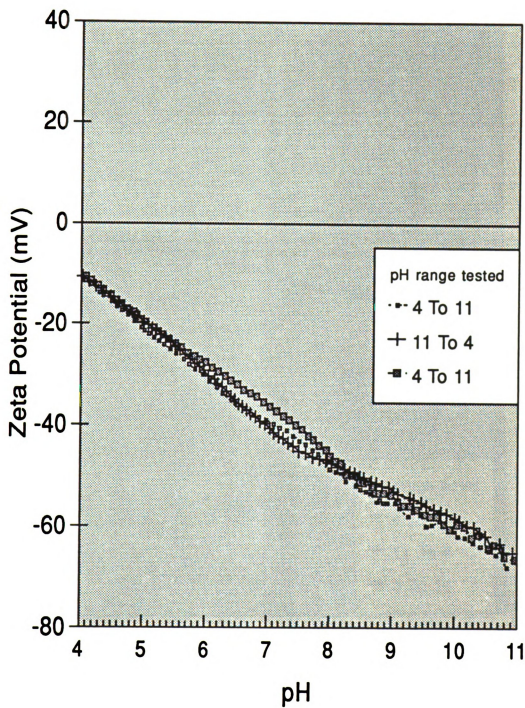


Figure 18 ESA zeta potential measurements for UF-10 SiC at an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$ .



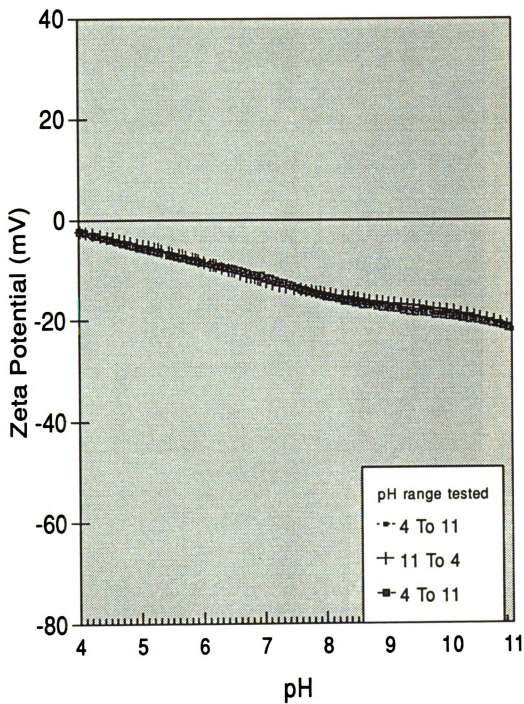


Figure 19 ESA zeta potential measurements for UF-15 SiC at an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$ .

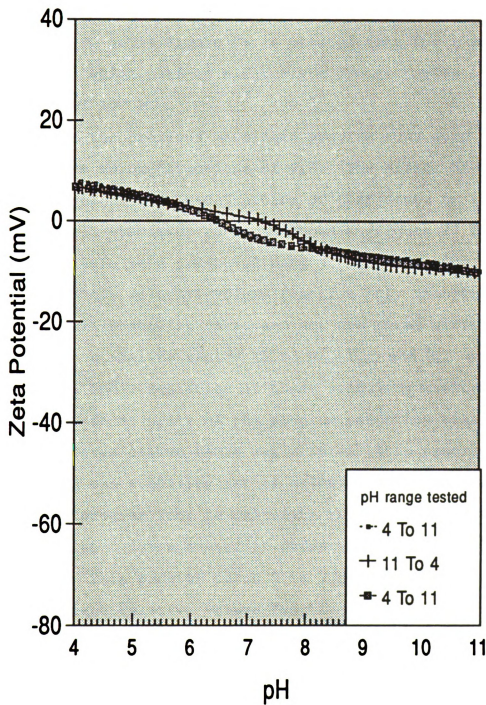


Figure 20 ESA zeta potential measurements for SN-E10  $\text{Si}_3\text{N}_4$  at an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$ .

and used electrophoresis zeta potential data for an electrolyte concentration of  $10^{-2}$  M. This data is plotted in Figure 25, while Figure 26 is plotted data for a similar program run which uses an electrolyte concentration of  $10^{-5}$  M instead of  $10^{-2}$  M.

All of the previous mentioned program runs were done for relative volume fractions of 0.5. The effect of different relative volume fraction of components on the total overall stability ratio is shown in Figure 27 for electrophoresis zeta potential data at concentration of 0.001 M. Since relative volume fraction only changes the total overall stability ratio and not the three different interaction stability ratios (i.e.  $W_{11}$ ,  $W_{12}$ , and  $W_{22}$ ) and since it is the calculation of these stability ratios which takes the vast majority of the program execution time another program called VARYN was written. This program simply uses the stability ratios calculated in the Stability Prediction program runs to calculate the total overall stability ratio for a number of different relative volume fractions. This program takes 2 to 3 seconds to execute five different relative volume fractions as opposed to the Stability Prediction program which takes from 30 minutes to 2 hours per different volume fraction.

Predictive program runs were also performed to see the sensitivity of the programs to variations of the input data. The first of these program runs varied the temperature for

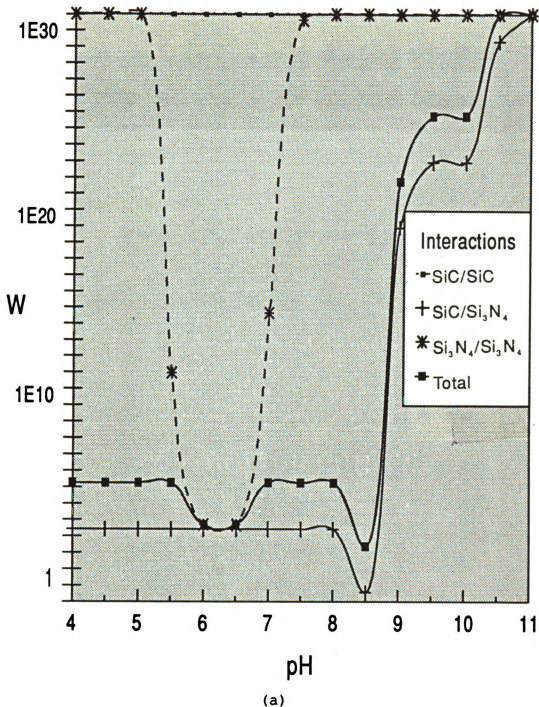
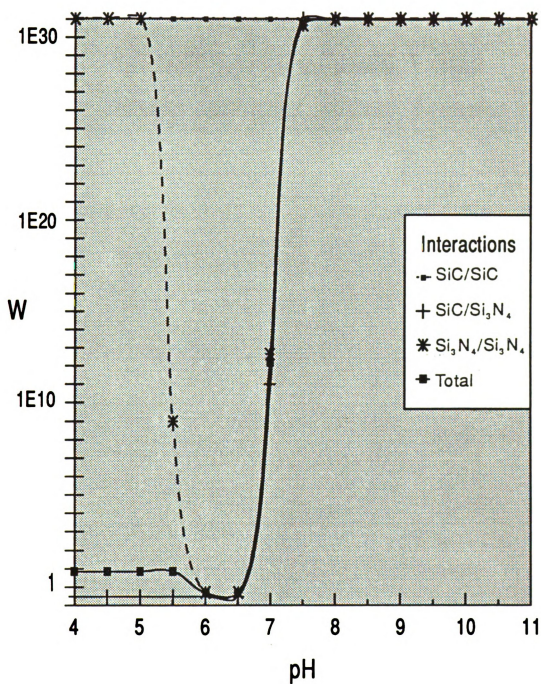


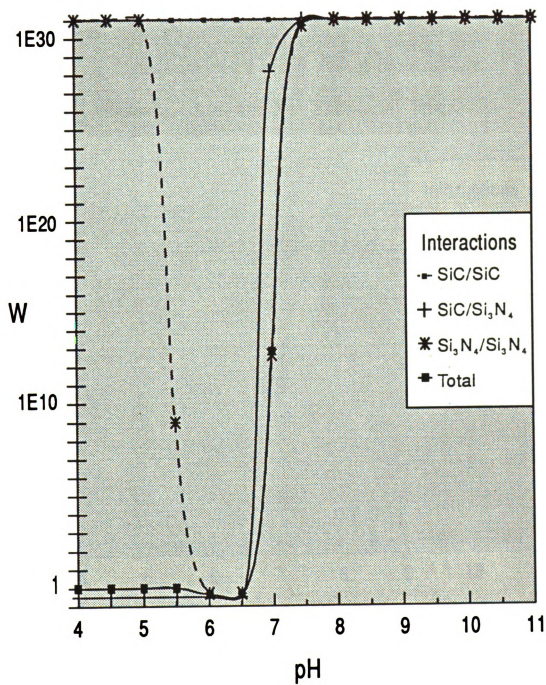
Figure 21 Stability ratio data from the predictive program using the constant potential repulsive equation and electrophoretic zeta potential for a) LS-5 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , b) UF-10 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , and c) UF-15 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , where: temperature is 25 °C, volume fraction of components is 0.5 and electrolyte concentration is  $10^{-3}$  M  $\text{KNO}_3$ .



(b)

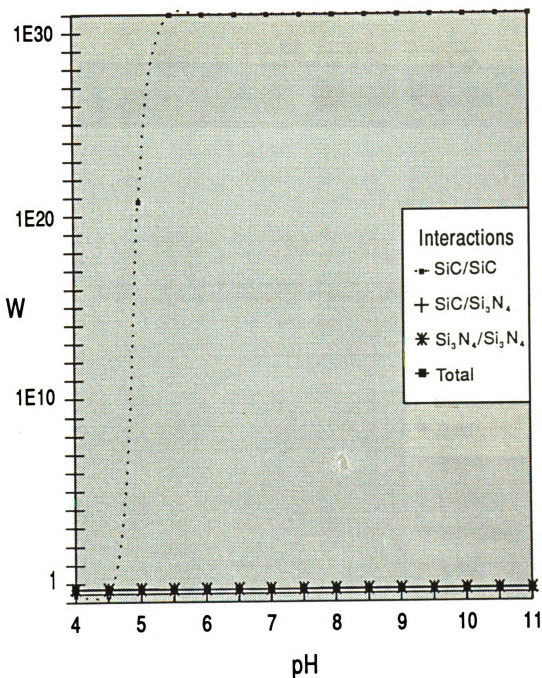
Figure 21 cont.





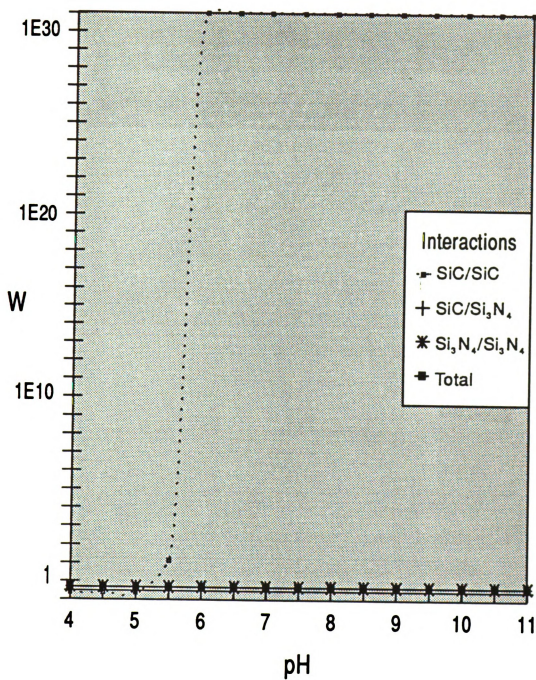
(c)

Figure 21 Cont.



(a)

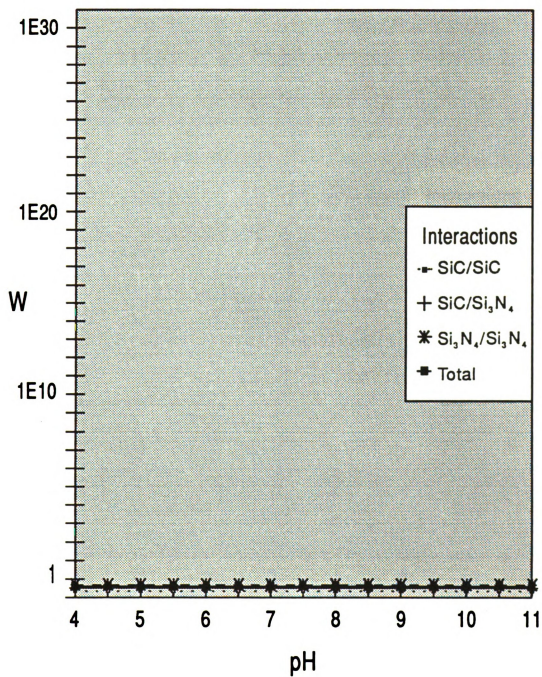
Figure 22 Stability ratio data from the predictive program using the constant potential repulsive equation and ESA zeta potential for a) LS-5 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, b) UF-10 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, and c) UF-15 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, where: temperature is 25 °C, volume fraction of components is 0.5 and electrolyte concentration is  $10^{-3}$  M KNO<sub>3</sub>.



(b)

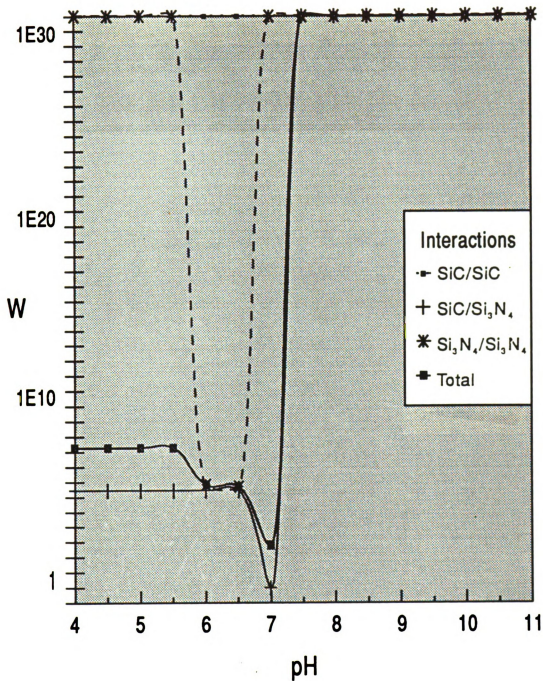
Figure 22 Cont.





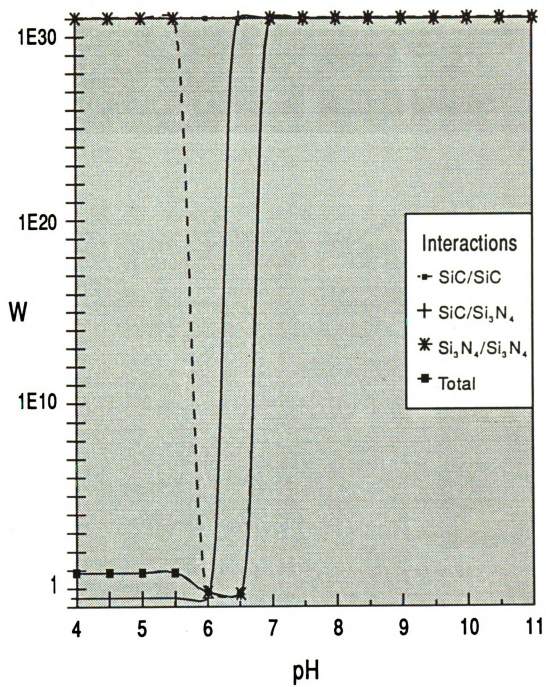
(c)

Figure 22 cont.



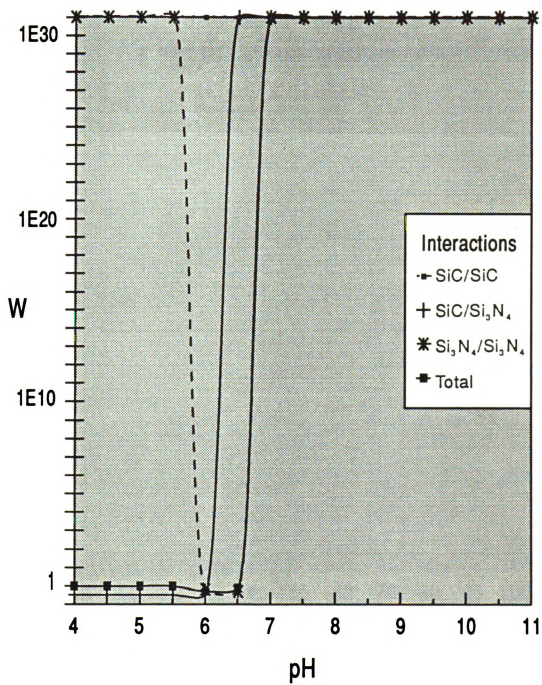
(a)

Figure 23 Stability ratio data from the predictive program using the constant charge repulsive equation and ESA zeta potential for a) LS-5 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , b) UF-10 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , and c) UF-15 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , where: temperature is 25 °C, volume fraction of components is 0.5 and electrolyte concentration is  $10^{-3}$  M  $\text{KNO}_3$ .



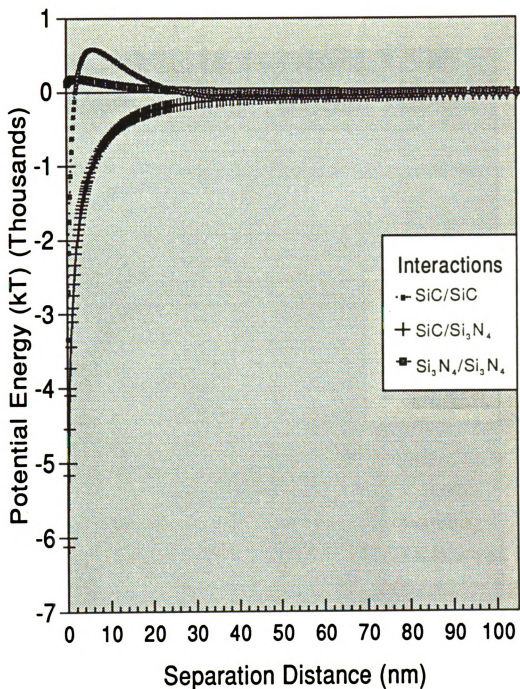
(b)

Figure 23 Cont.



(C)

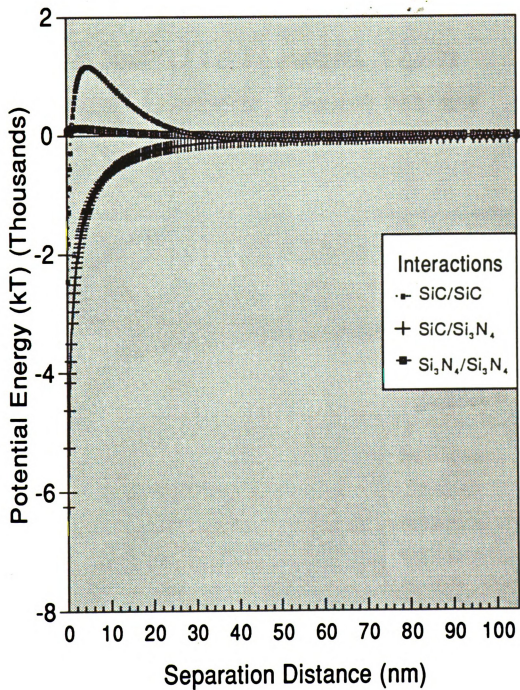
Figure 23 Cont.



(a) pH=4.0

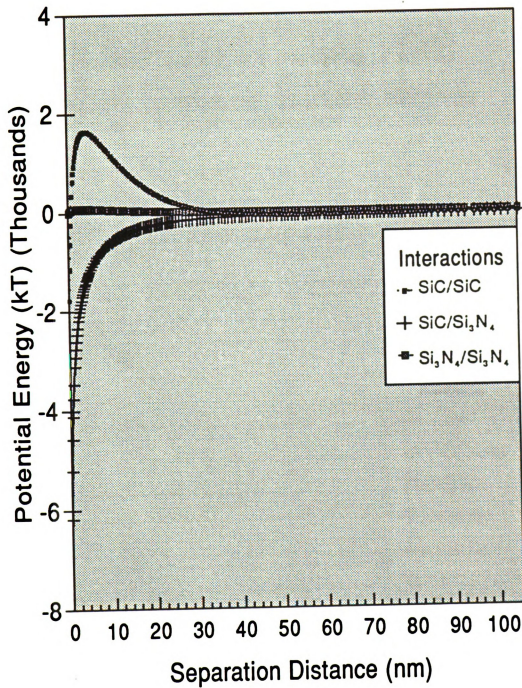
Figure 24 Interaction potential data from the predictive program using the constant potential repulsive equation and electrophoretic zeta potential for LS-5 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, where: temperature is 25°C, volume fraction of components is 0.5 and electrolyte concentration is 10<sup>-3</sup> M.





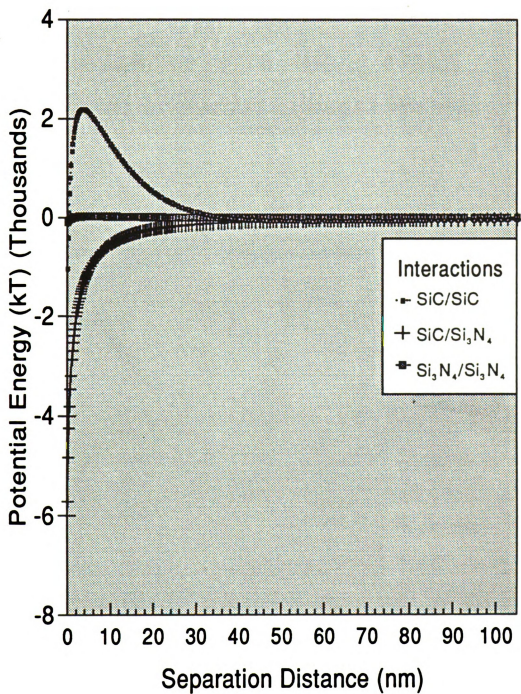
(b) pH= 4.5

Figure 24 Cont.



(c) pH= 5.0

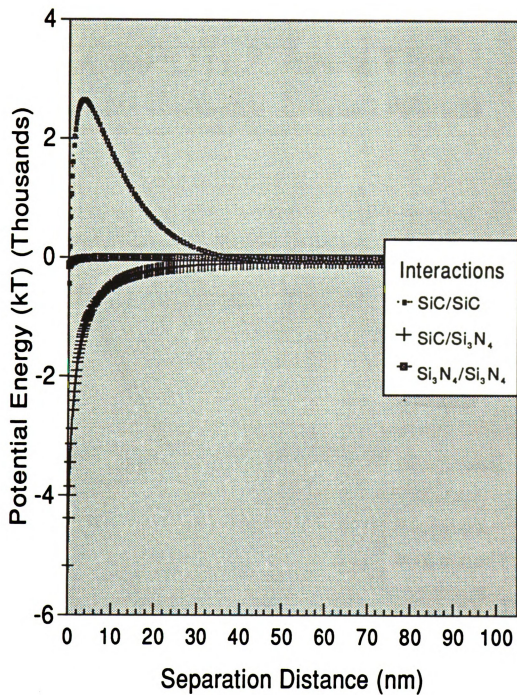
Figure 24 Cont.



(d) pH= 5.5

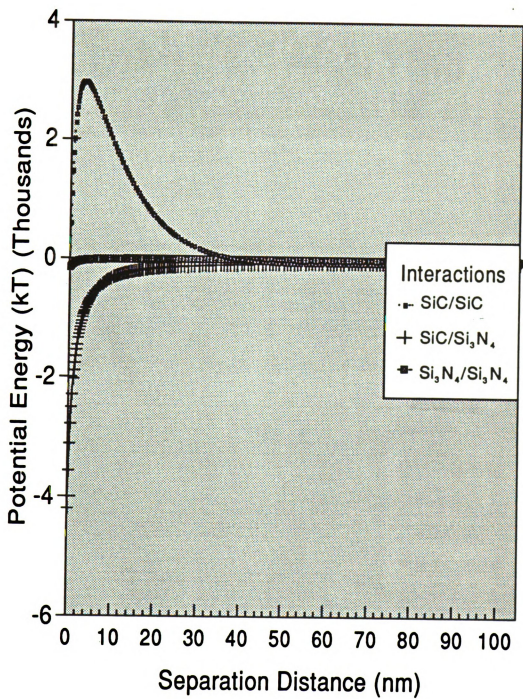
Figure 24 Cont.





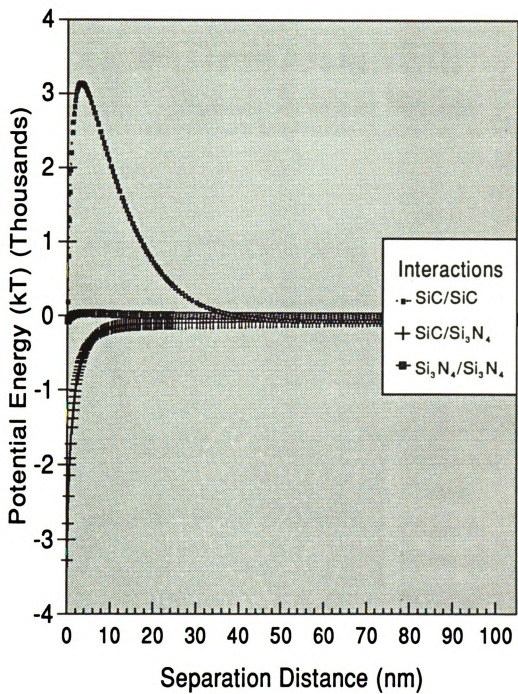
(e) pH= 6.0

Figure 24 Cont.



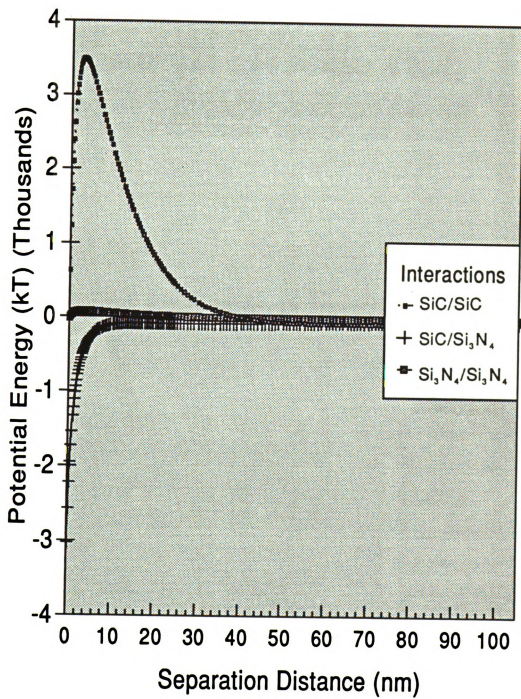
(f) pH= 6.5

Figure 24 Cont.



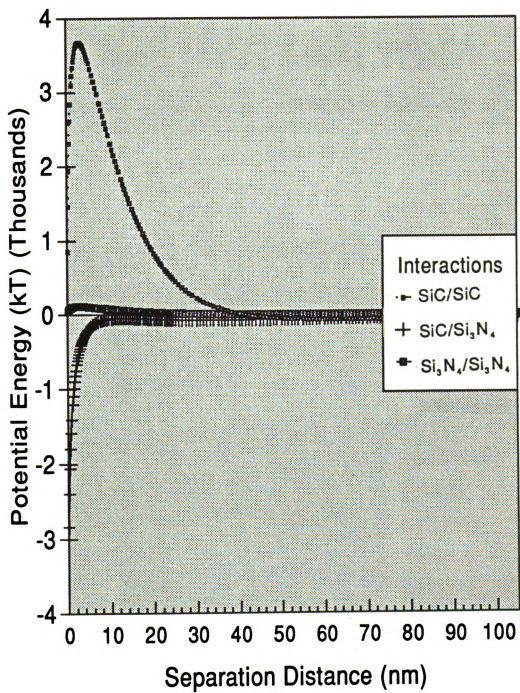
(g) pH= 7.0

Figure 24 Cont.



(h) pH= 7.5

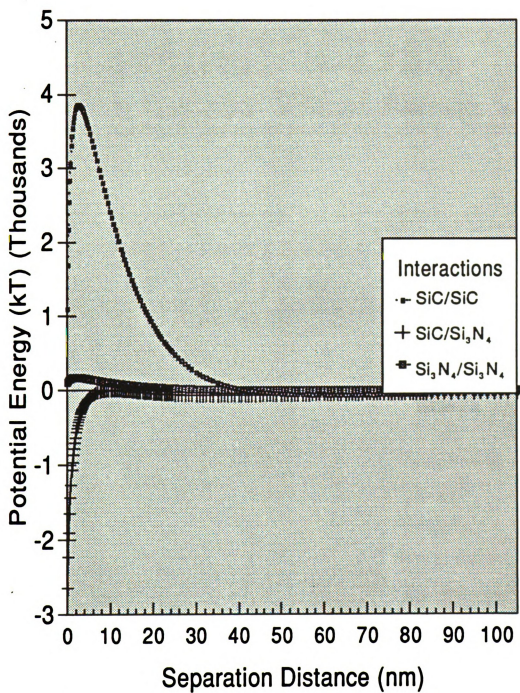
Figure 24 Cont.



(i) pH= 8.0

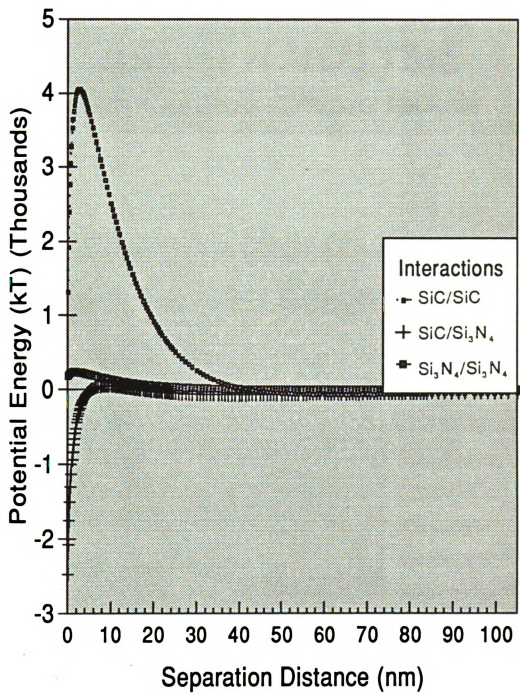
Figure 24 Cont.





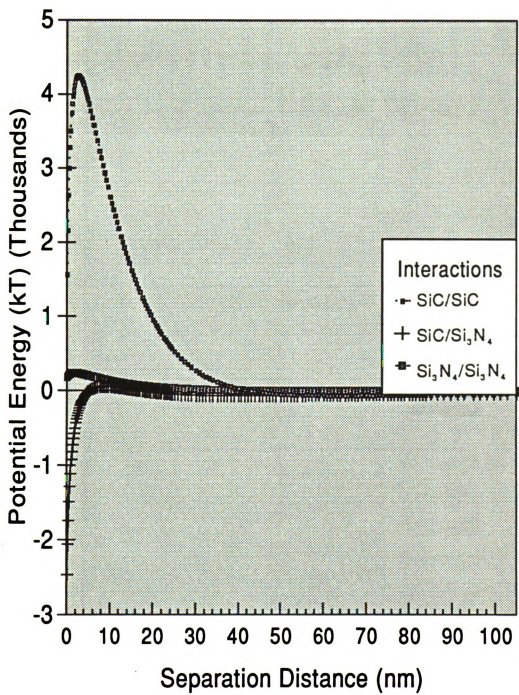
(j) pH= 8.5

Figure 24 Cont.



(k) pH= 9.5

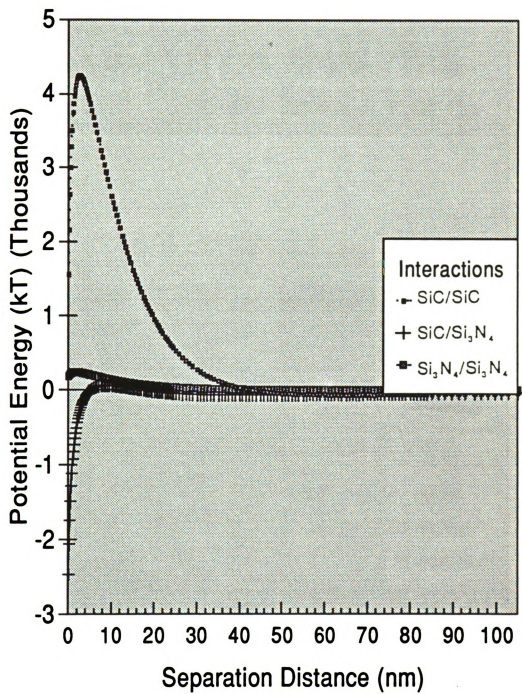
Figure 24 Cont.



(1) pH= 9.5

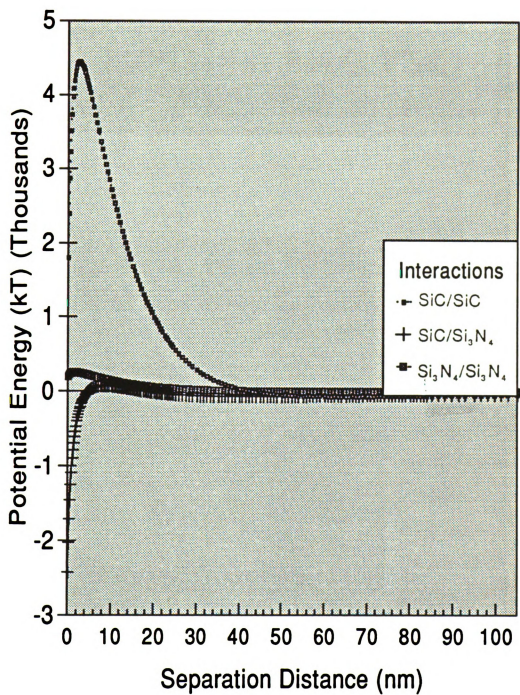
Figure 24 Cont.





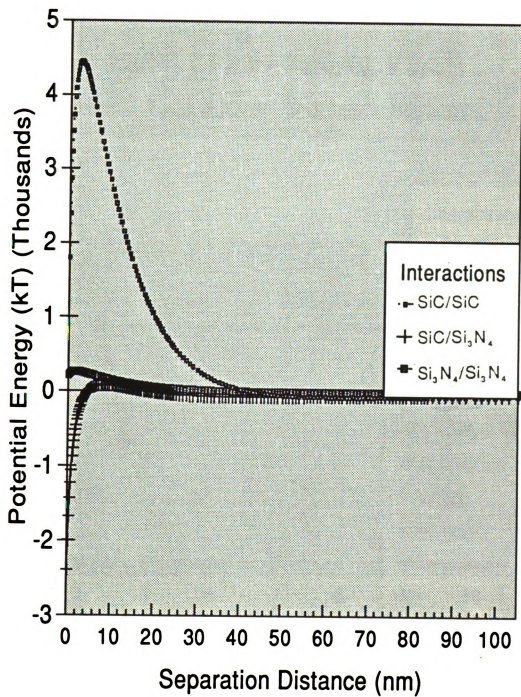
(m) pH= 10.0

Figure 24 Cont.



(n) pH= 10.5

Figure 24 Cont.



(o) pH = 11.0

Figure 24 cont.

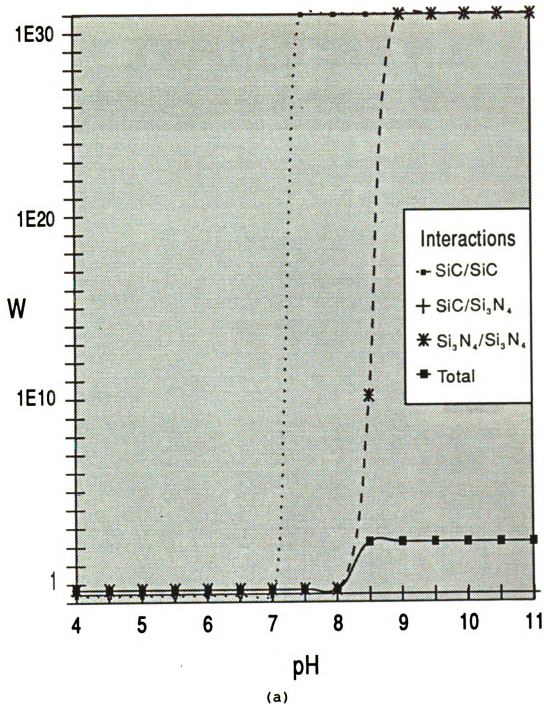
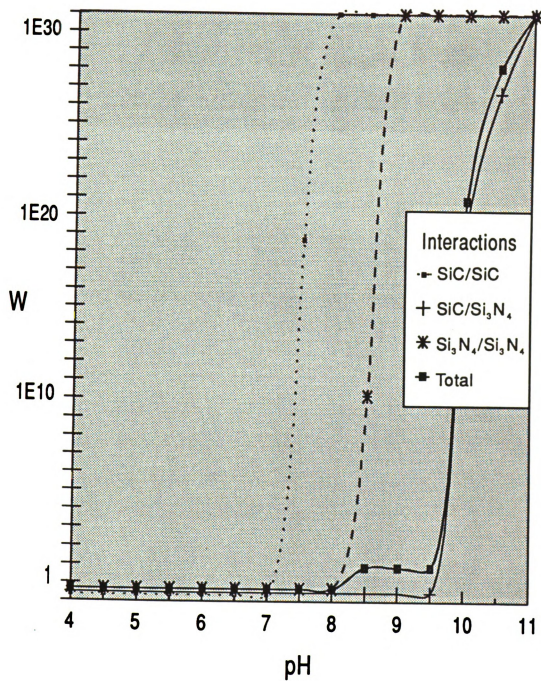


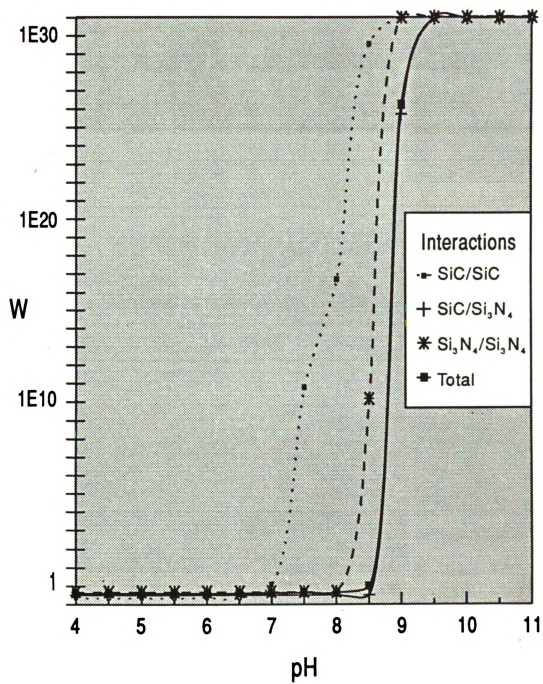
Figure 25 Stability ratio data from the predictive program using the constant potential repulsive equation and electrophoretic zeta potential for a) LS-5 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , b) UF-10 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , and c) UF-15 SiC/SN-E10  $\text{Si}_3\text{N}_4$ , where: temperature is  $25^\circ\text{C}$ , volume fraction of components is 0.5 and electrolyte concentration is  $10^{-2}$  M.



(b)

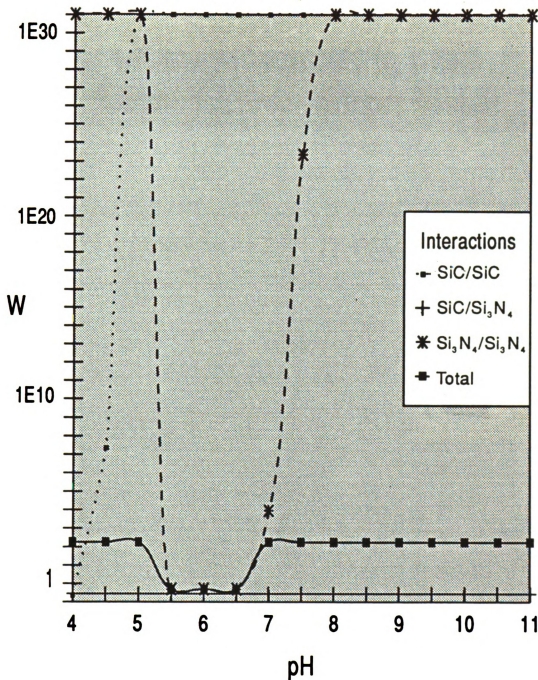
Figure 25 Cont.





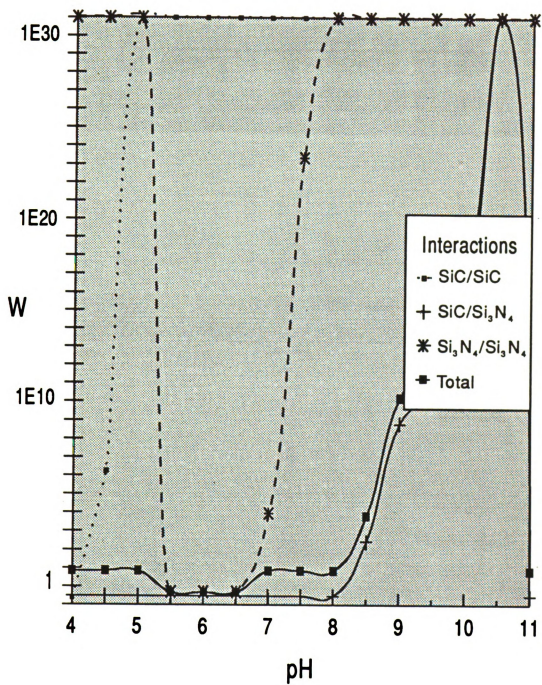
(c)

Figure 25 Cont.



(a)

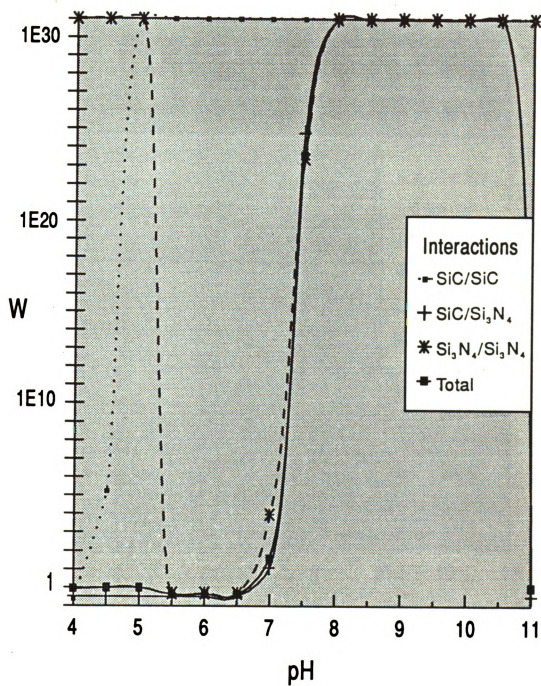
Figure 26 Stability ratio data from the predictive program using the constant potential repulsive equation and electrophoretic zeta potential for a) LS-5 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, b) UF-10 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, and c) UF-15 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, where: temperature is 25 °C, volume fraction of components is 0.5 and electrolyte concentration is  $10^{-5}$  M.



(b)

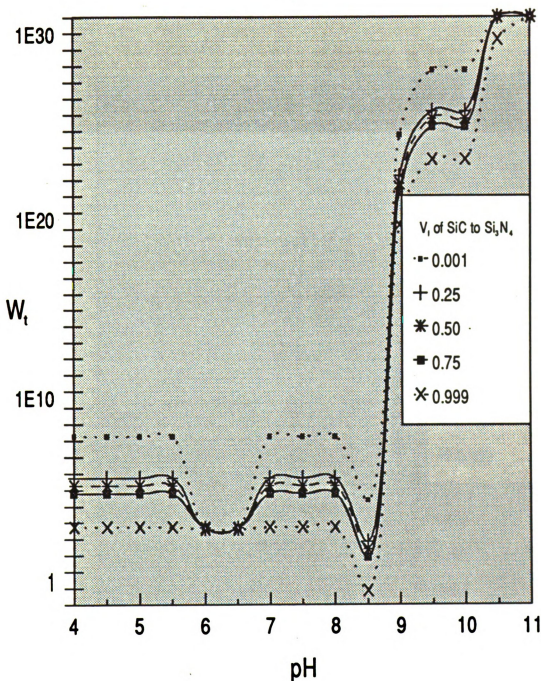
Figure 26 Cont.





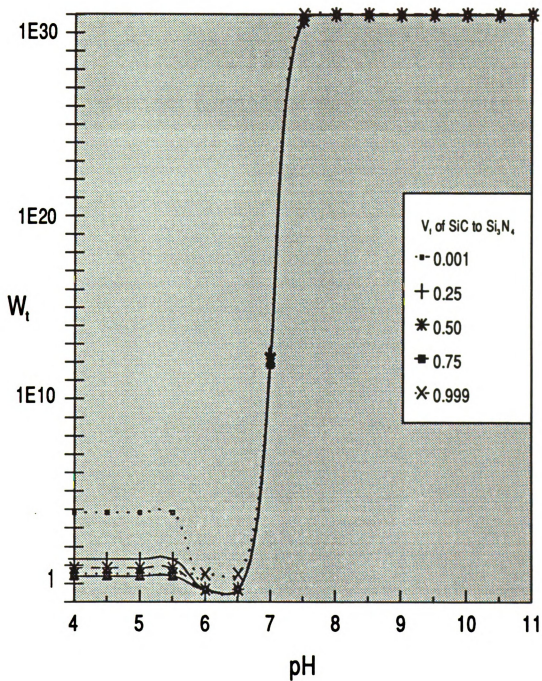
(c)

Figure 26 Cont.



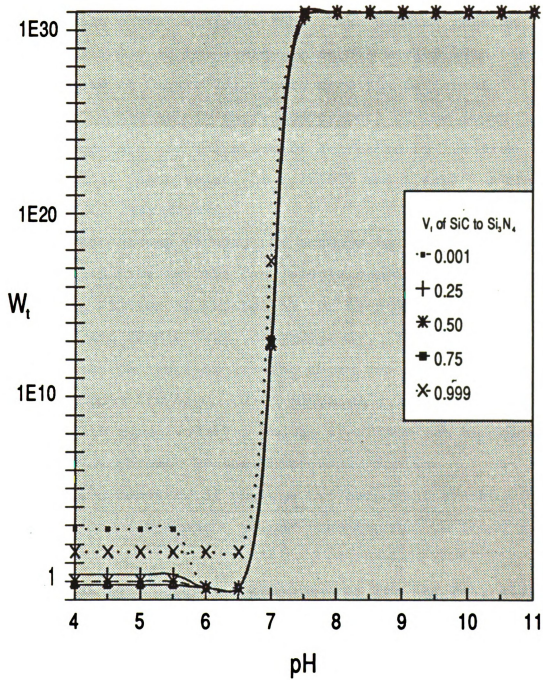
(a)

Figure 27 Total stability ratio data from the program VARYN using data from the predictive program which used the constant potential repulsive equation and electrophoretic zeta potential for a) LS-5 SiC/SN-E10  $Si_3N_4$ , b) UF-10 SiC/SN-E10  $Si_3N_4$ , and c) UF-15 SiC/SN-E10  $Si_3N_4$ , where: temperature is 25 °C, volume fraction of components is varied and electrolyte concentration is  $10^{-3}$  M.



(b)

Figure 27 Cont.



(c)

Figure 27 Cont.

the system with variations from room temperature of plus or minus 5 °C being shown in Figure 28a) and larger temperature changes being shown in Figure 28b). The Hamaker constant was another input of the system which was varied with the results shown in Figure 29. There were six different variations in the values where one or both of the input Hamaker constants was increased or decreased by 10% from their original input values of  $3.0 \times 10^{-19}$  and  $1.6 \times 10^{-19}$  J for SiC and Si<sub>3</sub>N<sub>4</sub>, respectively.

The photographs showing the changes in sedimentation as a function of time for the four single component systems can be found in Figures 30 through 33 for LS-5 SiC, UF-10 SiC, UF-15 SiC, and SN-E10 Si<sub>3</sub>N<sub>4</sub>, respectively. The sedimentation photographs for the three two component systems of LS-5 SiC/Si<sub>3</sub>N<sub>4</sub>, UF-10 SiC/Si<sub>3</sub>N<sub>4</sub>, and UF-15 SiC/Si<sub>3</sub>N<sub>4</sub> with equal relative volume fractions can be found in Figures 34 through 36 and photographs for the sedimentation behavior of the one two component system with unequal relative component volume fraction can be found in Figure 37.

The ESA zeta potential measurements for the FeAl/Al<sub>2</sub>O<sub>3</sub> fiber system in an electrolyte solution of concentration equal to  $10^{-3}$  M are shown in Figures 38 and 39. These data was used along with the constant potential solution for the repulsive interaction potential in stability prediction runs for the system. This data generated in these prediction



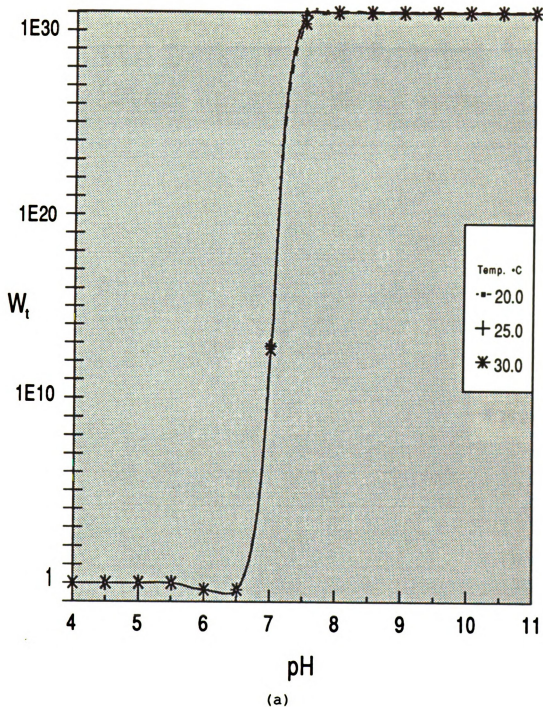
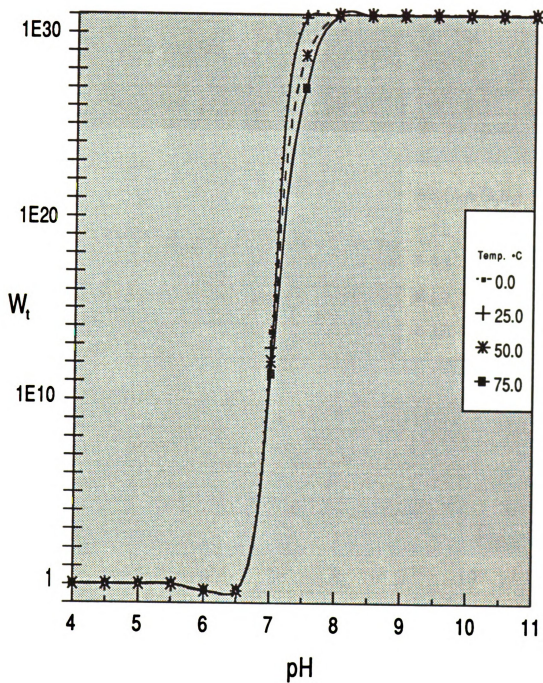


Figure 28 Stability ratio data from the predictive program using the constant potential repulsive equation and electrophoretic zeta potential for UF-15 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, where: temperature is a) 20, 25, and 30 °C and b) 0, 25, 50, 75 °C volume fraction of components is 0.5 and electrolyte concentration is  $10^{-3}$  M.



(b)

Figure 28 Cont.

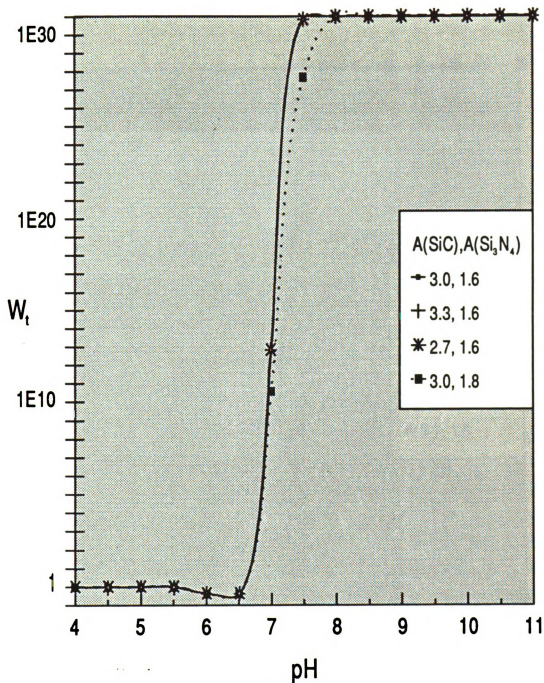
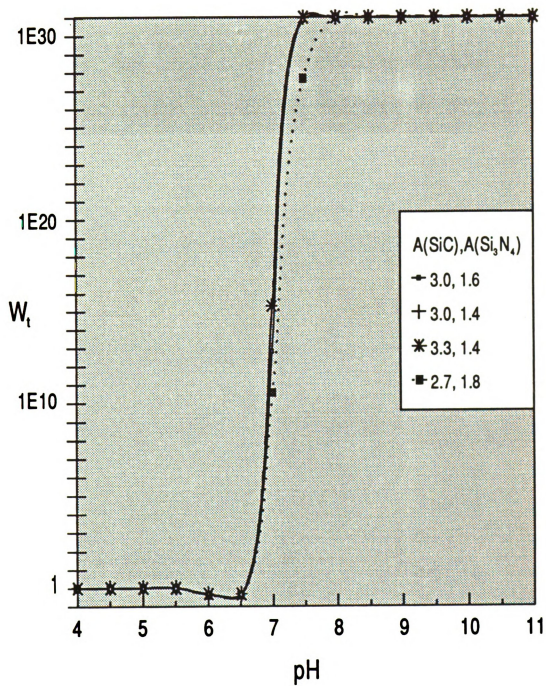


Figure 29 Stability ratio data from the predictive program using the constant potential repulsive equation and electrophoretic zeta potential for UF-15 SiC/SN-E10 Si<sub>3</sub>N<sub>4</sub>, where: temperature is 25 °C volume fraction of components is 0.5, the electrolyte concentration is 10<sup>-3</sup> M, and the Hamaker constants in units of 10<sup>-19</sup> J are varied by +/- 10% to the values noted in a) and b).

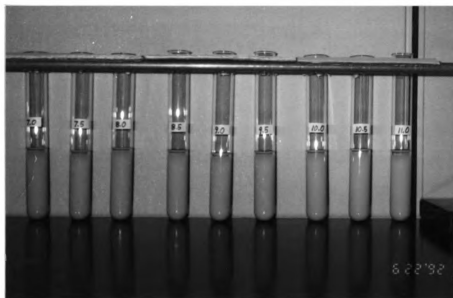




(b)

Figure 29 Cont.

runs are plotted in Figure 40.

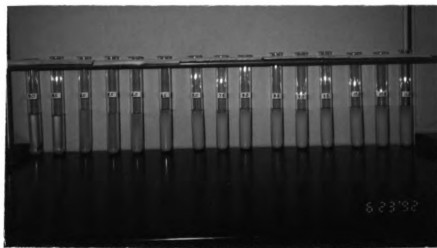


(a)



(b)

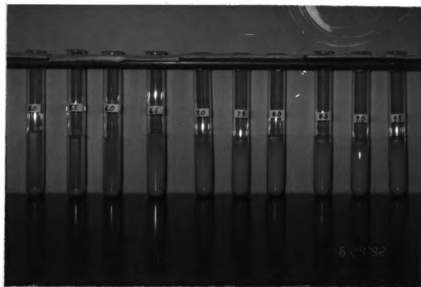
Figure 30 Sedimentation samples for a single component suspension of LS-5 SiC with an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$  after sedimentation for a) 21 hours, b) 21 hours, c) 21 hours, d) 73 hours, and e) 73 hours.



(c)



(d)



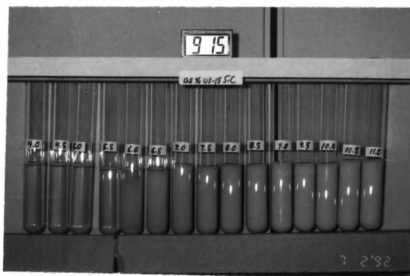
(e)



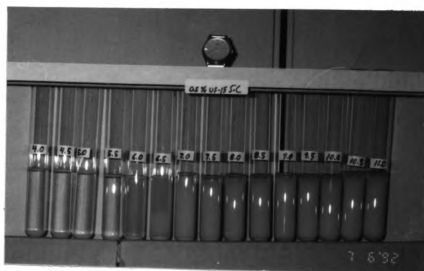
(a)

(b)

Figure 31 Sedimentation samples for a single component suspension of UF-10 SiC with an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$ , after sedimentation for a) 21 hours, and b) 119 hours.

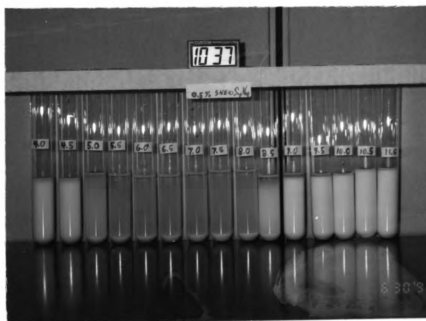


(a)

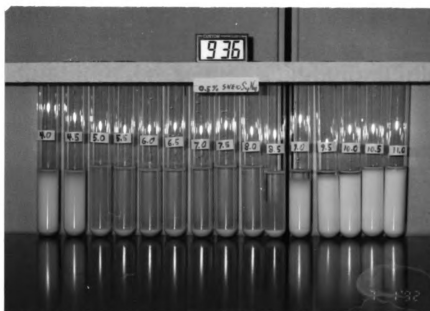


(b)

Figure 32 Sedimentation samples for a single component suspension of UF-15 SiC with an electrolyte concentration of  $10^{-3}$  M after sedimentation for a) 20 hours, and b) 118 hours.



(a)



(b)

Figure 33 Sedimentation samples for a single component suspension of SN-E10  $\text{Si}_3\text{N}_4$  with an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$  after sedimentation for a) 1.5 hours, b) 24 hours, c) 48 hours and d) 146 hours.





(c)

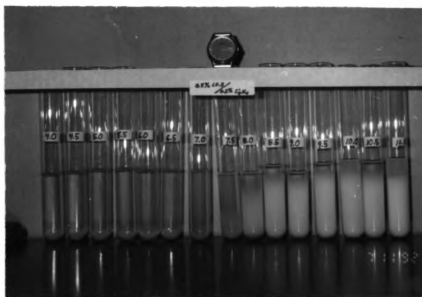


d)

Figure 33 Cont.



(a)



(b)

Figure 34 Sedimentation samples for a two component suspension of 0.5 relative volume fraction of LS-5 SiC and SN-E10  $\text{Si}_3\text{N}_4$  with an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$  after sedimentation for a) 0 hours, and b) 72 hours.



(a)



(b)

Figure 35 Sedimentation samples for a two component suspension of 0.5 relative volume fraction of UF-10 SiC and SN-E10 Si<sub>3</sub>N<sub>4</sub>, with an electrolyte concentration of 10<sup>-3</sup> M KNO<sub>3</sub>, after sedimentation for a) 29 hours, and b) 70 hours.



(a)

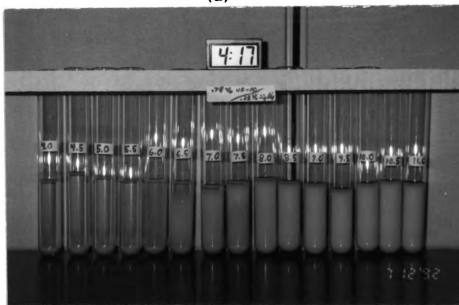


(b)

Figure 36 Sedimentation samples for a two component suspension of 0.5 relative volume fraction of UF-15 SiC and SN-E10 Si<sub>3</sub>N<sub>4</sub>, with an electrolyte concentration of  $10^{-3}$  M KNO<sub>3</sub>, after sedimentation for a) 23 hours, and b) 64 hours.



(a)



(b)

Figure 37 Sedimentation samples for a two component suspension of 0.75 relative volume fraction of UF-10 SiC and SN-E10 Si<sub>3</sub>N<sub>4</sub>, with an electrolyte concentration of 10<sup>-3</sup> M KNO<sub>3</sub>, after sedimentation for a) 22 hours, and b) 63 hours.

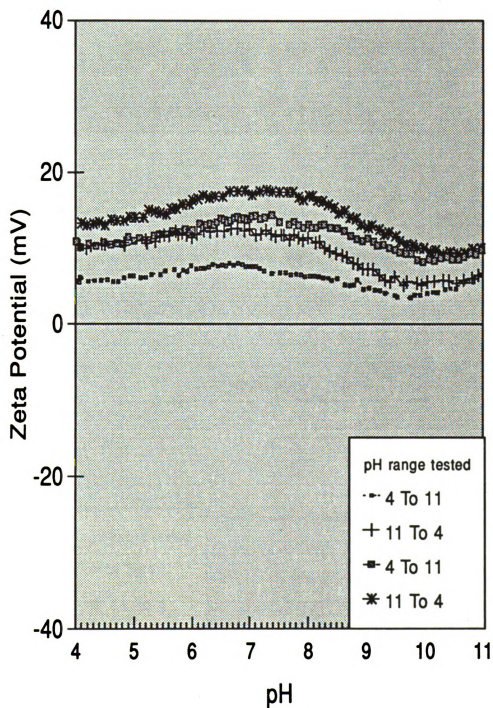


Figure 38 ESA zeta potential measurements for FeAl powder at an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$ .

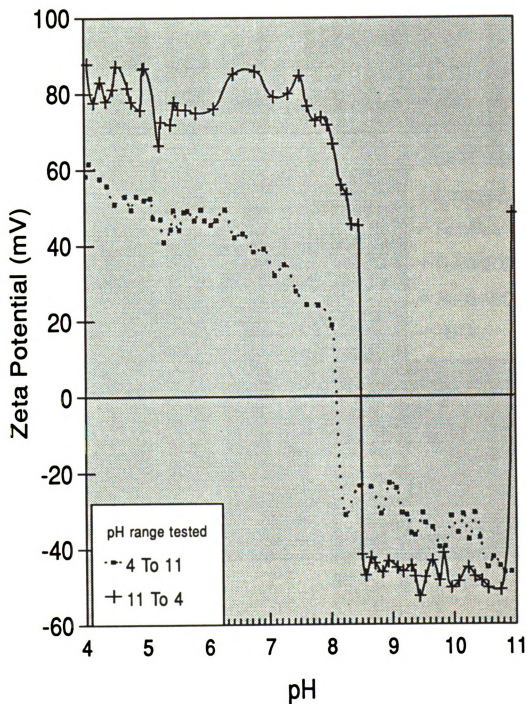


Figure 39 ESA zeta potential measurements for  $\text{Al}_2\text{O}_3$  fiber at an electrolyte concentration of  $10^{-3}$  M  $\text{KNO}_3$ .

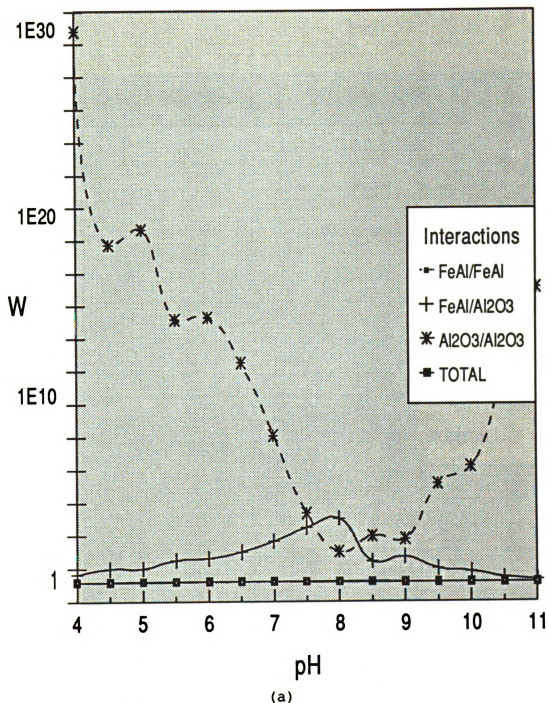
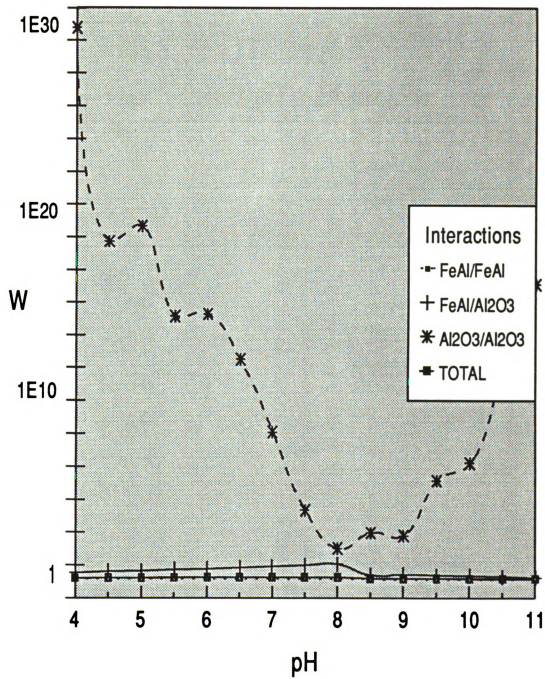


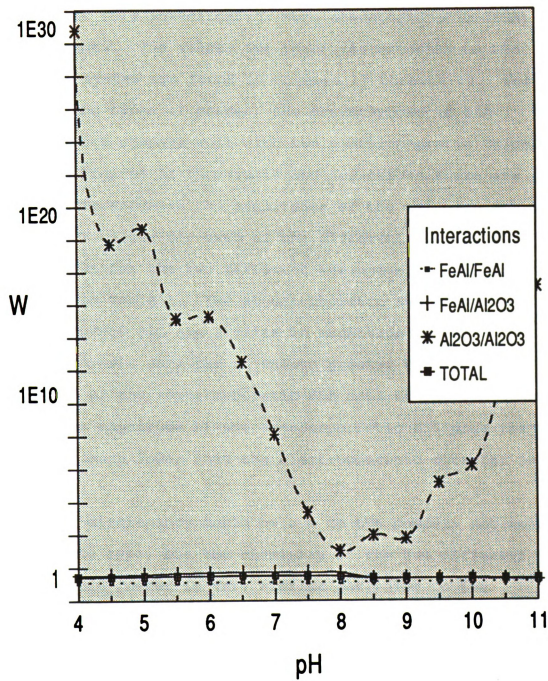
Figure 40 Stability ratio data from the predictive program using the constant potential repulsive equation and ESA zeta potential for FeAl and  $\text{Al}_2\text{O}_3$ , radii of a) 3.5 and 15.0 microns, b) 7.5 and 15.0 microns, and c) 12.5 and 15.0 microns respectively, where: temperature is 25 °C, volume fraction of components is 0.5 and electrolyte concentration is  $10^{-3}$  M  $\text{KNO}_3$ .





(b)

Figure 40 Cont.



(c)

Figure 40 Cont.

## DISCUSSION

The zeta potential data measured in the experimental portion of this investigation were acoustophoretic (ESA) measurements. The values for these measurements on the SiC/Si<sub>3</sub>N<sub>4</sub> system are found in Figures 17 through 20. For some of the types of powder, the acoustophoretic ESA measurements compare well with the electrophoretic values shown in Figures 12 through 14 and for others there are major differences in the magnitudes of the values. A summary of values for each of the different powders at several pHs for the two different measurement techniques can be found in Table 1. The acoustophoretic ESA data for the LS-5 and UF-10 SiC are similar in magnitude to the electrophoresis data for pH values greater than 5, while the magnitude of the acoustophoretic ESA data at lower pHs are less. The magnitude of the acoustophoretic ESA data for UF-15 SiC is much lower than the electrophoretic data for the UF-10 SiC.

This discrepancy could be due to the powders not being of the same type, but the chemistry of the two different types of SiC powder is very similar according to the manufacturer and so surface charge generation and zeta potential values would be expected to be similar. Examination of the Si<sub>3</sub>N<sub>4</sub> acoustophoretic ESA data shows a similar behavior, with the magnitude of the acoustophoretic

Table 1 Zeta potential values at several pHs from acoustophoresis (ESA) and electrophoresis measurements.

pH Values	ESA LS-5	ESA UF-10	ESA UF-10	ESA SN-E10	Electrophoresis UF-10	Electrophoresis SN-E10
4	-10	-14	-2.2	8.0	-34	44
5	-20	-26	-5.5	5.7	-44	29.4
7	-39	-38	-11	-3.5	-54	-24
8.5	-52	-47	-16	-5.8	-58	-38
10	-61	-52	-19	-7.8	-60	-43

ESA zeta potential data being much lower in magnitude than the values of the electrophoresis data for the same type of  $\text{Si}_3\text{N}_4$  powder. Both the UF-15 SiC and  $\text{Si}_3\text{N}_4$  powder are of a similar small size range. A similar discrepancy between measured acoustophoretic ESA data and electrophoresis data was discussed by James, Hunter, and O' Brien (79) in testing several different types of alumina powders and UBE SN-E10  $\text{Si}_3\text{N}_4$ . For  $\text{Si}_3\text{N}_4$ , these authors showed that if an effective radius was used for the average particle size to calculate the zeta potential with the acoustophoretic ESA technique, the results were found to approximately match the electrophoresis data. The reason was found in Equations [10] through [16]. Equation [10] calculated the zeta potential once the dynamic mobility was found using the measured ESA amplitude to solve Equation [8]. The term  $G(\alpha)$  was the inertial contribution to the dynamic mobility which was dependent upon both the frequency of the acoustic wave and the particle size and was found by solving Equations [11] through [16]. Generally,  $G(\alpha)$  was an inverse function of the particle radius. If the radius was underestimated, the inertial contribution  $G(\alpha)$  was overestimated, resulting in an underestimation of the zeta potential. James et al. showed calculations where the reported particle size was half of the true particle size, resulting in a  $G(\alpha)$  1.75 times higher. This indicates that the zeta potential will be reported as 1.75 times smaller in magnitude than it

should be.

Part of the problem in finding the correct particle size to calculate the acoustophoretic ESA zeta potential was that each method used will give different average particle sizes. For example for  $\text{Si}_3\text{N}_4$ , the manufacturer reports an average particle radius of  $0.25\text{ }\mu\text{m}$ , Crimp reports a BET equivalent spherical radius of  $0.06\text{ }\mu\text{m}$  (76), James et al. (79) report a particle analyzer mass average radius of  $0.275\text{ }\mu\text{m}$  and a light scattering radius of  $0.55\text{ }\mu\text{m}$ . James et al. found the best results using photon correlation spectroscopy (PCS). A major factor responsible for the difference in the particle radius and need for use of an effective radius, was agglomeration of particles into larger sized particles during ESA testing (71). As will be discussed later and can be seen in Figures 30 through 32, SiC agglomerates at low pH values. These were the pH values where the acoustophoretic ESA measurements were slightly lower than the electrophoresis values for LS-5 and UF-10 SiC. This agglomeration and the need for an effective particle radius would explain this behavior. Electrophoresis does not "see" the need for an effective particle radius for two reasons. The electrophoresis measurements are carried out at much lower particle volume percents of solids to liquids in the suspension and the electrophoresis values do not require particle size in the calculation of the zeta potential.

Figure 21 is the first of the graphs of stability vs.

pH from data produced by the predictive program for the SiC/Si<sub>3</sub>N<sub>4</sub> system. Figure 21(a) is the predictive data found using the constant potential repulsion equation along with electrophoresis data for the LS-5 SiC/Si<sub>3</sub>N<sub>4</sub> system with equal relative component volume fraction in an electrolyte concentration of 10<sup>-3</sup> M at room temperature (25°C). Figure 21(b) and (c) are for the same system conditions, but are for UF-10 SiC/Si<sub>3</sub>N<sub>4</sub> and UF-15 SiC/Si<sub>3</sub>N<sub>4</sub>, respectively. For all of the stability vs. pH plots, the maximum value plotted for the stability ratio is 10<sup>31</sup> due to limitations of the available graphics software. Four different curves were plotted on each graph. The curves represent the different types of interactions which are possible for the system. SiC/SiC, SiC/Si<sub>3</sub>N<sub>4</sub>, and Si<sub>3</sub>N<sub>4</sub>/Si<sub>3</sub>N<sub>4</sub> represent the interactions of SiC particles with themselves ( $W_{11}$ ), SiC particles with Si<sub>3</sub>N<sub>4</sub> particles ( $W_{12}$ ), and Si<sub>3</sub>N<sub>4</sub> particles with themselves ( $W_{22}$ ), respectively. The curve for the total interaction represents the total overall particle interaction ( $W_t$ ).

The SiC/SiC curves in Figures 21(a), (b), and (c) are horizontal lines at a value of  $W$  equal to 10<sup>31</sup>. This means that the SiC particles are predicted to be stable with respect to themselves at all pH values from a pH of 4 to 11. The Si<sub>3</sub>N<sub>4</sub>/Si<sub>3</sub>N<sub>4</sub> curves for these plots begins at stability values of 10<sup>31</sup> at pH 4 to 5, decreasing to lower values for pH 5.5 to 7, and increases to the maximum for pH 7.5 and above. The prediction is then that Si<sub>3</sub>N<sub>4</sub> is stable at low

pH values and high pH values, but is unstable for intermediate pH values with respect to itself.

The SiC/Si<sub>3</sub>N<sub>4</sub> curves differ in the three plots of Figure 21. In Figure 21(a) the curve is constant at stability values of about  $10^3$  from pH 4 to 8, decreases to a value of less than 1 at pH 8.5, and then increases to values above  $10^{19}$ . This means that the method predicts SiC and Si<sub>3</sub>N<sub>4</sub> particles will be attracted to one another to form agglomerates for pH less than 9 and so instability is predicted in this range. For pH 9 to 10 it is unclear if the stability ratio is large enough to predict stability or partial stability (i.e. where the particles will be stable but only for smaller time periods). The actual stability ratio values which delineate stability from instability or partial stability will have to be determined by application to a real system. For Figures 21(b) and (c), the SiC/Si<sub>3</sub>N<sub>4</sub> curves are very similar with instability predicted for pH less than 7, partial stability for pH 7, and stability for pH values greater than pH 7. For the three curves plotted in Figure 21 the total stability is predicted to follow closely each of the SiC/Si<sub>3</sub>N<sub>4</sub> interaction curves with only small shifts in stability values. This would indicate total system instability below pH 9, partial stability from 9 to 10 and stability above pH 10 for the LS-5 SiC/Si<sub>3</sub>N<sub>4</sub> system and instability below pH 7 with stability above pH 7 for both the UF-10 and UF-15/Si<sub>3</sub>N<sub>4</sub> systems. Figure 22 contains



plots of computer predicted stability for the same three systems except that the ESA zeta potential data was used instead of the electrophoretic data. All three of the plots predict complete instability of the  $\text{SiC/Si}_3\text{N}_4$ ,  $\text{Si}_3\text{N}_4/\text{Si}_3\text{N}_4$ , and total interactions at all pH values. This is due to the smaller magnitudes reported for the  $\text{Si}_3\text{N}_4$  ESA zeta potential data compared to the electrophoresis. Figures 22 (a) and (b) predict instability for the  $\text{SiC/SiC}$  interactions at low pH values and stability at higher pH values, while Figure 22 (c) predicts instability at all pH values (again this is due to the lower ESA zeta potential values).

Figure 23 contains plots of computer predicted stability for the same systems as Figure 21, but uses the constant charge repulsion equation instead of the constant potential equation. Figure 23 (a) predicts  $\text{SiC/SiC}$  interaction stability for all pH values and  $\text{Si}_3\text{N}_4/\text{Si}_3\text{N}_4$  stability for pH below 6 and above 6.5. The  $\text{SiC/Si}_3\text{N}_4$  and total interactions are predicted to be unstable below pH 7. Figures 23 (b) and (c) are almost identical predicting  $\text{SiC/SiC}$  interaction stability for all pH values and  $\text{Si}_3\text{N}_4/\text{Si}_3\text{N}_4$  stability for pH below 6 and above 6.5. The  $\text{SiC/Si}_3\text{N}_4$  and total interactions are predicted to be stable below pH 6.5.

Figure 24 (a) through (c) are plots of the potential energy of interaction versus particle separation distance for each of the 15 pH values for which data was calculated

for the LS-5 SiC/Si<sub>3</sub>N<sub>4</sub> system with equal relative component volume fraction in an electrolyte of concentration  $10^{-3}$  at room temperature (corresponds to stability data in Figure 21 (a)). In the figures the higher the maximum repulsive peak, the larger the barrier to agglomeration, the higher the corresponding stability ratio will be in Figure 21 (a). An example of this can be seen for the Si<sub>3</sub>N<sub>4</sub>/Si<sub>3</sub>N<sub>4</sub> interaction. Figure 24 (f) shows the potential energy at pH 6.5 for this interaction. This curve is the middle curve of the three and is shown as barely reaching a positive potential value and corresponds to a low stability value in Figure 21 (a). Figure 24 (j) shows the potential energy at pH 8.5 for this interaction. This curve is the middle curve of the three and is shown as reaching a positive potential peak of approximately 100 kT or so and corresponds to a stability value in Figure 21 (a) which indicates stability.

These figures illustrate an advantage of the stability prediction theory used in this investigation over methods which simply look at the interparticle potential curves. Instead of using one figure (e.g. Figure 21 (a)) to predict the system stability over a pH range, as in this theory, it would be necessary to look at a plot of potential verses separation for each pH in the pH range (e.g. the 15 plots in Figure 24) in order to use the interaction energy versus separation to predict stability.

The plots in Figure 25 are for data from the predictive

program using the constant potential repulsion equation and electrophoresis data for the three main two-component systems with equal relative volume fraction as in Figure 21, but with an electrolyte concentration of  $10^{-2}$  M. The curves predict instability for SiC/SiC interactions at pH below 7.5 and below 8.5 or 9 for Si<sub>3</sub>N<sub>4</sub>/Si<sub>3</sub>N<sub>4</sub> interactions. For the SiC/Si<sub>3</sub>N<sub>4</sub> and total interactions instability is predicted for all pH values for the LS-5 SiC/Si<sub>3</sub>N<sub>4</sub> system and for pH below 10 and 9 for the UF-10 and UF-15 SiC/Si<sub>3</sub>N<sub>4</sub> systems, respectively.

The plots in Figure 26 are the same as in Figure 25, but with an electrolyte concentration of  $10^{-5}$  M. For each of the three systems shown, stability is predicted for the SiC/SiC interaction for pH above 5 and for the Si<sub>3</sub>N<sub>4</sub> interaction stability is predicted for pH below 5.5 or above 7.5. The SiC/Si<sub>3</sub>N<sub>4</sub> and total interactions are different for each of the three systems. For the LS-5 SiC/Si<sub>3</sub>N<sub>4</sub> system, the method predicts instability at all pHs. For the UF-10 SiC/Si<sub>3</sub>N<sub>4</sub> system, instability is predicted for all pHs below 10.5, while for the UF-15 SiC/Si<sub>3</sub>N<sub>4</sub> system, instability is predicted for all pHs below 8. The method predicts changes in stability behavior with changes in the electrolyte concentration. This is expected since variations in electrolyte concentration will change the size of the repulsive double layer as was discussed earlier. An increase in electrolyte concentration reduces the double

layer size since the ion concentration reaches the bulk value in a shorter distance from the particle surface. Increasing the electrolyte concentration from  $10^{-3}$  M to  $10^{-2}$  M reduced the predicted stability behavior which is seen by comparing the plots of Figure 21 and Figure 25.

The effect of variations in the relative volume fraction of components on the total overall stability is shown in Figure 27. The conditions chosen to show the variation were for systems in which there was the largest difference between the stability behavior for SiC and  $\text{Si}_3\text{N}_4$ . Therefore, the largest changes in the total stability should be seen for these systems. All three systems show that for these conditions the method does not predict much change in the total overall stability of each system for different relative volume fractions.

The effect of temperature on the total overall stability is shown in Figure 28. Figure 28 (a) shows the total overall stability for room temperature and room temperature  $\pm 5^\circ\text{C}$ . This figure shows that stability is predicted to barely change for the temperature range of normal laboratory temperature fluctuations. Figure 28 (b) shows the total overall stability for much larger temperature changes. Even the large variations in temperature show little change in predicted stability except at pH 7 where the stability might change from complete stability to partial stability for a temperature increase of

50°C. A plot of the log of the stability ratio versus pH shows all curves as being almost identical except for the 0°C curve which is shifted to the left of the other curves by about a half a pH unit. This indicates that processing in an ice bath or similar low temperature environment, would allow for stability at a half a pH lower than if the processing was done at room temperature. This could be an important processing aid for systems in which components are soluble at high pH or have surface groups which are unstable at high pH as is the case for  $\text{Si}_3\text{N}_4$  (70).

Figure 29 shows the effect on the predicted stability from variations in the input Hamaker constants of plus or minus 10% for SiC and/or  $\text{Si}_3\text{N}_4$ . This was done because the values for the Hamaker constants vary depending on the method (i.e. microscopic method Equation [2] or macroscopic method of Equation [3]) used to calculate them. Figure 29 little change in the overall stability predicted even for variations as large as a 10% increase in one and a 10% decrease in the other input Hamaker constant. This means that the predictions are not strongly sensitive to the accuracy of the Hamaker constants input.

To verify the stability predictions, sedimentation experiments were performed. With the small size and similar appearance of all the powders upon dispersion, it was not possible to identify any heterocoagulation between SiC and  $\text{Si}_3\text{N}_4$ . For future investigations the heterocoagulation

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predictions could be examined using SEM or TEM studies. In the current investigation, single component sedimentation experiments were performed along with the two component systems tested so that the each of the SiC/SiC and  $\text{Si}_3\text{N}_4/\text{Si}_3\text{N}_4$  interactions could be known experimentally along with the total overall stability for the two component systems. The sedimentation of each of these single and two component systems at varying time intervals can be seen in Figures 30 through 37.

The reason sedimentation experiments indicate the agglomeration state and stability for a system results from the fact that as agglomerates form, the sizes of these agglomerates are larger than the single particle. The more agglomeration that takes place larger the agglomerates become. 'The larger a particle or agglomerate becomes the more gravity affects it and the quicker it falls.' Factors which indicate the degree of agglomeration are sedimentation rate, sedimentation height and whether the liquid above the sedimentation level is clear or cloudy (80). If the sedimentation height is small, the system is strongly coagulated. Larger sedimentation heights with clear liquid above the sedimentation show a partially stable suspension and suspensions which remain cloudy above any sedimentation height show stable suspensions (70).

Figure 30 shows the sedimentation behavior for LS-5 SiC by itself. At a time of 21 hours, the suspension is

unstable below pH 5.5, partially stable at pH 6.0, and stable for all higher pH values. At 73 hours, the same stability is shown. Figure 31 shows the stability of UF-10 SiC. At 21 hours the UF-10 is unstable for pH values less than 6 and stable for values of 6 or greater. After 119 hours, the UF-10 is unstable for pH less than 6, is partially stable for pH 6 and 6.5, and stable for higher pHs. Figure 32 shows the stability for UF-15 SiC. At 20 hours, the UF-15 is unstable for pHs less than 6, partially stable for pH 6, and stable for values of greater than 6. After 118 hours, the UF-15 is unstable for pH 6 or less, is partially stable for pH 6.5, and stable for higher pH values. Figure 33 shows the stability for SN-E10  $\text{Si}_3\text{N}_4$ . At 24 hours, the SN-E10 is stable for pH less than 5, unstable for pH 5 to 8, partially stable for pH 8.5, and stable for values greater than 8.5. At 48 hours, the SN-E10 is stable for pH less than 5, unstable for a pH 5 to 8.5, partially stable for pH 9 and 9.5, and stable for values greater than 9.5. At 146 hours, the SN-E10 is stable for pH less than 5, unstable for a pH 5 to 9, partially stable for pH 9.5 and 10, and stable for values greater than 10.0.

For the two component systems of LS-5 SiC/ $\text{Si}_3\text{N}_4$  in equal volume fractions Figure 34 shows the total stability. At 72 hours, the system is unstable for pH less than 7.5, partially stable for pH 7.5 and 8, and stable for pH greater than 8. For the UF-10 SiC/ $\text{Si}_3\text{N}_4$  in equal volume fractions,



Figure 35 shows the total stability. At 29 hours, the system is unstable for pH less than 7, partially stable for pH 7, and stable for pH greater than 7. At 70 hours, the system is unstable for pH less than 7, partially stable for pH 7 to 8.5, and stable for pH greater than 8.5. For the UF-15 SiC/Si<sub>3</sub>N<sub>4</sub> in equal volume fractions, Figure 36 shows the total stability. At 23 hours, the system is unstable for pH less than 7, partially stable for pH 7 to 8, and stable for pH greater than 8. At 64 hours, the system is unstable for pH less than 7, partially stable for pH 7 to 8.5, and stable for pH greater than 8.5. For the 0.75 v% UF-10 SiC/0.25 v% Si<sub>3</sub>N<sub>4</sub>, Figure 37 shows the total stability. At 22 hours, the system is unstable for pH less than 6, partially stable for pH 6 and 6.5, and stable for pH greater than 7. At 63 hours, the system is unstable for pH less than 6.5, partially stable for pH 6.5 to 7.5, and stable for pH greater than 7.5.

The prediction for LS-5 and UF-10 SiC using the acoustophoretic ESA data and the constant potential repulsion equation predicts the change from partial stability to stability to occur for pH 5 to 5.5 and 5.5 to 6, respectively. The single component sedimentation experiments for these powders at 21 hours show this transition to be at 5.5 to 6 for both of the powder types. The prediction for the Si<sub>3</sub>N<sub>4</sub> using the acoustophoretic ESA data and the constant potential equation predicts stability

for pH less than 5.5 and greater than 7. The single component sedimentation experiment for  $\text{Si}_3\text{N}_4$  shows stability of less than 5 and greater than 8.5. This prediction is close for the lower pH range, but while the program did predict the second stability range, it was not very close as to where this range began.

For the total overall stability of the LS-5  $\text{SiC}/\text{Si}_3\text{N}_4$  system with the constant potential repulsion equation and zeta potential data used for prediction, a stability prediction determines the suspension to be unstable below pH 9 and partially stable at 9 to 10 and stable for pH above 10. The sedimentation results after 72 hours for this system indicate a stable suspension below 8.5 and stable at 8.5 and above. For the total overall stability of the UF-10  $\text{SiC}/\text{Si}_3\text{N}_4$  system with the constant potential repulsion equation and zeta potential data used for prediction, a stability prediction determines the suspension to be unstable below pH 7 and partially stable at 7 and stable for pH above 7. The sedimentation results after 29 hours for this system indicate a stable suspension below 7 and stable at 7.5 and above.

Some of the results can be seen as quite encouraging, but with the acoustophoretic ESA data not being correct for  $\text{Si}_3\text{N}_4$  or UF-15  $\text{SiC}$ , much of the accuracy of the predictions is decreased. This points out how necessary accurate zeta potential measurements are. For future work with the

program, acoustophoretic ESA zeta potential data need to be taken using an effective particle radius.

The FeAl zeta potential curves are shown in Figure 38. The zeta potential data curves are relatively flat over the pH range. Shaw (15) shows a zeta potential curve for latex particles which is also fairly flat over the pH range. The flatness of the curve indicates one of two things. Either hydrogen and hydroxyl ions are not the potential determining ions for FeAl or there are competing charge generation mechanisms. The charge generation mechanism is unknown, but could be a variety of different mechanisms such as various corrosion reactions or hydroxylation reactions. This points to another advantage of this prediction method. From a purely processing standpoint, a prediction of the stability for this system can be made with accurate zeta potential data without knowing the charge mechanisms, although from a scientific standpoint it would be desirable to know the charge mechanisms.

The ESA zeta potential data for the alumina fibers are shown in Figure 39. The magnitude of the values are similar to values reported by James et al. (79) for alumina powder and an i.e.p. that is similar to that shown by James et al. (79). However, the shapes of the curves differ. This is probably due to the authors taking approximately ten data points and then drawing a best fit curve through them. The data scatter of the ESA zeta potential data is probably due

to the large distribution of fiber lengths as can be seen in the SEM photograph in Figure 61. To improve the acoustophoretic ESA data, a better method for shortening the fibers is needed.

The stability prediction curves in Figure 40 show complete instability of FeAl. Observation of the FeAl suspensions made in this investigation show this not to be true. This poor prediction is due to the use of an inaccurate average particle radius in calculating the ESA zeta potential. An improved method for finding an effective particle radius is needed. If it is assumed that correct particle size would shift the stability up, it would follow that the FeAl would be stable for all pH values, although there might be instability above a pH of 9 where the acoustophoretic ESA curve dips slightly.

The stability for alumina is predicted to be stable for pH under 6.5 to 7 or above 10.5 or 11. The FeAl/alumina interaction is shown to be stable for the whole pH range, but if the FeAl stability curve were shifted up, the FeAl/alumina curve would be also. The curve is at a maximum at pH 7 and drops off for higher and lower values of pH. The ideal pH for processing this composite system would be where the FeAl/FeAl and alumina/alumina interactions would be stable, but the FeAl/alumina interaction would be unstable so that the matrix and fiber are attracted to each other. This would occur at pH 5 or 6. If after initial

mixing of the composite at pH 5 to allow for a uniform distribution of FeAl and alumina fibers the pH was increased to 8, in order to induce total coagulation of the system, so differential settling of the composite components could be reduced or eliminated.

## CONCLUSIONS

Due to the importance of using both stable and agglomerated suspensions in ceramic processing along with the increasing use of ceramic processing for multicomponent and composite systems, a method for predicting the stability of multicomponent colloidal suspensions at different pH values was developed from a method originated by Hogg, Healy, and Fuerstenau (53). A computer program was written to perform the calculations required in using this method. Material and system data such as particle radii, relative volume fraction of components, monatomic electrolyte concentration, Hamaker constants, and zeta potential versus pH measurements were input into the computer program. The stability ratio versus pH data was output by the program into ASCII files for plotting using graphics software.

The SiC/Si<sub>3</sub>N<sub>4</sub> system was investigated in detail using both electrophoresis and electroacoustic zeta potential data. The method was used to make general predictions to be compared with actual stability experiments, and to show the effect of relative volume fraction of components, temperature and the accuracy of the Hamaker values on the predicted stability. The regions of stability predicted by the method were found to be within a half a pH in some instances. However, the predictions were found to be strongly dependent upon the accuracy of the electroacoustic

zeta potential measurement data. Problems with these data were discovered and found to be the result of the particle size data which were used to calculate the electroacoustic zeta potential from the measured dynamic mobilities.

Contrary to what was intuitively expected, the predicted total overall stability was found to be only slightly changed for different relative volume fractions of components. This was also shown for actual stability in the sedimentation results for a SiC/Si<sub>3</sub>N<sub>4</sub> system with 0.75 relative volume fraction of SiC. The prediction method was shown not to be dependent on the precision of the Hamaker constant values used for stability calculations nor upon the system temperature.

The stability prediction method was also applied to a FeAl/Al<sub>2</sub>O<sub>3</sub> fiber composite system. The method was used to determine the pH where the processing conditions would be ideal. The ideal composite processing would have the fiber coated by the matrix while having the fiber and the matrix stable enough to form a uniform distribution of fiber within the matrix. This would occur at the pH where the fiber and matrix were attracted to each other and agglomerated together while the fiber and the matrix were individually stable with respect to themselves. The method predicted that the ideal pH where this would occur would be 5 and that a subsequent increase to pH 8 would then prevent differential settling of the fiber and powder.

In general, future investigations should include: 1) electroacoustic ESA data collected using effective particle radius versus pH data, 2) should use the log of the stability ratio to better indicate stability, 3) should have the heterocoagulation predictions investigated through SEM or TEM studies, and 4) should try to better determine at which values of the stability ratio suspensions become stable. For the FeAl/Al<sub>2</sub>O<sub>3</sub> fiber system, future investigations should include 1) the general recommendations listed above, 2) a better method for shortening the fibers for the electroacoustic ESA measurements, and 3) determination of the surface chemistry of FeAl.



## APPEDIX A

Derivation relating  $n$  to particle radii and  
relative component volume fraction.

In the HHF method  $n$  is the overall number of particles of component 1 in the system. In other words  $n$  is the ratio of the total number of type 1 particles to the total number of all particles in the system:

$$n = \frac{TN_1}{TN_1 + TN_2} \quad [A1]$$

This was deemed as quite impracticable from an experimental viewpoint. In real experimental systems variables which are known include the particle radii ( $r_1$  and  $r_2$ ) and the relative volume fraction of component 1 (RVFC<sub>1</sub>):

$$RVFC_1 = \frac{TV_1}{TV_1 + TV_2} \quad [A2]$$

Since the method being used assumes spherically shaped particles and the particle radii are known, the volume of an individual particle  $i$  is:

$$V_i = \frac{4}{3} \pi r_i^3 \quad [A3]$$

The total volume of all particles of type  $i$  is then:

$$TV_i = TN_i V_i = \frac{4}{3} \pi TN_i r_i^3 \quad [A4]$$

Equation [A2] for component 1 then becomes:

$$RVFC_1 = \frac{TN_1 \frac{4}{3} \pi r_1^3}{TN_1 \frac{4}{3} \pi r_1^3 + TN_2 \frac{4}{3} \pi r_2^3} \quad [A5]$$

This simplifies to:

$$RVFC_1 = TN_1 \frac{r_1^3}{TN_1 r_1^3 + TN_2 r_2^3} . \quad [A6]$$

Now if Equation [A1] is solved for  $TN_2$ , the result is:

$$TN_2 = \frac{TN_1}{n} - TN_1 = TN_1 \left( \frac{1}{n} - 1 \right) . \quad [A7]$$

Substituting Equation [A7] into [A6] results in:

$$RVFC_1 = \frac{TN_1 r_1^3}{TN_1 r_1^3 + [TN_1 \left( \frac{1}{n} - 1 \right)] r_2^3} \quad [A8]$$

which can be simplified to:

$$RVFC_1 = \frac{TN_1 r_1^3}{TN_1 [r_1^3 + \left( \frac{1}{n} - 1 \right) r_2^3]} . \quad [A9]$$

The equation then becomes:

$$RVFC_1 = \frac{r_1^3}{r_1^3 + \left( \frac{1}{n} - 1 \right) r_2^3} . \quad [A10]$$

Solving this equation for  $n$  through simple algebra:

$$n = \frac{1}{\frac{r_1^3 (1 - RVFC_1)}{r_2^3 RVFC_1} + 1} . \quad [A11]$$

## APPENDIX B

List files of the computer program  
STABILITY PREDICTION and its subroutines.

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      PROGRAM STABILITY PREDICTION
2
3      CCCCC REV. 06-22-92
4
5      IMPLICIT NONE
6      CHARACTER CODE*6
7      CHARACTER ZPQ*1,FLDIR*7
8      INTEGER L,NZP1,NZP2
9      INTEGER*2 CDATE,STIME,FTIME
10     DIMENSION CDATE(3),STIME(4),FTIME(4)
11     REAL APR,PHCZI,N,AHP,PHSS,SPH,FPH,PH,AHM,TAH
12     REAL ZPPH1,ZPDP1,ZPPH2,ZPDP2,CONCL,TEMP,V
13     REAL*8 WOO,WOT,WTT,WT
14     DIMENSION PHCZI(2), AHP(2), WT(200), PH(200),
15     DIMENSION APR(2)
16     DIMENSION ZPPH1(200), ZPDP1(200),
17     DIMENSION ZPPH2(200), ZPDP2(200)
18     DIMENSION WOO(200),WOT(200),WTT(200),TAH(2:4)
19
20     CCCCC N= OVERALL PROPORTION OF PARTICLES OF COMPONENT
21     CCCCC ONE IN SYSTEM
22     CCCCC V= VOLUME PERCENT OF COMPONENT ONE IN SYSTEM
23     CCCCC APR= ATOMIC PARTICLE RADIUS (ARRAY VARIABLE)
24     CCCCC PHCZI= PH OF ZERO-POINT-OF-CHARGE (ARRAY
25     CCCCC VARIABLE)
26     CCCCC AHP= HAMAKER CONSTANT OF PARTICLE (ARRAY
27     CCCCC VARIABLE) (J)
28     CCCCC AHM= HAMAKER CONSTANT OF MEDIUM(J)
29     CCCCC TAH= TOTAL HAMAKER CONSTANT(J)
30     CCCCC TAH(2)=A131
31     CCCCC TAH(3)=A132
32     CCCCC TAH(4)=A232
33     CCCCC TEMP=TEMPERATURE OF SYSTEM (deg. C)
34     CCCCC SPH= STARTING PH
35     CCCCC FPH FINISHING PH
36     CCCCC PHSS= PH STEP SIZE
37     CCCCC MSS= MINIMUM STEP SIZE
38     CCCCC FLNAME= NAME OF FILE DATA WILL BE STORED IN
39     CCCCC FLDIR=NAME OF DIRECTORY DATA FILE IS STORED IN
40     CCCCC CICS= CORRECT INPUT CHARACTER STRING
41     CCCCC CI= CORRECT INPUT ANSWER VARIABLE
42     CCCCC RICS= READ INPUT CHARACTER STRING
43     CCCCC WOO,WOT,WTT=INVERSE OF THE PROBABILITY THAT A
44     CCCCC GIVEN PARTICLE
45     CCCCC COLLISION LEADS TO ADHESION
46     CCCCC WT=OVERALL STABILITY RATIO
47     CCCCC PH=PH COORESPONDING TO AN OVERALL STABILITY
48     CCCCC RATIO VALUE

```

Line# Source Line

```

42 CCCCC ZPQ=ZETA POTENTIAL QUESTION VARIABLE
43 CCCCC ('Z'=ZETA POTENTIAL DATA USED FOR
44 CCCCC CALCULATIONS)
45 CCCCC ('P'=POINT-OF-ZERO-CHARGE DATA USED FOR
46 CCCCC CALCULATIONS)
47 CCCCC NZP=NUMBER OF ZETA POTENTIAL DATA POINTS
48 CCCCC ZPDP=ZETA POTENTIAL DATA POINT (ARRAY VARIABLE)
49 CCCCC ZPPH=COORESPONDING ZETA POTENTIAL PH (ARRAY
50 CCCCC VARIABLE)
51 CCCCC CONCL=CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM
52 CCCCC (MOLE/L)
53 CCCCC L=INTERGER USED AS A COUNTER FOR DO LOOPS
54 CCCCC CDATE=CURRENT DATE
55 CCCCC STIME=STARTING TIME OF RUN
56 CCCCC FTIME=FINISHING TIME OF RUN
57
58 10 OPEN(14,FILE='FLEINPUT.DAT',STATUS='OLD')
59
60 CCC-----GETTING SYSTEM DATA FROM
61 C-----FILE-----
62 20 CALL FDATA INPUT (V, APR, PHCZI, AHP, AHM, SPH,
63 & FPH, PHSS, ZPQ, NZP1, NZP2,ZPPH1, ZPDP1, ZPPH2,
64 ZPDP2, CONCL, FLDIR, TEMP)
65
66 CC-----GETTING CURRENT DATE AND
67 C-----PROGRAM RUN STARTING TIME---
68 30 CALL GETDAT (CDATE(1),CDATE(2),CDATE(3))
69 40 CALL GETTIM (STIME(1), STIME(2), STIME(3),
70 & STIME(4))
71
72 CCC-----CALCULATING TOTAL HAMAKER
73 C-----CONSTANT-----
74 50 TAH(2)=(SQRT(AHP(1)) - SQRT(AHM)) *
75 (SQRT(AHP(1)) - SQRT(AHM))
76 60 TAH(3)=(SQRT(AHP(1)) - SQRT(AHM)) *
77 (SQRT(AHP(2)) - SQRT(AHM))
78 70 TAH(4)=(SQRT(AHP(2)) - SQRT(AHM)) *
79 (SQRT(AHP(2)) - SQRT(AHM))
80
81 CCC-----INITIALIZING WT & PH VALUES TO
82 C-----ZERO-----
83 80 DO 140 L=1,200,1
84 90 WT(L) = 0.0
85 100 PH(L) = 0.0
86 110 WOO(L)=0.0
87 120 WOT(L)=0.0
88 130 WTT(L)=0.0
89 140 CONTINUE

```

## Line# Source Line

```

83 CCC-----CALCULATING WT & PH VALUES FOR
   C-----SPECIFIED -----
84 C-----PH RANGE & STEP SIZE-----
85 150 IF (ZPQ.EQ.'P') THEN
86 160 CALL CALCPZC(V, APR, PHCZI, TAH, SPH, FPH,
87      & PHSS, WT, PH, CONCL, WOO, WOT, WTT, FLDIR,
      & TEMP)
88 170 ELSE
89 180 CALL CALCZP(V, APR, TAH, ZPDP1, ZPPH1, ZPPH2,
90      & ZPDP2, SPH, FPH, PHSS, WT, PH, CONCL, NZP1,
      & NZP2, WOO, WOT, WTT, FLDIR, TEMP)
91 190 END IF
92
93 CC-----GETTING PROGRAM RUN FINISHING
   C-----TIME-----
94 200 CALL GETTIM (FTIME(1), FTIME(2), FTIME(3),
      & FTIME(4))
95
96 CCC-----STORING INPUT & CALCULATED
   C-----DATA-----
97 210 CALL DATA STORAGE(N, APR, ZPQ, AHM, AHP, PHCZI,
98      & NZP1, NZP2, ZPPH1, ZPDP1, ZPPH2, ZPDP2, WT, PH,
99      & CONCL, WOO, WOT, WTT, CDATE, STIME, FTIME, TEMP)
100 220 CLOSE(14)
101
102 CCC-----FORMATTING READ STATEMENTS-----
103 800 FORMAT (A1)
104
105 998 STOP
106 999 END

```

## main Local Symbols

Name	Class	Type	Size	Offset
PH. . . . .	local	REAL*4	800	0000
STIME . . . . .	local	INTEGER*2	8	0002
L . . . . .	local	INTEGER*4	4	000a
N . . . . .	local	REAL*4	4	000e
V . . . . .	local	REAL*4	4	0012
AHM . . . . .	local	REAL*4	4	0016
AHP . . . . .	local	REAL*4	8	001a
CODE. . . . .	local	CHAR*6	6	0022
TAH . . . . .	local	REAL*4	12	0028
FPH . . . . .	local	REAL*4	4	0034
CDATE . . . . .	local	INTEGER*2	6	0038
APR . . . . .	local	REAL*4	8	003e
NZP1. . . . .	local	INTEGER*4	4	0046

## main Local Symbols

Name	Class	Type	Size	Offset
NZP2. . . . .	local	INTEGER*4	4	004a
SPH . . . . .	local	REAL*4	4	004e
CONCL . . . . .	local	REAL*4	4	0052
FLDIR . . . . .	local	CHAR*7	7	0056
FTIME . . . . .	local	INTEGER*2	8	005e
TEMP. . . . .	local	REAL*4	4	0066
ZPQ . . . . .	local	CHAR*1	1	006a
PHSS. . . . .	local	REAL*4	4	006c
PHCZI . . . . .	local	REAL*4	8	0070
WT. . . . .	local	REAL*8	1600	0320
ZPDP1 . . . . .	local	REAL*4	800	0960
ZPDP2 . . . . .	local	REAL*4	800	0c80
ZPPH1 . . . . .	local	REAL*4	800	0fa0
ZPPH2 . . . . .	local	REAL*4	800	12c0
WOO . . . . .	local	REAL*8	1600	15e0
WOT . . . . .	local	REAL*8	1600	1c20
WTT . . . . .	local	REAL*8	1600	2260

## Global Symbols

Name	Class	Type	Size	Offset
CALCPZC . . . . .	extern	***	***	***
CALCZP. . . . .	extern	***	***	***
DATASTORAGE . . . . .	extern	***	***	***
FDATAINPUT. . . . .	extern	***	***	***
GETDAT. . . . .	extern	***	***	***
GETTIM. . . . .	extern	***	***	***
main. . . . .	FSUBRT	***	***	0000

Code size = 044b (1099)

Data size = 002b (43)

Bss size = 0078 (120)

No errors detected



## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE FDATA INPUT(N, APR, PHCZI, AHP, AHM,
2 & SPH, FPH, PHSS, ZPQ, NZP1, NZP2, ZPPH1, ZPDP1, ZPPH2,
3 & ZPDP2, CONCL, FLDIR, TEMP)
4      CCCCC REV. 05-03-92
5      CCC-----SUBROUTINE TO READ IN SYSTEM
6      CC-----DATA FROM A DATA FILE-----
7
8      IMPLICIT NONE
9      CHARACTER ZPQ*1,FLDIR*7
10     INTEGER I,NZP1,NZP2
11     REAL N,APR,PHCZI,AHP,AHM,SPH,FPH,PHSS,TEMP
12     REAL ZPDP1,ZPPH1,ZPDP2,ZPPH2,CONCL,SPHL,FPHL
13     DIMENSION PHCZI(2),AHP(2),APR(2), ZPDP1(200)
14     DIMENSION , ZPPH1(200), ZPPH2(200), ZPDP2(200)
15
16     CCCCC MSS=MINIMUM STEP SIZE
17
18     10      READ (14,800)TEMP
19     20      READ (14,805)N
20     30      READ(14,810)CONCL
21     40      READ(14,815)APR(1)
22     50      READ(14,815)APR(2)
23     60      READ(14,820)ZPQ
24     70      IF (ZPQ.EQ.'P') THEN
25     80          READ(14,825)PHCZI(1)
26     90          READ(14,825)PHCZI(2)
27     100         READ(14,830)SPH
28     110         READ(14,830)FPH
29     120         READ(14,835)PHSS
30     130     ELSE IF (ZPQ.EQ.'Z') THEN
31     140         READ(14,840)NZP1
32     150         DO 180 I=1,NZP1,1
33     160             READ(14,830)ZPPH1(I)
34     170             READ(14,845)ZPDP1(I)
35     180         CONTINUE
36     190         READ(14,840)NZP2
37     200         DO 230 I=1,NZP2,1
38     210             READ(14,830)ZPPH2(I)
39     220             READ(14,845)ZPDP2(I)
40     230         CONTINUE
41
42     C-----DETERMINING PH RANGE FOR
43     C-----Z.P. DATA-----
43     240         IF (ZPPH1(1).LE.ZPPH2(1)) THEN
44     250             SPHL=ZPPH2(1)
45     260         ELSE
46     270             SPHL=ZPPH1(1)

```

## Line# Source Line

```

47 280      END IF
48 290      IF (ZPPH1(NZP1).GE.ZPPH2(NZP2)) THEN
49 300          FPHL=ZPPH2(NZP2)
50 310      ELSE
51 320          FPHL=ZPPH1(NZP1)
52 330      END IF
53 340      READ(14,830)SPH
54 350      READ(14,830)FPH
55 360      READ(14,835)PHSS
56 370      END IF
57 380      READ(14,850)AHM
58 390      READ(14,850)AHP(1)
59 400      READ(14,850)AHP(2)
60 410      IF (ZPQ.NE.'P'.AND.SPH.LT.SPHL) THEN
61 420          SPH=SPHL
62 430      ELSE IF (ZPQ.NE.'P'.AND.FPH.GT.FPHL) THEN
63 440          FPH=FPHL
64 450      END IF
65 460      READ(14,855)FLDIR
66
67 CCC-----FORMATING READ STATEMENTS-----
68 800      FORMAT (F4.1)
69 805      FORMAT (F4.3)
70 810      FORMAT (F7.5)
71 815      FORMAT (F7.1)
72 820      FORMAT(A1)
73 825      FORMAT (F5.2)
74 830      FORMAT (F5.2)
75 835      FORMAT (F5.3)
76 840      FORMAT (I2)
77 845      FORMAT (F4.1)
78 850      FORMAT (E10.2)
79 855      FORMAT (A7)
80
81 998      RETURN
82 999      END

```

## FDATAINPUT Local Symbols

Name	Class	Type	Size	Offset
TEMP. . . . .	param			0006
FLDIR . . . . .	param			000a
CONCL . . . . .	param			000e
ZPDP2 . . . . .	param			0012
ZPPH2 . . . . .	param			0016
ZPDP1 . . . . .	param			001a
ZPPH1 . . . . .	param			001e

## FDATAINPUT Local Symbols

Name	Class	Type	Size	Offset
NZP2. . . . .	param			0022
NZP1. . . . .	param			0026
ZPQ . . . . .	param			002a
PHSS. . . . .	param			002e
FPH . . . . .	param			0032
SPH . . . . .	param			0036
AHM . . . . .	param			003a
AHP . . . . .	param			003e
PHCZI . . . . .	param			0042
APR . . . . .	param			0046
N . . . . .	param			004a
I . . . . .	local	INTEGER*4	4	0002
FPHL. . . . .	local	REAL*4	4	0006
SPHL. . . . .	local	REAL*4	4	000a

## Global Symbols

Name	Class	Type	Size	Offset
FDATAINPUT. . . . .	FSUBRT	***	***	0000

Code size = 04a1 (1185)

Data size = 00f7 (247)

Bss size = 000e (14)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE CALCPZC (V, APR, PHCZI, TAH, SPH,
2      & FPH, PHSS, WT, PH, CONCL, WOO, WOT, WTT, FLDIR,
3      & TEMP)
4      CCCCC REV. 06-22-92
5
6      CCC-----SUBPROGRAM TO CALCULATE
7      C-----OVERALL STABILITY RATIO USING
8      C-----POINT-OF-ZERO-CHARGE DATA-----
9
10     IMPLICIT NONE
11     CHARACTER FLDIR*7
12     INTEGER L,K,ONE,TWO,IPHC,IWIDTH
13     REAL*8 WT,WOO,WOT,WTT,OOWT,AZ,AZN,AZP
14     REAL N, APR, PHCZI, SPH, FPH, PHSS, PH, CONCL,
15     REAL HOA, HOR, APRC, TEMPK, V, OON
16     REAL CPH, PSI, RPHC, DELTPH, TAH, KRL, TEMP,
17     DIMENSION PH(200), WT(200), APR(2), PHCZI(2),
18     DIMENSION PSI(2), APRC(2)
19     DIMENSION WOO(200),WOT(200),WTT(200),TAH(2:4)
20
21     CCCCC OOWT=ONE OVER WT
22     CCCCC CPH=CURRENT PH
23     CCCCC RPHC=REAL VARIABLE PH COUNTER(FOR DO LOOP)
24     CCCCC IPHC=INTEGER VARIABLE PH COUNTER(FOR DO LOOP)
25     CCCCC PSI=SURFACE POTENTIAL CALCULATED FROM
26     CCCCC POINT-OF-ZERO-CHARGE (V)
27     CCCCC HOA=MINIMUM PARTICLE SEPERATION FOR ATTRACTIVE
28     CCCCC TERMS(M)
29     CCCCC HOR=MINIMUM SEPERATION FOR REPULSIVE TERMS(M)
30     CCCCC TEMPK=TEMPERATURE OF SYSTEM IN DEGREES KELVIN
31     CCCCC IWIDTH=WIDTH OF INTERAGER K (1 DIGIT,2 DIGITS,
32     CCCCC ETC.)
33     CCCCC DELTPH=CHANGE IN PH FROM FINISHING PH AND
34     CCCCC STARTING PH
35     CCCCC KRL=REAL VARIABLE REPULSION OF VARIABLE K
36     CCCCC K=INTEGER VARIABLE USED AS A COUNTER FOR DO LOOP
37     CCCCC WHICH CALCULATES OVERALL STABILITY AT EACH
38     CCCCC SPECIFIED PH
39     CCCCC L=INTEGER USED AS COUNTER FOR VARIOUS DO LOOPS
40     CCCCC ONE=INTEGER VARIABLE EQUAL TO ONE
41     CCCCC TWO=INTEGER VARIABLE EQUAL TO TWO
42     CCCCC AZ=VARIABLE REPRESENTING ALMOST ZERO (1.0E-309)
43     CCCCC AZP=POSITIVE VALUE OF AZ USED TO PREVENT AN
44     CCCCC INVERSE FROM GOING TO INFINITY WHICH CAUSES
45     CCCCC A MATH OVERFLOW ERROR RESULTING IN PROGRAM
46     CCCCC TERMINATION
47     CCCCC AZN=NEGATIVE VALUE OF AZ USED AS AZP IS

```

```

39 CCCCC APRC=ATOMIC PARTICLE RADIUS CUBED
40 CCCCC OON=ONE OVER N
41 CCCCC WKO=SUBROUTINE TO CALCULATE W VALUES IF K IS 1
   CCCCC      DIGIT IN LENGTH
42 CCCCC WKTW=SUBROUTINE CALCULATING W VALUES IF K IS 2
   CCCCC      DIGITS LONG
43 CCCCC WKTH=SUBROUTINE CALCULATING W VALUES IF K IS 3
   CCCCC      DIGITS IN LENGTH
44
45 10      TEMPK=TEMP+273.2
46 20      ONE=1
47 30      TWO=2
48 CCC-----CALCULATING VALUES FOR
   C-----AZP,AZN-----
49 40      AZ=1.0E-25
50 50      DO 70 K=1,11,1
51 60      AZ=AZ/1.0E25
52 70      CONTINUE
53 80      AZP=AZ/1.0E9
54 90      AZN=-1.0*AZP
55 CC-----CONVERTING PH COUNTER TO
   C-----INTEGER VARIABLE-----
56 100     DELTPH = FPH-SPH
57 110     IF (PHSS.EQ.0.0 .OR. DELTPH.EQ.0.0) THEN
58 120     IPHC=1
59 130     ELSE
60 140     RPHC = (FPH-SPH)/PHSS
61 150     IPHC = NINT(RPHC)
62 160     IPHC = IPHC + 1
63 170     END IF
64 CC-----CALCULATING N FROM V-----
65 180     APRC(1) = APR(1)**3
66 190     APRC(2) = APR(2)**3
67 200     OON = ((APRC(1))-(V*APRC(1)))/(V*APRC(2))
68 210     OON = OON + 1.00
69 220     N = 1.00/OON
70
71 CC-----INITIALIZING CURRENT PH-----
72 230     CPH = SPH
73 CC-----CALCULATING OVERALL STABILITY
74 C-----RATIO FOR SPECIFIED PH RANGE
   C-----& STEP SIZE-----
75 240     DO 530 K=1,IPHC,1
76 250     KRL=REAL(K)
77 260     IWIDTH=INT(LOG10(KRL)+1)
78
79 C-----CALCULATING POTENTIAL,PSI, FOR
80 C-----THE TWO DIFFERENT PARTICES
   C-----FOR CURRENT PH-----
81 270     DO 290 L=1,2,1
82 280     PSI(L)=(8.6205E-5)*(TEMPK)*(2.3026)*
              (PHCZI(L)-CPH)

```

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Line#  Source Line
83      290      CONTINUE
84
85      C-----SETTING MINIMUM PARTICLE
86      C-----SURFACE-----
87      300      HOR = 1.0E-10
88      310      HOA = 0.0
89
90      CC-----FINDING VARIOUS (INVERSE)
91      C-----PROBABILITIES OF PARTICLE
92      C-----COLLISION & ADHESION FOR
93      C-----COLLISION OF TWO PARTICLES
94      C-----OF TYPE #1-----
95      320      IF (IWIDTH.EQ.1) THEN
96      330      CALL WKO(K, WOO, WOT, WTT, APR, TAH, PSI,
97      & CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
98      340      ELSE IF (IWIDTH.EQ.2) THEN
99      350      CALL WKTW(K, WOO, WOT, WTT, APR, TAH, PSI,
100      & CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
101      360      ELSE IF (IWIDTH.EQ.3) THEN
102      370      CALL WKTH(K, WOO, WOT, WTT, APR, TAH, PSI,
103      & CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
104      380      END IF
105
106      CC-----FINDING THE OVERALL STABILITY
107      C-----RATIO AT CURRENT PH-----
108
109      C-----MAKING SURE INVERSES WILL NOT
110      C-----GO TO INFINITY SO A MATH
111      C-----OVERFLOW ERROR DOES NOT
112      C-----RESULT IN PROGRAM
113      C-----TERMINATION-----
114      390      IF (WOO(K) .LE. AZP .AND. WOO(K) .GE. AZN) THEN
115      400      WT(K) = WOO(K)
116      410      ELSE IF (WOT(K) .LE. AZP .AND. WOT(K) .GE. AZN)
117      & THEN
118      420      WT(K) = WOT(K)
119      430      ELSE IF (WTT(K) .LE. AZP .AND. WTT(K) .GE. AZN)
120      & THEN
121      440      WT(K) = WTT(K)
122      450      C-----ACTUALLY CALCULATING OVERALL
123      C-----STABILITY-----
124      460      ELSE
125      470      OOWT = (N*N/WOO(K))
126      480      OOWT = OOWT + ((1.0-N) * (1.0-N) / WTT(K))
127      490      OOWT = OOWT + (2.0*N*(1.0-N) / WOT(K))
128      500      WT(K) = 1.0/OOWT
129      510      END IF

```

## Line# Source Line

```

124 CC-----SETTING COORESPONDING PH VALUE
    C-----FOR WT (K) -----
125 510      PH (K) =CPH
126
127 CC-----SETTING NEW CURRENT PH
    C-----VALUE-----
128 520      CPH = CPH + PHSS
129
130 530      CONTINUE
131
132 CC-----RETURNING WT & PH VALUES TO
    C-----MAIN PROGRAM-----CCCCCCCC
133 998      RETURN
134 999      END

```

## CALCPZC Local Symbols

Name	Class	Type	Size	Offset
TEMP. . . . .	param			0006
FLDIR . . . . .	param			000a
WTT . . . . .	param			000e
WOT . . . . .	param			0012
WOO . . . . .	param			0016
CONCL . . . . .	param			001a
PH. . . . .	param			001e
WT. . . . .	param			0022
PHSS. . . . .	param			0026
FPH . . . . .	param			002a
SPH . . . . .	param			002e
TAH . . . . .	param			0032
PHCZI . . . . .	param			0036
APR . . . . .	param			003a
V . . . . .	param			003e
TEMPK . . . . .	local	REAL*4	4	0000
DELTPH. . . . .	local	REAL*4	4	0004
OOWT. . . . .	local	REAL*8	8	0008
IWIDTH. . . . .	local	INTEGER*4	4	0010
K . . . . .	local	INTEGER*4	4	0014
L . . . . .	local	INTEGER*4	4	0018
N . . . . .	local	REAL*4	4	001c
HOA . . . . .	local	REAL*4	4	0020
CPH . . . . .	local	REAL*4	4	0024
AZ. . . . .	local	REAL*8	8	0028
ONE . . . . .	local	INTEGER*4	4	0030
IPHC. . . . .	local	INTEGER*4	4	0034
APRC. . . . .	local	REAL*4	8	0038
KRL . . . . .	local	REAL*4	4	0040
HOR . . . . .	local	REAL*4	4	0044

## CALCPZC Local Symbols

Name	Class	Type	Size	Offset
AZN . . . . .	local	REAL*8	8	0048
AZP . . . . .	local	REAL*8	8	0050
OON . . . . .	local	REAL*4	4	0058
PSI . . . . .	local	REAL*4	8	005c
RPHC. . . . .	local	REAL*4	4	0064
TWO . . . . .	local	INTEGER*4	4	0068

## Global Symbols

Name	Class	Type	Size	Offset
CALCPZC. . . . .	FSUBRT	***	***	0000
WKO . . . . .	extern	***	***	***
WKTH. . . . .	extern	***	***	***
WKTW. . . . .	extern	***	***	***

Code size = 082d (2093)

Data size = 003c (60)

Bss size = 006c (108)

No errors detected



## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE CALCZP (V, APR, TAH, ZPDP1, ZPPH1,
2      & ZPPH2, ZPDP2, SPH, FPH, PHSS, WT, PH, CONCL,
3      & NZP1, NZP2, WOO, WOT, WTT, FLDIR, TEMP)
4      CCCCC REV. 06-22-92
5
6      CCC-----SUBPROGRAM TO CALCULATE
7      C-----OVERALL STABILITY RATIO
8      C-----USING ZETA POTENTIAL DATA--
9
10     IMPLICIT NONE
11     CHARACTER FLDIR*7
12     INTEGER ONE,TWO,IPHC,IWIDTH
13     REAL N, APR, ZPDP1, ZPPH1, ZPDP2, ZPPH2, SPH,
14     REAL FPH, PHSS, PH, TEMP, TEMPK
15     REAL CPH, RPHC, DELTPH, TAH, KRL, POT, CONCL,
16     REAL*8 WOO,WOT,WTT,OOWT,WT,AZ,AZP,AZN
17     DIMENSION PH(200),APR(2),POT(2),TAH(2:4)
18     DIMENSION WT(200),WOO(200),WOT(200),WTT(200)
19     DIMENSION ZPDP1(200), ZPPH1(200), ZPDP2(200),
20     DIMENSION ZPPH2(200)
21     INTEGER K,NZP1,NZP2
22     REAL ZPD,APRC,V, OON
23     REAL DELTA,HOA,HOR
24     DIMENSION ZPD(2),APRC(2)
25     DIMENSION DELTA(2)
26
27     CCCCC OOWT=ONE OVER WT
28     CCCCC W=REAL FCN. USED IN FCN. SUBPROGRAM TO FIND
29     CCCCC WOO,WOT,WTT
30     CCCCC CPH=CURRENT PH
31     CCCCC TEMPK=SYSTEM TEMPREATURE IN DEGREES KELVIN
32     CCCCC DELTA=DISTANCE FROM PARTICLE SURFACE TO STERN
33     CCCCC LAYER(M)
34     CCCCC RPHC=REAL VARIABLE PH COUNTER(FOR DO LOOP)
35     CCCCC IPHC=INTEGER VARIABLE PH COUNTER(FOR DO LOOP)
36     CCCCC POT=ZETA POTENTIAL FOR PARTICLES AT CURRENT PH
37     CCCCC ZPD=ZETA POTENTIAL DATA AT CPH FOR
38     CCCCC PARTICLE(ARRAY VARIABLE)
39     CCCCC DELTPH=CHANGE IN PH FROM FINISHING PH TO
40     CCCCC STARTING PH
41     CCCCC K=INTEGER VARIABLE USED AS COUNTER FOR LOOP TO
42     CCCCC CALCULATE STABILITY RATIO FOR EACH SPECIFIED
43     CCCCC PH
44     CCCCC KRL=REAL REPRESENTATION OF VARIABLE K
45     CCCCC IWIDTH=WIDTH OF INTEGER K (EX: 1 DIGIT, 2
46     CCCCC DIGITS,ETC.)

```

Line# Source Line

```

39 CCCCC ONE=INTEGER VARIABLE EQUAL TO ONE
40 CCCCC TWO=INTEGER VARIABLE EQUAL TO TWO
41 CCCCC HOA=MINIMUM PARTICLE SEPERATION FOR ATTRACTIVE
    CCCCC      TERM (M)
42 CCCCC HOR=MINIMUM SEPARATION FOR REPULSIVE TERMS (M)
43 CCCCC AZ=VARIABLE REPRESENTING ALMOST ZERO (1.0E-309)
44 CCCCC AZP=POSITIVE VALUE OF AZ USED TO PREVENT AN
45 CCCCC      INVERSE FROM GOING TO INFINITY WHICH WILL
46 CCCCC      CAUSE A MATH OVERFLOW ERROR RESULTING IN
    CCCCC      PROGRAM TERMINATION
47 CCCCC AZN=NEGATIVE VALUE OF AZ USED AS AZP IS USED
48 CCCCC WKO=SUBROUTINE TO CALCULATE STABILITY IF K IS
    CCCCC      ONE DIGIT WIDE
49 CCCCC WKTW=SUBROUTINE TO CALCULATE STABILITY IF K IS
    CCCCC      TWO DIGITS WIDE
50 CCCCC WKTH=SUBROUTINE TO CALCULATE STABILITY IF K IS
    CCCCC      THREE DIGITS
51
52
53 10      TEMPK=TEMP+273.2
54 20      DELTA(1)=0.50E-9
55 30      DELTA(2)=0.50E-9
56 40      ONE=1
57 50      TWO=2
58
59 CC-----CALCULATING VALUES FOR AZP AND
    C-----AZN-----
60 60      AZ=1.0E-25
61 70      DO 90 K=1,11,1
62 80          AZ=AZ/1.0E25
63 90      CONTINUE
64 100     AZP=AZ/1.0E9
65 110     AZN=-1.0*AZP
66
67 CC-----CONVERTING PH COUNTER TO
    C-----INTEGervARIABLE-----
68 120     DELTPH = FPH-SPH
69 130     IF (PHSS.EQ.0.0 .OR. DELTPH.EQ.0.0) THEN
70 140         IPHC=1
71 150     ELSE
72 160         RPHC = (FPH-SPH)/PHSS
73 170         IPHC = NINT(RPHC)
74 180         IPHC = IPHC+1
75 190     END IF
76
77 CC-----CALCULATING N FROM V-----
78 200     APRC(1) = APR(1)**3
79 210     APRC(2) = APR(2)**3
80 220     OON = ((APRC(1))-(V*APRC(1)))/(V*APRC(2))
81 230     OON = OON + 1.00

```

Line# Source Line

```

82 240 N = 1.00/OON
83
84 CC-----INITIALIZING CURRENT PH-----
85 250 CPH = SPH
86
87
88 CC-----CALCULATING OVERALL STABILITY
89 C-----RATIO FOR SPECIFIED PH RANGE
90 C-----& STEP SIZE-----
91 260 DO 550 K=1,IPHC,1
92 270 KRL=REAL(K)
93 280 IWIDTH=INT(LOG10(KRL)+1)
94
95 C-----GETTING ZETA POTENTIAL VALUES
96 C-----FOR SPECIFIED PH VALUES--
97 290 CALL INTERP(ZPDP1, ZPPH1, ZPPH2, ZPDP2, CPH,
& NZP1, NZP2, ZPD)
98
99 C-----CHANGING UNITS OF V FROM mV---
100 300 POT(1)=ZPD(1)*1.0E-3
101 310 POT(2)=ZPD(2)*1.0E-3
102 320 HOA = DELTA(1)+DELTA(2)
103 330 HOR = 1.0E-10
104
105 CC-----FINDING VARIOUS (INVERSE)
106 C-----PROBABILITIES OF PARTICLE
107 C-----COLLISION & ADHESION-----
107 340 IF(IWIDTH.EQ.1)THEN
108 350 CALL WKO(K, WOO, WOT, WTT, APR, TAH, POT,
& CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
109 360 ELSE IF(IWIDTH.EQ.2)THEN
110 370 CALL WKTW(K, WOO, WOT, WTT, APR, TAH, POT,
& CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
111 380 ELSE IF(IWIDTH.EQ.3)THEN
112 390 CALL WKTH(K, WOO, WOT, WTT, APR, TAH, POT,
& CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
113 400 END IF
114
115 CC-----FINDING THE INVERSE OF THE
116 C-----OVERALL STABILITY RATIO AT
117 C-----CURRENTPH-----
118
119 C-----ENSURING INVERSES WILL NOT GO
120 C-----TO INFINITY, CAUSE A MATH
121 C-----OVERFLOW ERROR, AND RESULT
122 C-----IN IN PROGRAM TERMINATION--
123 410 IF(WOO(K).LE.AZP .AND. WOO(K).GE.AZN)THEN
124 420 WT(K)=AZP
125 430 ELSE IF(WOT(K).LE.AZP .AND. WOT(K).GE.AZN)THEN

```

## Line# Source Line

```

127 440      WT(K)=AZP
128 450      ELSE IF(WTT(K).LE.AZP .AND. WTT(K).GE.AZN) THEN
129 460          WT(K)=AZP
130 470      ELSE
131 480          OOWT = (N*N/WOO(K))
132 490          OOWT = OOWT+((1.0-N)*(1.0-N)/WTT(K))
133 500          OOWT = OOWT+(2.0*N*(1.0-N)/WOT(K))
134 510          WT(K)=1.0/OOWT
135 520      END IF
136
137 CC-----SETTING COORESPONDING PH VALUE
   C-----FOR WT(I)-----
138 530      PH(K)=CPH
139
140 CC-----SETTING NEW CURRENT PH VALUE--
141 540      CPH = CPH + PHSS
142 550      CONTINUE
143
144
145 CC-----RETURNING WT & PH VALUES TO
   C-----MAINPROGRAM-----
146 998      RETURN
147 999      END

```

## CALCZP Local Symbols

Name	Class	Type	Size	Offset
TEMP. . . . .	param			0006
FLDIR . . . . .	param			000a
WTT . . . . .	param			000e
WOT . . . . .	param			0012
WOO . . . . .	param			0016
NZP2. . . . .	param			001a
NZP1. . . . .	param			001e
CONCL . . . . .	param			0022
PH. . . . .	param			0026
WT. . . . .	param			002a
PHSS. . . . .	param			002e
FPH . . . . .	param			0032
SPH . . . . .	param			0036
ZPDP2 . . . . .	param			003a
ZPPH2 . . . . .	param			003e
ZPPH1 . . . . .	param			0042
ZPDP1 . . . . .	param			0046
TAH . . . . .	param			004a
APR . . . . .	param			004e
V . . . . .	param			0052
TEMPK . . . . .	local	REAL*4	4	0000

## CALCZP Local Symbols

Name	Class	Type	Size	Offset
DELTPH. . . . .	local	REAL*4	4	0004
OOWT. . . . .	local	REAL*8	8	0008
IWIDTH. . . . .	local	INTEGER*4	4	0010
K . . . . .	local	INTEGER*4	4	0014
N . . . . .	local	REAL*4	4	0018
HOA . . . . .	local	REAL*4	4	001c
AZ. . . . .	local	REAL*8	8	0020
CPH . . . . .	local	REAL*4	4	0028
ONE . . . . .	local	INTEGER*4	4	002c
IPHC. . . . .	local	INTEGER*4	4	0030
APRC. . . . .	local	REAL*4	8	0034
HOR . . . . .	local	REAL*4	4	003c
AZN . . . . .	local	REAL*8	8	0040
KRL . . . . .	local	REAL*4	4	0048
DELTA . . . . .	local	REAL*4	8	004c
AZP . . . . .	local	REAL*8	8	0054
OON . . . . .	local	REAL*4	4	005c
RPHC. . . . .	local	REAL*4	4	0060
ZPD . . . . .	local	REAL*4	8	0064
POT . . . . .	local	REAL*4	8	006c
TWO . . . . .	local	INTEGER*4	4	0074

Line# Source Line

```

148
149
150
151      SUBROUTINE INTERP(ZPDP1, ZPPH1, ZPPH2, ZPDP2,
      & CPH, NZP1, NZP2, ZPD)
152
153      CCCCC REV. 03-05-92
154
155      CCC-----SUBPROGRAM TO CALCULATE
156      C-----OVERALL STABILITY RATIO
157      C-----USING ZETA POTENTIAL DATA---
158
159      IMPLICIT NONE
160      REAL ZPDP1,ZPPH1,ZPPH2,ZPDP2
161      REAL CPH
162      DIMENSION ZPDP1(200), ZPPH1(200), ZPDP2(200),
163      DIMENSION ZPPH2(200)
164      INTEGER M,NZP1,NZP2
165      REAL ZPD,ZPDN,ZPDD,ZPGT,ZPLT,PHGT,PHLT
166      REAL PZPGT,PZPLT,PGTDIF,PLTDIF,CGTDIF,CLTDIF
167      REAL PPHGT,PPHLT
168      DIMENSION ZPD(2)
169
170      CCCCC ZPDN=NUMERATOR TERM USED TO CALCULATE ZPD
171      CCCCC ZPDD=DENOMENATOR TERM USED TO CALCULATE ZPD
172      CCCCC PPHGT=PRESENT/PERMANENT PH VALUE GREATER THAN
173      CCCCC      CPH (i.e.PH PRESENTLY NEAREST TO CPH, BUT
174      CCCCC      STILL GREATER THAN CPH)
175      CCCCC PPHGT=PRESENT/PERMANENT PH VALUE LESS THAN CPH
176      CCCCC      (i.e.PH PRESENTLY NEAREST TO CPH, BUT
177      CCCCC      STILL LESS THAN CPH)
178      CCCCC PZPGT=PRESENT/PERMANENT ZETA POTENTIAL VALUE
179      CCCCC      COORESPONDING TO PPHGT
180      CCCCC PZPLT=PRESENT/PERMANENT ZETA POTENTIAL VALUE
181      CCCCC      COORESPONDING TO PPHLT
182      CCCCC PGTDIF=PRESENT/PERMANENT GREATER THAN DIFFERENCE
183      CCCCC      BETWEEN PGTPH AND CPH
184      CCCCC PLTDIF=PRESENT/PERMANENT LESS THAN DIFFERENCE
185      CCCCC      BETWEEN PLTPH AND CPH
186      CCCCC CGTDIF=CURRENT(i.e.THIS ITERATION) GREATER THAN
187      CCCCC      DIFFERENCE BETWEEN CPH AND THE CURRENT
188      CCCCC      ZPPH VALUE IF IT IS GREATER THAN CPH(THIS
189      CCCCC      ITERATION)
190      CCCCC CLTDIF=CURRENT(i.e.THIS ITERATION) LESS THAN
191      CCCCC      DIFFERENCE BETWEEN CPH AND THE CURRENT
192      CCCCC      ZPPH VALUE IF IT IS LESS THAN CPH(THIS
193      CCCCC      ITERATION)
194      CCCCC PHGT=PH GREATER THAN (CPH AND NEAREST TO IT)
195      CCCCC PHLT=PH LESS THAN (CPH AND NEAREST TO IT)
196      CCCCC ZPGT=ZETA POTENTIAL VALUE COORESPONDING TO PHGT

```

Line# Source Line

```

191 CCCCC ZPLT=ZETA POTENTIAL VALUE COORESPONDING TO ZPLT
192 CCCCC M=INTEGER VARIABLE USED AS COUNTER FOR VARIOUS
    CCCCC DO LOOPS
193
194
195 CC-----INTERPOLATING Z.P. DATA TO GET
    C-----VALUESFOR-----
196 C-----CURRENT PH (IF NEED BE)-----
197 10          PLTDIF=20.0
198 20          PGTDIF=20.0
199 30          DO 220 M=1,NZP1,1
200
201 CC-----IF CPH= a ZPPH VALUE:
202 CC-----RETURNING THAT ZPAS THE
    C-----DESIRED ZP VALUE-----
203 40          IF (ZPPH1(M) .EQ. CPH) THEN
204 50              ZPD(1) = ZPDP1(M)
205 60              GOTO 300
206
207 CC-----IF CPH.NE. a ZPPH VALUE:THEN
208 CC-----MUST INTERPOLATE TO GET A
    C-----ZPD FOR THIS CPH-----
209 C-----TRYING TO FIND THE NEAREST PH
210 C-----TO CPH THAT IS LESS THAN CPH-
211 70          ELSE IF (ZPPH1(M) .LT. CPH) THEN
212 80              CLTDIF = CPH-ZPPH1(M)
213 90              IF (CLTDIF .LT. PLTDIF) THEN
214 100                 PPHLT = ZPPH1(M)
215 110                 PLTDIF = CLTDIF
216 120                 PZPLT = ZPDP1(M)
217 130                 END IF
218
219 C-----TRYING TO FIND THE NEAREST PH
220 C-----TO CPH THAT IS GREATER THAN
    C-----CPH-----
221 140          ELSE IF (ZPPH1(M) .GT. CPH) THEN
222 150              CGTDIF = ZPPH1(M) - CPH
223 160              IF (CGTDIF .LT. PGTDIF) THEN
224 170                 PPHGT = ZPPH1(M)
225 180                 PGTDIF = CGTDIF
226 190                 PZPGT = ZPDP1(M)
227 200                 END IF
228 210                 END IF
229 220                 CONTINUE
230
231 C-----INTERPOLATING WITH NEAREST
    C-----VALUES-----
232 230          PPHLT = PPHLT
233 240          ZPLT = PZPLT
234 250          PHGT = PPHGT

```

Line# Source Line

```

235 260      ZPGT = PZPGT
236 270      ZPDN = ZPLT*(CPH-PHGT) + ZPGT*(PHLT-CPH)
237 280      ZPDD = PHLT - PHGT
238 290      ZPD(1) = ZPDN/ZPDD
239
240 CC-----INTERPOLATING Z.P. DATA TO GET
   C-----VALUESFOR-----
241 C-----CURRENT PH (IF NEED BE) -----
242 300      PLTDIF=20.0
243 310      PGTDIF=20.0
244 320      DO 510 M=1,NZP2,1
245
246 CC-----IF CPH= a ZPPH VALUE:
247 CC-----RETURNING THAT ZP AS THE
   C-----DESIRED ZP VALUE-----
248 330      IF (ZPPH2(M) .EQ. CPH) THEN
249 340          ZPD(2) = ZPDP2(M)
250 350          GOTO 998
251
252 CC-----IF CPH.NE. a ZPPH VALUE: THEN
253 CC-----MUST INTERPOLATE TO GET A
   C-----ZPD FOR THIS CPH-----
254 C-----TRYING TO FIND THE NEAREST PH
255 C-----TO CPH THAT IS LESS THAN CPH-
256 360      ELSE IF (ZPPH2(M) .LT. CPH) THEN
257 370          CLTDIF = CPH-ZPPH2(M)
258 380          IF (CLTDIF .LT. PLTDIF) THEN
259 390              PPHLT = ZPPH2(M)
260 400              PLTDIF = CLTDIF
261 410              PZPLT = ZPDP2(M)
262 420              END IF
263
264 C-----TRYING TO FIND THE NEAREST PH
265 C-----TO CPH THAT IS GREATER THAN
   C-----CPH-----
266 430      ELSE IF (ZPPH2(M) .GT. CPH) THEN
267 440          CGTDIF = ZPPH2(M) - CPH
268 450          IF (CGTDIF .LT. PGTDIF) THEN
269 460              PPHGT = ZPPH2(M)
270 470              PGTDIF = CGTDIF
271 480              PZPGT = ZPDP2(M)
272 490              END IF
273 500          END IF
274 510      CONTINUE
275
276 C-----INTERPOLATING WITH NEAREST
   C-----VALUES-----
277 520      PHLT = PPHLT
278 530      ZPLT = PZPLT
279 540      PHGT = PPHGT

```





## Line# Source Line

```

280 550      ZPGT = PZPGT
281 560      ZPDN = ZPLT*(CPH-PHGT) + ZPGT*(PHLT-CPH)
282 570      ZPDD = PHLT - PHGT
283 580      ZPD(2) = ZPDN/ZPDD
284
285 CC-----RETURNING WT & PH VALUES TO
    C-----MAIN PROGRAM-----
286 998      RETURN
287 999      END

```

## INTERP Local Symbols

Name	Class	Type	Size	Offset
ZPD . . . . .	param			0006
NZP2. . . . .	param			000a
NZP1. . . . .	param			000e
CPH . . . . .	param			0012
ZPDP2 . . . . .	param			0016
ZPPH2 . . . . .	param			001a
ZPPH1 . . . . .	param			001e
ZPDP1 . . . . .	param			0022
PPHGT . . . . .	local	REAL*4	4	0078
PLTDIF. . . . .	local	REAL*4	4	007c
ZPGT. . . . .	local	REAL*4	4	0080
PPHLT . . . . .	local	REAL*4	4	0084
ZPLT. . . . .	local	REAL*4	4	0088
M . . . . .	local	INTEGER	4	008c
PZPGT . . . . .	local	REAL*4	4	0090
PZPLT . . . . .	local	REAL*4	4	0094
CGTDIF. . . . .	local	REAL*4	4	0098
ZPDD. . . . .	local	REAL*4	4	009c
PHGT. . . . .	local	REAL*4	4	00a0
CLTDIF. . . . .	local	REAL*4	4	00a4
PHLT. . . . .	local	REAL*4	4	00a8
ZPDN. . . . .	local	REAL*4	4	00ac
PGTDIF. . . . .	local	REAL*4	4	00b0

## Global Symbols

Name	Class	Type	Size	Offset
CALCZP. . . . .	FSUBRT	***	***	0000
INTERP. . . . .	FSUBRT	***	***	079e
WKO . . . . .	extern	***	***	***
WKTH. . . . .	extern	***	***	***
WKTW. . . . .	extern	***	***	***

Code size = 0ec7 (3783)  
Data size = 0044 (68)  
Bss size = 00b4 (180)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE WKO(K, WOO, WOT, WTT, APR, TAH,
2      & PSI, CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
3
4      CCCC REV. 05-04-92
5
6      IMPLICIT NONE
7      CHARACTER FLNME*28,FLDIR*7
8      INTEGER ONE,TWO,K,POS,KI,L
9      REAL APR,TAH,PSI,CONCL,HOA,HOR,CPH,X,TEMPK
10     REAL*8 WOO,WOT,WTT,WCALC,VOO,VOT,VTT
11     DIMENSION X(250), VOO(250), VOT(250),
12     DIMENSION VTT(250), TAH(2:4), APR(2), PSI(2)
13     DIMENSION WOO(200), WOT(200), WTT(200)
14
15     CCCCC ONE=INTEGER VARIABLE EQUAL TO 1
16     CCCCC TWO=INTEGER VARIABLE EQUAL TO 2
17     CCCCC WCALC=CALCULATED W VALUE FROM SUBROUTINE WC
18     CCCCC KI=INTEGER VARIABLE REPRESENTATION OF K USED
19     CCCCC      TO MAKE A CHARACTER VARIABLE REPRESENTATION
20     CCCCC      OF K FOR FILENAME
21     CCCCC X=SEPARATION DISTANCE (ARRAY) (M)
22     CCCCC VOO,VOT,VTT=POTENTIAL FOR A GIVEN PARTICLE
23     CCCCC      INTERACTION AT COORESPONDING
24     CCCCC      SEPERATION DISTANCE X (ARRAY)
25
26
27     10      ONE=1
28     20      TWO=2
29     30      KI=K
30
31     CC-----FINDING VARIOUS (INVERSE)
32     C-----PROBABILITIES OF PARTICLE
33     C-----COLLISION & ADHESION-----
34
35     C-----FOR COLLISION OF TWO
36     C-----PARTICLES OF TYPE #1-----
37
38     40      FLNME(1:14)='C:\JK\LL\DATA\'
39     50      FLNME(15:21)=FLDIR
40     60      FLNME(22:22)='\'
41     70      FLNME(23:23)='V'
42     80      FLNME(24:24)=CHAR(MOD(KI,10)+ICHAR('0'))
43     90      FLNME(25:28)=' .DAT'
44     100     CALL WC(WCALC, APR, TAH, PSI, ONE, ONE, CONCL,
45     & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
46     110     WOO(K)=WCALC
47

```

Line# Source Line

```

42 C-----FOR COLLISION OF PARTICLES 1
43 C-----& 2-----
44 120 CALL WC(WCALC, APR, TAH, PSI, ONE, TWO, CONCL,
45 & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
46 130 WOT(K)=WCALC
47
80 C-----FOR COLLISION OF TWO
49 C-----PARTICLES OF TYPE #2-----
50 140 CALL WC(WCALC, APR, TAH, PSI, TWO, TWO, CONCL,
51 & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
52 150 WTT(K)=WCALC
53
54 CC-----WRITING V DATA TO FILE-----
55 160 OPEN(15,FILE=FLNME,STATUS='NEW')
56 170 WRITE(15,*)'CPH,APR(1),APR(2)'
57 180 WRITE(15,*)CPH,APR(1),APR(2)
58 190 WRITE(15,*)'PSI(1),PSI(2),CONCL,TAH'
59 200 WRITE(15,*)PSI(1),PSI(2),CONCL,TAH
60 210 WRITE(15,900)
61 220 WRITE(15,910)
62 230 DO 300 L=1,240,1
63 240 IF(X(L).NE.0.0)THEN
64 250 WRITE(15,920)X(L),VOO(L),VOT(L),VTT(L)
65 260 END IF
66 270 CONTINUE
69 280 CLOSE(15)
70
71 CCC-----FORMAT STATEMENTS-----
72 900 FORMAT (5X,'SEP',12X,'V11',12X,
73 & 1X,'V12',12X,
74 & 1X,'V22')
75 910 FORMAT (5X,'---',12X,'---',12X,
76 & 1X,'---',12X,
77 & 1X,'---')
78 920 FORMAT (1X,E12.4,1X,',',1X,E12.4,1X,',',
79 & 1X,E12.4,1X,',',
80 & 1X,E12.4,1X)
81
82 998 RETURN
83 999 END
84

```

## WKTW Local Symbols

Name	Class	Type	Size	Offset
TEMPK . . . . .	param			0006
FLDIR . . . . .	param			000a
CPH . . . . .	param			000e
HOR . . . . .	param			0012
HOA . . . . .	param			0016
CONCL . . . . .	param			001a
PSI . . . . .	param			001e
TAH . . . . .	param			0022
APR . . . . .	param			0026
WTT . . . . .	param			002a
WOT . . . . .	param			002e
WOO . . . . .	param			0032
K . . . . .	param			0036
X . . . . .	local	REAL*4	1000	0000
L . . . . .	local	INTEGER*4	4	0002
KI. . . . .	local	INTEGER*4	4	0006
ONE . . . . .	local	INTEGER*4	4	000a
WCALC . . . . .	local	REAL*8	8	000e
POS . . . . .	local	INTEGER*4	4	0016
FLNME . . . . .	local	CHAR*29	29	001a
TWO . . . . .	local	INTEGER*4	4	0038
VOO . . . . .	local	REAL*8	2000	03e8
VOT . . . . .	local	REAL*8	2000	0bb8
VTT . . . . .	local	REAL*8	2000	1388

## Global Symbols

Name	Class	Type	Size	Offset
WC. . . . .	extern	***	***	***
WKTW. . . . .	FSUBRT	***	***	0000

Code size = 045e (1118)

Data size = 0089 (137)

Bss size = 003c (60)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE WKTW(K, WOO, WOT, WTT, APR, TAH,
2      & PSI, CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
3
4      CCCC REV. 05-04-92
5
6      IMPLICIT NONE
7      CHARACTER FLNME*29,FLDIR*7
8      INTEGER ONE,TWO,K,POS,KI,L
9      REAL APR,TAH,PSI,CONCL,HOA,HOR,CPH,X,TEMPK
10     REAL*8 WOO,WOT,WTT,WCALC,VOO,VOT,VTT
11     DIMENSION X(250), VOO(250), VOT(250),
12     DIMENSION VTT(250), TAH(2:4), APR(2), PSI(2)
13     DIMENSION WOO(200), WOT(200), WTT(200)
14
15     CCCCC ONE=INTEGER VARIABLE EQUAL TO 1
16     CCCCC TWO=INTEGER VARIABLE EQUAL TO 2
17     CCCCC WCALC=CALCULATED W VALUE FROM SUBROUTINE WC
18     CCCCC KI=INTEGER VARIABLE REPRESENTATION OF K USED
19     CCCCC      TO MAKE A CHARACTER VARIABLE REPRESENTATION
20     CCCCC      OF K FOR FILENAME
21     CCCCC X=SEPARATION DISTANCE (ARRAY) (M)
22     CCCCC VOO,VOT,VTT=POTENTIAL FOR A GIVEN PARTICLE
23     CCCCC      INTERACTION AT COORESPONDING
24     CCCCC      SEPERATION DISTANCE X (ARRAY)
25
26
27     10      ONE=1
28     20      TWO=2
29     30      KI=K
30
31     CC-----FINDING VARIOUS (INVERSE)
32     C-----PROBABILITIES OF PARTICLE
33     C-----COLLISION & ADHESION-----
34
35     C-----FOR COLLISION OF TWO
36     C-----PARTICLES OF TYPE #1-----
37
38     40      FLNME(1:14)='C:\JK\LL\DATA\'
39     50      FLNME(15:21)=FLDIR
40     60      FLNME(22:22)='\ '
41     70      FLNME(23:23)='V'
42     80      DO 110 POS=25,24,-1
43     90          FLNME(POS:POS)=CHAR(MOD(KI,10)+ICHAR('0'))
44     100         KI=KI/10
45     110      CONTINUE
46     120      FLNME(26:29)='.DAT'
47     130      CALL WC(WCALC, APR, TAH, PSI, ONE, ONE, CONCL,
48     & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
49     140      WOO(K)=WCALC
50

```

Line# Source Line

```

45  C-----FOR COLLISION OF PARTICLES 1
C-----& 2-----
46  150  CALL WC(WCALC, APR, TAH, PSI, ONE, TWO, CONCL,
47      & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
48  160  WOT(K)=WCALC
49
50  C-----FOR COLLISION OF TWO
C-----PARTICLES OF TYPE #2-----
51  170  CALL WC(WCALC, APR, TAH, PSI, TWO, TWO, CONCL,
52      & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
53  180  WTT(K)=WCALC
54
55  CC-----WRITING V DATA TO FILE-----
56  190  OPEN(15,FILE=FLNME,STATUS='NEW')
57  200  WRITE(15,*) 'CPH,APR(1),APR(2)'
58  210  WRITE(15,*) CPH,APR(1),APR(2)
59  220  WRITE(15,*) 'PSI(1),PSI(2),CONCL,TAH'
60  230  WRITE(15,*) PSI(1),PSI(2),CONCL,TAH
61  240  WRITE(15,900)
62  250  WRITE(15,910)
63  260  DO 300 L=1,240,1
64  270      IF(X(L).NE.0.0) THEN
65  280          WRITE(15,920) X(L),VOO(L),VOT(L),VTT(L)
66  290      END IF
67  300  CONTINUE
68  310  CLOSE(15)
69
70  CCC-----FORMAT STATEMENTS-----
71  900  FORMAT (5X,'SEP',12X,'V11',12X,
72      & 1X,'V12',12X,
73      & 1X,'V22')
74  910  FORMAT (5X,'---',12X,'---',12X,
75      & 1X,'---',12X,
76      & 1X,'---')
77  920  FORMAT (1X,E12.4,1X,',',1X,E12.4,1X,',',
78      & 1X,E12.4,1X,',',
79      & 1X,E12.4,1X)
80
81  998  RETURN
82  999  END

```



## WKTW Local Symbols

Name	Class	Type	Size	Offset
TEMPK . . . . .	param			0006
FLDIR . . . . .	param			000a
CPH . . . . .	param			000e
HOR . . . . .	param			0012
HOA . . . . .	param			0016
CONCL . . . . .	param			001a
PSI . . . . .	param			001e
TAH . . . . .	param			0022
APR . . . . .	param			0026
WTT . . . . .	param			002a
WOT . . . . .	param			002e
WOO . . . . .	param			0032
K . . . . .	param			0036
X . . . . .	local	REAL*4	1000	0000
L . . . . .	local	INTEGER*4	4	0002
KI. . . . .	local	INTEGER*4	4	0006
ONE . . . . .	local	INTEGER*4	4	000a
WCALC . . . . .	local	REAL*8	8	000e
POS . . . . .	local	INTEGER*4	4	0016
FLNME . . . . .	local	CHAR*29	29	001a
TWO . . . . .	local	INTEGER*4	4	0038
VOO . . . . .	local	REAL*8	2000	03e8
VOT . . . . .	local	REAL*8	2000	0bb8
VTT . . . . .	local	REAL*8	2000	1388

## Global Symbols

Name	Class	Type	Size	Offset
WC. . . . .	extern	***	***	***
WKTW. . . . .	FSUBRT	***	***	0000

Code size = 045e (1118)

Data size = 0089 (137)

Bss size = 003c (60)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1          SUBROUTINE WKTH(K, WOO, WOT, WTT, APR, TAH,
2          & PSI, CONCL, HOA, HOR, CPH, FLDIR, TEMPK)
3
4  CCCC REV. 05-04-92
5
6          IMPLICIT NONE
7          CHARACTER FLNME*30,FLDIR*7
8          INTEGER ONE,TWO,K,POS,KI,L
9          REAL APR,TAH,PSI,CONCL,HOA,HOR,CPH,X,TEMPK
10         REAL*8 WOO,WOT,WTT,WCALC,VOO,VOT,VTT
11         DIMENSION VOO(250), VOT(250), VTT(250), X(250)
12         DIMENSION TAH(2:4), APR(2), PSI(2)
13         DIMENSION WOO(200), WOT(200), WTT(200)
14
15 CCCCC ONE=INTEGER VARIABLE EQUAL TO 1
16 CCCCC TWO=INTEGER VARIABLE EQUAL TO 2
17 CCCCC WCALC=CALCULATED W VALUE FROM SUBROUTINE WC
18 CCCCC KI=INTEGER VARIABLE REPRESENTATION OF K USED
19 CCCCC    TO MAKE A CHARACTER VARIABLE REPRESENTATION
20 CCCCC    OF K FOR FILENAME
21 CCCCC X=SEPARATION DISTANCE (ARRAY) (M)
22 CCCCC VOO,VOT,VTT=POTENTIAL FOR A GIVEN PARTICLE
23 CCCCC    INTERACTION AT COORESPONDING
24 CCCCC    SEPERATION DISTANCE X (ARRAY)
25
26
27
28 CC-----FINDING VARIOUS (INVERSE)
29 C-----PROBABILITIES OF PARTICLE
30 C-----COLLISION & ADHESION-----
31
32 C-----FOR COLLISION OF TWO
33 C-----PARTICLES OF TYPE #1-----
34 40      FLNME(1:14)='C:\JK\LL\DATA\'
35 50      FLNME(15:21)=FLDIR
36 60      FLNME(22:22)='V'
37 70      FLNME(23:23)='\ '
38 80      DO 110 POS=26,24,-1
39 90          FLNME(POS:POS)=CHAR(MOD(KI,10)+ICHAR('0'))
40 100         KI=KI/10
41 110      CONTINUE
42 120      FLNME(27:30)=' .DAT'
43 130      CALL WC(WCALC, APR, TAH, PSI, ONE, ONE, CONCL,
44 140      & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
45      WOO(K)=WCALC

```

Line# Source Line

```

45
46 C-----FOR COLLISION OF PARTICLES 1
   C-----& 2-----
47 150 CALL WC(WCALC, APR, TAH, PSI, ONE, TWO, CONCL,
48      & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR,TEMPK)
49 160 WOT(K)=WCALC
50
51 C-----FOR COLLISION OF TWO
   C-----PARTICLES OF TYPE #2-----
52 170 CALL WC(WCALC, APR, TAH, PSI, TWO, TWO, CONCL,
53      & HOA, HOR, CPH, VOO,VOT,VTT, X, FLDIR, TEMPK)
54 180 WTT(K)=WCALC
55
56 CC-----WRITING V DATA TO FILE-----
57 190 OPEN(15,FILE=FLNME,STATUS='NEW')
58 200 WRITE(15,*) 'CPH,APR(1),APR(2)'
59 210 WRITE(15,*) CPH,APR(1),APR(2)
60 220 WRITE(15,*) 'PSI(1),PSI(2),CONCL,TAH'
61 230 WRITE(15,*) PSI(1),PSI(2),CONCL,TAH
62 240 WRITE(15,900)
63 250 WRITE(15,910)
64 260 DO 300 L=1,240,1
65 270 IF(X(L).NE.0.0) THEN
66 280 WRITE(15,920) X(L),VOO(L),VOT(L),VTT(L)
67 290 END IF
68 300 CONTINUE
69 310 CLOSE(15)
70
71 CCC-----FORMAT STATEMENTS-----
72 900 FORMAT (5X,'SEP',12X,'V11',12X,
73      & 1X,'V12',12X,
74      & 1X,'V22')
75 910 FORMAT (5X,'---',12X,'---',12X,
76      & 1X,'---',12X,
77      & 1X,'---')
78 920 FORMAT (1X,E12.4,1X,',',1X,E12.4,1X,',',
79      & 1X,E12.4,1X,',',
80      & 1X,E12.4,1X)
81
82 998 RETURN
83 999 END

```

## WKTH Local Symbols

Name	Class	Type	Size	Offset
TEMPK . . . . .	param			0006
FLDIR . . . . .	param			000a
CPH . . . . .	param			000e
HOR . . . . .	param			0012
HOA . . . . .	param			0016
CONCL . . . . .	param			001a
PSI . . . . .	param			001e
TAH . . . . .	param			0022
APR . . . . .	param			0026
WTT . . . . .	param			002a
WOT . . . . .	param			002e
WOO . . . . .	param			0032
K . . . . .	param			0036
X . . . . .	local	REAL*4	1000	0000
L . . . . .	local	INTEGER*4	4	0002
KI. . . . .	local	INTEGER*4	4	0006
ONE . . . . .	local	INTEGER*4	4	000a
WCALC . . . . .	local	REAL*8	8	000e
POS . . . . .	local	INTEGER*4	4	0016
FLNME . . . . .	local	CHAR*30	30	001a
TWO . . . . .	local	INTEGER*4	4	0038
VOO . . . . .	local	REAL*8	2000	03e8
VOT . . . . .	local	REAL*8	2000	0bb8
VTT . . . . .	local	REAL*8	2000	1388

## Global Symbols

Name	Class	Type	Size	Offset
WC. . . . .	extern	***	***	***
WKTH. . . . .	FSUBRT	***	***	0000

Code size = 045e (1118)

Data size = 0089 (137)

Bss size = 003c (60)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE WC(WCALC, APR, TAH, PSI, I, J,
2      & CONCL, HOA, HOR, CPH, VOO, VOT, VTT, X,
3      & FLDIR, TEMPK)
4      CCCCC REV. 05-04-92
5
6      CCC-----SUBPROGRAM TO INTEGRATE FROM
7      CCC-----MINIMUM PARTICLE SEPARATION TO AN
8      CCC-----INFINITE SEPARATION IN SEGMENTS SO
9      CCC-----THAT WHEN AN AREA OF A SEGMENT ADDS
10     CCC-----A SMALL ENOUGH AMOUNT TO THE TOTAL
11     CCC-----AREA OF ALL THE SEGMENTS SO FAR THEN
12     CCC-----CAN STOP INTEGRATING BEFORE GET TO
13     CCC-----INFINITY-----
14
15     IMPLICIT NONE
16     CHARACTER FLDIR*7
17     INTEGER I,J,XN
18     REAL*8 AREAN,CONTRIB,DIFFN,SIMP,AREATL,TOL
19     REAL*8 CONTMX,SUMARG,SUMMAX,SUMMIN,OOAT,SOC
20     REAL HIGH,LOW,HIMAX,HIMIN,APR,TAH,PSI,CONCL
21     REAL HOA,HOR,ROR,CPH,INTSIZE,LOWEST,X,TEMPK
22     REAL*8 WCALC,VOO,VOT,VTT
23     DIMENSION APR(2),PSI(2),TAH(2:4)
24     DIMENSION X(250),VOO(250),VOT(250),VTT(250)
25
26     CCCCC XN=COUNTER FOR TRACKING POSITION IN ARRAYS IN
27     CCCCC SUBROUTINE SI FOR ENTIRE INTERVAL OF
28     CCCCC INTEGRAL
29     CCCCC I=FIRST PARTICLE TYPE OF INTERACTION
30     CCCCC J=OTHER PARTICLE TYPE OF INTERACTION
31     CCCCC HIGH=HIGH VALUE OF LIMITS OF INTEGRATION OF
32     CCCCC CURRENT SEGMENT
33     CCCCC LOW=LOW VALUE OF LIMITS OF INTEGRATION OF
34     CCCCC CURRENT SEGMENT
35     CCCCC INTSIZE=INTERVAL SIZE FOR EACH SEGMENT
36     CCCCC LOWEST=LOWEST VALUE OF LOW VALUE OF LIMITS OF
37     CCCCC INTEGRATION
38     CCCCC =MINIMUM SEPARATION DISTANCE
39     CCCCC TOL=TOLERANCE FOR A DIFFERENCE IN TOTAL AREA
40     CCCCC UPON ADDITION OF AREA OF CURRENT SEGMENT
41     CCCCC AT WHICH MAY RETURN A VALUE FOR COMPLETE
42     CCCCC INTERVAL IF PASSED MIMIN
43     CCCCC HIMIN=MINIMUM VALUE OF INTEGRATION LIMITS
44     CCCCC BEFORE A VALUE FOR COMPLETE INTEGRAL MAY
45     CCCCC BE RETURNED IF TOLERANCE IS MET
46     CCCCC HIMAX=MAXIMUM VALUE OF INTEGRATION LIMITS AT

```

Line# Source Line

```

41 CCCCC WHICH TIME THE PRESENT VALUE FOR THE
42 CCCCC COMPLETE INTEGRAL WILL BE RETURNED EVEN
43 CCCCC IF TOLERANCE HAS NOT BEEN MET SO THAT
44 CCCCC THE PROGRAM DOES NOT RUN FOREVER OR
CCCCC CAUSE A MATH OVERFLOW ERROR AND PROGRAM
CCCCC TERMINATION
45 CCCCC SUMMAX=MAXIMUM POSITIVE VALUE FOR A REAL
46 CCCCC VARIABLE BEFORE A MATH OVERFLOW ERROR
CCCCC OCCURS AND CAUSES PROGRAM TERMINATION
47 CCCCC SUMMARG=ARGUMENT USED TO CALCULATE SUMMAX
48 CCCCC SUMMIN=MINIMUM POSITIVE VALUE FOR A REAL
49 CCCCC VARIABLE BEFORE A MATHOVERFLOW ERROR
CCCCC OCCURS AND CAUSES PROGRAM TERMINATION
50 CCCCC SIMP=VALUE OF SEGMENT INTEGRAL CALCULATED BY
CCCCC SUBROUTINE SI
51 CCCCC CONTRIB=CONTRIBUTION BY AREA OF CURRENT SGMENT
CCCCC TO TOTAL AREA
52 CCCCC CONTMX=MAXIMUM CONTRIBUTION TO TOTAL AREA
53 CCCCC BEFORE A MATH OVERFLOW ERROR CAUSES
CCCCC PROGRAM TERMINATION
54 CCCCC AREATL=TOTAL AREA OF ALL PREVIOUS SEGMENTS OF
CCCCC INTEGRAL
55 CCCCC AREAN=NEW AREA WITH ADDITION OF CURRENT
CCCCC SEGMENT AREA TO AREATL
56 CCCCC DIFFN=DIFFERENCE IN AREA CONTRIBUTED TO TOTAL
57 CCCCC AREA WITH TOTAL AREA
58 CCCCC OOAT=ONE OVER AREA TOTAL
59 CCCCC SOC=SUMMAX OVER CONTRIB
60
61
62 CC-----SETTING VARIOUS INITIAL
C-----VALUES-----
63 05 XN=1
64 10 SUMARG=663.0
65 15 SUMMAX=EXP(SUMARG)
66 20 SUMMAX=SUMMAX*1.0E+20
67 25 SUMMIN=1.0/SUMMAX
68 30 HIMIN=100.0E-9
69 35 TOL=1.0E-5
70 40 HIMAX=APR(I)+APR(J)+HOA
71 45 HIGH=HOR
72 50 LOWEST=HOR
73 55 INTSIZE=1.0E-9
74
75 C-----SENDING PROGRAM PROGRESS
C-----MESSAGE TO SCREEN-----
76 60 WRITE(*,900)FLDIR,CPH,I,J
77
78 CC-----BEGIN ITERATION LOOP-----
79 65 IF (HIGH.LT.HIMAX) THEN

```

Line# Source Line

```

80 70      LOW=HIGH
81 75      HIGH=LOW+INTSIZE
82
83 CC-----CALCULATING AREA OF CURRENT
84 C-----SEGMENT-----
84 80      CALL SI(SIMP, LOW, HIGH, APR, TAH, PSI, I,
85      &      J, CONCL, HOA, CPH, VOO,VOT,VTT, X,
86      &      XN, TEMPK)
86 85      CONTRIB=SIMP
87
88 CC-----CALCULATING VARIABLES TO
89 C-----PREVENT MATH OVERFLOW
90 C-----ERRORS AND PROGRAM
91 C-----TERMINATION-----
90 90      CONTMX=SUMMAX-AREATL
91 95      IF (CONTRIB.GE.1.0) THEN
92 100      SOC=SUMMAX/CONTRIB
93 105      IF (AREATL.LT.SUMMIN) THEN
94 110      OOAT=SUMMAX
95 115      ELSE
96 120      OOAT=1.0/AREATL
97 125      END IF
98 130      ELSE
99 135      SOC=1.0
100 140      OOAT=0.0
101 145      END IF
102
103 CC-----CALCULATING AREAN AND
104 C-----PREVENTING MATH OVERFLOW
105 C-----ERRORS AND PROGRAM
106 C-----TERMINATION-----
105 150      IF (LOW.EQ.LOWEST) THEN
106 155      AREAN=CONTRIB
107 160      AREATL=AREAN*2
108 165      ELSE IF (CONTRIB.GE.CONTMX) THEN
109 170      AREAN=SUMMAX
110 175      ELSE
111 180      AREAN=AREATL+CONTRIB
112 185      END IF
113
114 CC-----CALCULATING DIFFN AND
115 C-----PREVENTING MATH OVERFLOW
116 C-----ERRORS AND PROGRAM
117 C-----TERMINATION-----
116 190      IF (AREATL.EQ.0.0) THEN
117 195      DIFFN=0.0
118 200      ELSE IF (AREAN.EQ.SUMMAX) THEN
119 205      DIFFN=0.0
120 210      ELSE IF (OOAT .GE. SOC) THEN
121 215      DIFFN=0.0

```

Line# Source Line

```

122 220      ELSE
123 225          DIFFN=(ABS((AREATL-AREAN)/AREATL))
124 230      END IF
125
126 CC-----RETURNING AREA VALUE IF
127 C-----DIFFERENCE BETWEEN
128 C-----SUCCESSIVE ITERATIONS IS
C-----WITHIN TOLERANCE AND
C-----SEPERATION IS MORE THAN
C-----MINIMUM-----
129 235      IF (DIFFN.LT.TOL .AND. HIGH.GE.HIMIN) THEN
130 240          ROR=HOA+((APR(I)+APR(J))/1.0E+9)
131 245          WCALC=ROR*AREAN
132 250          RETURN
133 C-----RESETTING AREATL IF NOT-----
134 255      ELSE
135 260          AREATL=AREAN
136 265          IF (AREATL.LT.SUMMIN) AREATL=SUMMIN
137 270      END IF
138
139 CC-----RETURNING AREA VALUE SINCE
140 C-----UPPER INTEGRATION LIMIT IS
C-----TOO LARGE-----
141 275      ELSE IF(HIGH.GE.HIMAX) THEN
142 280          WRITE(*,*) ' '
143 285          WRITE(*,*) 'WHILE INTEGRATING INTERACTION'
144 290          WRITE(*,*) 'BETWEEN PARTICLES',I,J
145 295          WRITE(*,*) 'UPPER INTEGRATION LIMIT',
&              'EXCEEDED', HIMAX,'nm'
146 300          ROR=HOA+((APR(I)+APR(J))/1.0E+9)
147 305          WCALC=AREAN*ROR
148 310          RETURN
149 315      END IF
150
151 CC-----SINCE DIFFERENCE IS NOT
152 C-----WITHIN TOLERANCE THEN
C-----PREPARE FOR ANOTHER
C-----ITERATION-----
153 C-----INCREASING INTSIZE AS
C-----SEPARATION INCREASES-----
154 320      IF(HIGH.GT.5.0E-9 .AND. HIGH.LE.25.0E-9) THEN
155 325          INTSIZE=2.5E-9
156 330      ELSE IF(HIGH.GT.25.0E-9 .AND.
&              HIGH.LE.85.0E-9) THEN
157 335          INTSIZE=5.0E-9
158 340      ELSE IF(HIGH.GT.85.0E-9 .AND.
&              HIGH.LE.170.0E-9) THEN
159 345          INTSIZE=10.0E-9
160 350      ELSE IF(HIGH.GT.170.0E-9 .AND.

```



Line# Source Line

```

      & HIGH.LE.500.0E-9) THEN
161 355      INTSIZE=100.0E-9
162 360      ELSE IF(HIGH.GT.500.0E-9) THEN
163 365      INTSIZE=1000.0E-9
164 370      END IF
165 375      GOTO 65
166
167 CCC-----MESSAGE REPORTING CURRENT
168 CC-----FILE, CURRENT INTERACTIONS
169 CC-----BEING CALCULATED AND THAT
      CC-----THE COMPUTER IS RUNNING A
      CC-----LONG PROGRAM-----
170 900      FORMAT(/,/ ,/,/,/,/,/,/,/,11X, 58('C')/,
171          & 11X,'C',4X,'This computer is currently',
          & 26X,'C'/,
172          & 11X,'C',4X,'running a program',35X,'C'/,
173          & 11X,'C',4X,'which has many lengthy',30X,'C'/,
174          & 11X,'C',4X,'calculations.',39X,'C'/,
175          & 11X,'C',56X,'C'/,
176          & 11X,'C',4X,'PLEASE DO NOT INTERRUPT THE',
          & 'PROGRAM!!',16X,'C'/,
177          & 11X,'C',56X,'C'/,
178          & 11X,'C',4X,'If there is a problem',
          & 'contact',23X,'C'/,
179          & 11X,'C',4X,5X,'Brett Wilson: Office',
          & 'A234',22X,'C'/,
180          & 11X,'C',56X,'C'/,
181          & 11X,58('C')/,
182          & 11X,'C',28X,A7,21X,'C'/,
183          & 11X,'C',28X,'CURRENT PH: ',F5.2,11X,'C'/,
184          & 11X,'C',28X,'INTERACTIONS BETWEEN: ',
          & I1,',',I1,3X,'C'/,
185          & 11X,58('C')/,/,/,/,/,/,/)
186
187
188
189
190 CCC-----RETURNING TO CACLUL
      CC-----SUBPROGRAM-----
191 999      END

```

## WC Local Symbols

Name	Class	Type	Size	Offset
TEMPK . . . . .	param			0006
FLDIR . . . . .	param			000a
X . . . . .	param			000e
VTT . . . . .	param			0012

## WC Local Symbols

Name	Class	Type	Size	Offset
VOT . . . . .	param			0016
VOO . . . . .	param			001a
CPH . . . . .	param			001e
HOR . . . . .	param			0022
HOA . . . . .	param			0026
CONCL . . . . .	param			002a
J . . . . .	param			002e
I . . . . .	param			0032
PSI . . . . .	param			0036
TAH . . . . .	param			003a
APR . . . . .	param			003e
WCALC . . . . .	param			0042
SUMARG. . . . .	local	REAL*8	8	0002
CONTRIB . . . . .	local	REAL*8	8	000a
SUMMIN. . . . .	local	REAL*8	8	0012
CONTMX. . . . .	local	REAL*8	8	001a
SUMMAX. . . . .	local	REAL*8	8	0022
LOWEST. . . . .	local	REAL*4	4	002a
HIGH. . . . .	local	REAL*4	4	002e
SOC . . . . .	local	REAL*8	8	0032
INTSIZE . . . . .	local	REAL*4	4	003a
XN. . . . .	local	INTEGER*4	4	003e
DIFFN . . . . .	local	REAL*8	8	0042
AREAN . . . . .	local	REAL*8	8	004a
TOL . . . . .	local	REAL*8	8	0052
LOW . . . . .	local	REAL*4	4	005a
ROR . . . . .	local	REAL*4	4	005e
OOAT. . . . .	local	REAL*8	8	0062
HIMIN . . . . .	local	REAL*4	4	006a
HIMAX . . . . .	local	REAL*4	4	006e
AREATL. . . . .	local	REAL*8	8	0072
SIMP. . . . .	local	REAL*8	8	007a

## Global Symbols

Name	Class	Type	Size	Offset
SI. . . . .	extern	***	***	***
WC. . . . .	FSUBRT	***	***	0000

Code size = 0643 (1603)

Data size = 00dd (221)

Bss size = 0082 (130)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE SI(SIMP, A, B, APR, TAH, PSI, I, J,
2      & CONCL, HOA, CPH, VOO,VOT,VTT, X, XN, TEMPK)
3
4      CCCCC REV. 05-04-92
5
6      CCC-----SUBPROGRAM TO INTEGRATE A GIVEN SEGMENT
7      C-----OF AN INTEGRAL USING SIMPSON'S RULE-
8
9      IMPLICIT NONE
10     INTEGER I,J,L,NSECTS,NMAX,XN,VN
11     REAL A, B, DX, APR, TAH, PSI, HOA, SEP, CPH,
12     REAL CONCL, X, XV, TEMPK
13     REAL*8 ODDS,EVENS,DIFFT,FA,FB,AREAO,CONTMX
14     REAL*8 AREAN,DIFFN,VFCN,WFCN,SUMARG,SUMMAX
15     REAL*8 SIMP,V,VOO,VOT,VTT
16     DIMENSION APR(2),PSI(2),X(250)
17     DIMENSION VOO(250),VOT(250),VTT(250)
18     DIMENSION V(140),XV(140),TAH(2:4)
19
20     CCCCC NSECTS=NUMBER OF SECTIONS INTERVALL TO BE
21     CCCCC DIVIDED INTO
22     CCCCC DIFFT=TOLERABLE DIFFERENCE BETWEEN SUCCESSIVE
23     CCCCC ITERATIONS
24     CCCCC NMAX=MAXIMUM NUMBER OF SECTIONS TO BE TAKEN
25     CCCCC A=LOWER LIMIT OF INTEGRATION
26     CCCCC B=UPPER LIMIT OF INTEGRATION
27     CCCCC WFCN=STABILITY CALCULATED BY SUBROUTINE WVFCN
28     CCCCC VFCN=POTENTIAL CALCULATED BY SUBROUTINE WVFCN
29     CCCCC FA=FUNCTION VALUE AT A
30     CCCCC FB=FUNCTION VALUE AT B
31     CCCCC DX=WIDTH OF SECTIONS
32     CCCCC ODDS=SUM OF FUCTION VALUES AT ODD SECTIONS
33     CCCCC EVENS=SUM OF FUCTION VALUES AT EVEN SECTIONS
34     CCCCC AREAO=AREA CALCULATED IN PREVIOUS ITERATION
35     CCCCC AREAN=AREA CALCULATED IN PRESENT ITERATION
36     CCCCC DIFFN=DIFFERENCE BETWEEN PRESENT AND PREVIOUS
37     CCCCC ITERATION
38     CCCCC CONTMX=MAXIMUM CONTRIBUTION TO TOTAL AREA
39     CCCCC BEFORE A MATH OVERFLOW ERROR CAUSES
40     CCCCC PROGRAM TERMINATION
41     CCCCC SUMMAX=MAXIMUM POSITVE VALUE FOR A REAL
42     CCCCC VARIABLE BEFORE A MATH OVERFLOW ERROR
43     CCCCC OCCURS AND CAUSES PROGRAM TERMINATION
44     CCCCC SUMMARG=ARGUMENT USED TO CALCULATE SUMMAX
45     CCCCC SUMMIN=MINIMUM POSITVE VALUE FOR A REAL
46     CCCCC VARIABLE BEFORE A MATH OVERFLOW ERROR
47     CCCCC OCCURS AND CAUSES PROGRAM TERMINATION
48     CCCCC V=INTERPARTICLE POTENTIAL AT A COORESPONDING

```

Line# Source Line

```

      CCCCC DISTANCE XV (ARRAY)
41 CCCCC XV=INTERPARTICLE SEPARATION DISTANCE (ARRAY)
42 CCCCC VN=COUNTER FOR TRACKING POSITION IN V AND XV
      CCCCC ARRAYS
43 CCCCC XN=COUNTER FOR SAVING V AND XV IN VOO,VOT,VTT
      CCCCC AND X ARRAYS
44
45
46 CC-----INITIALIZE AREA0 TO ZERO-----
47 05      AREA0=0.0
48
49 CC-----SET DIFF,NSECTS,& NMAX
      C-----VALUES-----
50 10      DIFFT = 0.0001
51 15      NSECTS=64
52 20      NMAX=2.0E+6
53 25      SUMARG=663.0
54 30      SUMMAX=EXP(SUMARG)
55 35      SUMMAX=SUMMAX*1.0E+20
56
57 CC-----EVALUATE FUNCTION AT UPPER &
      C-----LOWER BOUND-----
58 40      CALL WVFCN(WFCN, VFCN, A, APR, TAH, PSI, I, J,
      &          CONCL, HOA, TEMPK)
59 45      FA=WFCN
60 50      XV(1)=A
61 55      V(1)=VFCN
62 60      CALL WVFCN(WFCN, VFCN, B, APR, TAH, PSI, I, J,
      &          CONCL, HOA, TEMPK)
63 65      FB=WFCN
64 70      XV(130)=B
65 75      V(130)=VFCN
66
67 CC-----BEGIN ITERATION LOOP-----
68 80      IF (NSECTS .LE. NMAX) THEN
69
70 CC-----CALCULATE WIDTH OF SECTIONS-
71 85      DX = (B-A)/REAL(NSECTS)
72
73 CC-----RE-INITIALIZE ODDS & EVENS
      C-----TO ZERO-----
74 90      ODDS = 0.0
75 95      EVENS = 0.0
76 100     VN=1
77
78 CC-----CALCULATING SUM OF ALL ODD
      C-----FUNCTION VALUES-----
79 105     DO 170 L=1,NSECTS-1,2
80 110     SEP = A+(L*DX)
81 115     CALL WVFCN(WFCN, VFCN, SEP, APR, TAH, PSI,

```

Line# Source Line

```

      & I, J, CONCL, HOA, TEMPK)
82 120 CONTMX=SUMMAX-ODDS
83 125 IF (WFCN.GE.CONTMX) THEN
84 130 ODDS=SUMMAX
85 135 ELSE
86 140 ODDS=ODDS + WFCN
87 145 END IF
88 150 IF(NSECTS.EQ.128) THEN
89 155 XV(VN+L)=SEP
90 160 V(VN+L)=VFCN
91 165 END IF
92 170 CONTINUE
93
94 CC-----CALCULATING SUM OF ALL EVEN
   C-----FUNCTION VALUES-----
95 175 DO 240 L=2,NSECTS-2,2
96 180 SEP = A+(L*DX)
97 185 CALL WVFCN(WFCN, VFCN, SEP, APR, TAH, PSI,
      & I, J, CONCL, HOA, TEMPK)
98 190 CONTMX=SUMMAX-EVENS
99 195 IF(WFCN.GE.CONTMX) THEN
100 200 EVENS=SUMMAX
101 205 ELSE
102 210 EVENS=EVENS + WFCN
103 215 END IF
104 220 IF(NSECTS.EQ.128) THEN
105 225 XV(VN+L)=SEP
106 230 V(VN+L)=VFCN
107 235 END IF
108 240 CONTINUE
109
110 CC-----SAVING V DATA FOR WRITING TO
   C-----FILE-----
111 245 IF (NSECTS.EQ.128 .AND. B.LT.300.0E-9) THEN
112 C-----FOR INTERACTION OF PARTICLE
   C-----ONE WITH ONE-----
113 250 IF (I+J.EQ.2) THEN
114 255 VOO(XN)=V(1)
115 260 X(XN)=XV(1)
116 265 XN=XN+1
117 270 DO 290 L=20,100,20
118 275 VOO(XN)=V(L)
119 280 X(XN)=XV(L)
120 285 XN=XN+1
121 290 CONTINUE
122 295 VOO(XN)=V(130)
123 300 X(XN)=XV(130)
124 305 XN=XN+1
125 C-----FOR INTERACTION OF PARTICLE
   C-----ONE WITH TWO-----

```

Line# Source Line

```

126 310      ELSE IF (I+J.EQ.3) THEN
127 315          VOT(XN)=V(1)
128 320          XN=XN+1
129 325          DO 340 L=20,100,20
130 330              VOT(XN)=V(L)
131 335              XN=XN+1
132 340          CONTINUE
133 345          VOT(XN)=V(130)
134 350          XN=XN+1
135 C-----FOR INTERACTION OF PARTICLE
136 C-----TWO WITH TWO-----
136 355      ELSE IF (I+J.EQ.4) THEN
137 360          VTT(XN)=V(1)
138 365          XN=XN+1
139 370          DO 385 L=20,100,20
140 375              VTT(XN)=V(L)
141 380              XN=XN+1
142 385          CONTINUE
143 390          VTT(XN)=V(130)
144 395          XN=XN+1
145 400      END IF
146 405      END IF
147
148 CC-----ADDING ALL FUNCTION VALUES
149 C-----THIS TO FIND AREA OF
150 C-----ITERATION-----
150 410      IF (ODDS.GE.SUMMAX .OR.
      &          EVENS.GE.SUMMAX) THEN
151 415          AREAN=SUMMAX
152 420      ELSE
153 425          AREAN = (DX/3.0)*
      &          (FA+FB+4.0*ODDS+2.0*EVENS)
154 430      END IF
155
156 CC-----RETURNING AREA VALUE IF
157 C-----DIFFERENCE BETWEEN
158 C-----SUCCESSIVE ITERATIONS IS
159 C-----TOLERABLE-----
158 435      IF (AREAN.EQ.0.0) THEN
159 440          DIFFN=0.0
160 445      ELSE
161 450          DIFFN = ABS( (AREAN-AREAO) / AREAN)
162 455      END IF
163 460      IF (DIFFN.LT.DIFFT) THEN
164 465          SIMP = AREAN
165 470          RETURN
166
167 CC-----SINCE DIFFERENCE IS NOT
168 C-----WITHIN TOLERANCE THEN
169 C-----PREPARE FOR ANOTHER

```

## Line# Source Line

```

C-----ITERATION-----
169 475      ELSE
170 480      AREA0 = AREAN
171 485      NSECTS = NSECTS*2
172 490      ENDIF
173 495      GOTO 80
174
175 CC-----RETURNING AREA VALUE SINCE
C-----NSECTS TOO LARGE-----
176 500      ELSE
177 505      SIMP=AREAN
178 510      WRITE(*,*) 'NSECTS TOO LARGE IN SIMPSONS',
&          'INTEGRATION,'
179 515      WRITE(*,*) 'RETURNING AREA(LOW,HIGH) FOR',
&          'PH:'
180 520      WRITE(*,*) '(',A,',',',',B,')',',FOR:',CPH
181 525      PAUSE
182 530      ENDIF
183
184 CCC-----RETURNING TO WCALC
C-----SUBPROGRAM-----
185 998      RETURN
186 999      END

```

## SI Local Symbols

Name	Class	Type	Size	Offset
TEMPK . . . . .	param			0006
XN. . . . .	param			000a
X . . . . .	param			000e
VTT . . . . .	param			0012
VOT . . . . .	param			0016
VOO . . . . .	param			001a
CPH . . . . .	param			001e
HOA . . . . .	param			0022
CONCL . . . . .	param			0026
J . . . . .	param			002a
I . . . . .	param			002e
PSI . . . . .	param			0032
TAH . . . . .	param			0036
APR . . . . .	param			003a
B . . . . .	param			003e
A . . . . .	param			0042
SIMP. . . . .	param			0046
V . . . . .	local	REAL*8	1120	0000
EVENS . . . . .	local	REAL*8	8	0002
FA. . . . .	local	REAL*8	8	000a
FB. . . . .	local	REAL*8	8	0012

## SI Local Symbols

Name	Class	Type	Size	Offset
L . . . . .	local	INTEGER*4	4	001a
SUMARG. . . . .	local	REAL*8	8	001e
NSECTS. . . . .	local	INTEGER*4	4	0026
CONTMX. . . . .	local	REAL*8	8	002a
SUMMAX. . . . .	local	REAL*8	8	0032
DX. . . . .	local	REAL*4	4	003a
VN. . . . .	local	INTEGER*4	4	003e
DIFFN . . . . .	local	REAL*8	8	0042
AREAN . . . . .	local	REAL*8	8	004a
AREAO . . . . .	local	REAL*8	8	0052
SEP . . . . .	local	REAL*4	4	005a
ODDS. . . . .	local	REAL*8	8	005e
VFCN. . . . .	local	REAL*8	8	0066
DIFFT . . . . .	local	REAL*8	8	006e
WFCN. . . . .	local	REAL*8	8	0076
NMAX. . . . .	local	INTEGER*4	4	007e
XV. . . . .	local	REAL*4	560	0460

## Global Symbols

Name	Class	Type	Size	Offset
SI. . . . .	FSUBRT	***	***	0000
WVFCN . . . . .	extern	***	***	***

Code size = 0a5e (2654)

Data size = 00a7 (167)

Bss size = 0082 (130)

No errors detected



## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE WVFCN(WFCN, VFCN, SSEP, APR, TAH,
2      & PSI, I, J, CONCL, HOA, TEMPK)
3
4      CCCCC REV. 05-04-92
5
6      CCC-----EVALUATING THE FCN.S W AND V
7      CC-----AT GIVEN SEPERATIONS-----
8
9      IMPLICIT NONE
10     INTEGER I,J
11     REAL EC, BOC, SSEP, PIE, CONCL, CONCM, NA
12     REAL APRM, DIEL, PSEP
13     REAL APR,TAH,PSI,HOA,RSEP,RSEPSD,TEMPK
14     REAL*8 EARGMX,EARGMN,EXARG,EXAMAX,X,Y
15     REAL*8 TTWKT,TTH,FR,FV,KAP
16     REAL*8 DIELM,DIELV,EXW,WFCN,VFCN
17     REAL*8 TTWN,TTWNKT,TTWD,SI,SE,VRKT,FRE,FVNE
18     REAL*8 TTHN,TTHD,FRN,FRD,FVN,VTKT
19     REAL*8 VAKT,VANKT,VAD,KAPN,KAPD,KAPS
20     DIMENSION APR(2),PSI(2),APRM(2),TAH(2:4)
21
22     CCCCC EC=ELECTRON CHARGE (COUL)
23     CCCCC PIE=NUMERIC VALUE OF PIE (UNITLESS)
24     CCCCC DIELM=RELATIVE DIELECTRIC CONSTANT OF MEDIUM
25     CCCCC      (@25 C)(DIMENSIONLESS)
26     CCCCC DIELV=DIELECTRIC CONSTANT OF VACUUM (C^2/JM)
27     CCCCC DIEL=DIELECTRIC CONSTANT OF MEDIUM (C^2/JM)
28     CCCCC BOC=BOLTZMAN CONSTANT (J/ATOM K)
29     CCCCC NA=AVAGADRO'S CONSTANT (ATOMS/MOLE)
30     CCCCC CONCL=CONCENTRATION OF ELECTROLYTE (MOLE/L)
31     CCCCC CONCM=CONCENTRATION OF ELECTROLYTE (MOLE/M^3)
32     CCCCC APR=ATOMIC PARTICLE RADIUS (NM)
33     CCCCC APRM=ATOMIC PARTICLE RADIUS (M)
34     CCCCC SSEP=SEPERATION DISTANCE [BETWEEN STERN
35     CCCCC      SURFACES] (M)
36     CCCCC PSEP=SEPERATION DISTANCE [BETWEEN PARTICLE
37     CCCCC      SURFACES] (M)
38     CCCCC RSEP=SEPERATION DISTANCE [BETWEEN CENTERS] (M)
39     CCCCC RSEPSD=RSEP SQUARED (M^2)
40     CCCCC TAH=TOTAL HAMAKER CONSTANT (J)
41     CCCCC HOA=MINIMUM SURFACE SEPERATION FOR VAN DER
42     CCCCC      WAALS ATTRACTION (M)
43     CCCCC HOR=MINIMUM SURFACE SEPERATION FOR REPULSION
44     CCCCC      (M)
45     CCCCC VTKT=TOTAL INTERACTION POTENTIAL IN UNITS
46     CCCCC      OF KT
47     CCCCC VAKT=ATTRACTION INTERACTION POTENTIAL IN UNITS
48     CCCCC      OF KT
49     CCCCC VRKT=REPULSION INTERACTION POTENTIAL IN UNITS

```

Line# Source Line

```

      OF KT
40  CCCCC KAP=KAPPA THE DEBYE-HUCKEL PARAMETER (1/M)
41  CCCCC X,Y,VAN,VAD=VARIABLES USED TO BREAK DOWN
42  CCCC      EQUATION FOR THE ATTRACTION
43  CCCC      INTERACTION POTENTIAL SO IT MAY BE
      CCCC      SOLVED IN FORTRAN CODE WITH
      CCCC      LIMITED LINE LENGTH
44  CCCCC TTWKT,TTWNKT,TTWN,TTWD,TTH,TTHN,TTHD,FR,FRN
45  CCCC & FRD,FRE,FV,FVN, SI,SE,KAP,KAPN,KAPD,KAPS
      CCC      = VARIABLES USED TO BREAK DOWN
46  CCC      LARGE EQUATION FOR THE REPULSION
47  CCC      INTERACTION POTENTIAL SO IT MAY
48  CCC      BE SOLVED IN FORTRAN CODE WITH
49  CCC      LIMITED LINE LENGTH
50
51
52  CC-----INITIALIZING THE CONSTANTS-
53  10      CONCM = CONCL*1.0E+3
54  20      EC = 1.602E-19
55  30      NA = 6.02E+23
56  40      PIE = 3.1416
57  50      DIELM = 78.54
58  60      DIELV = 8.8542E-12
59  70      DIEL = DIELM*DIELV
60  80      BOC = 1.381E-23
61  90      APRM(I) = APR(I)/1.0E+9
62  100     APRM(J) = APR(J)/1.0E+9
63  110     PSEP=SSEP+HOA
64  120     EARGMX=709.0
65  130     EARGMN=-745.0
66
67  CC-----EVALUATING FCN. BY BREAKING
68  C-----INTO SMALLER TERMS &
      C-----RECOMBING THEM-----
69
70  CC-----CALCULATING VA-----
71  140     X=PSEP/(APRM(I)+APRM(J))
72  150     Y=APRM(I)/APRM(J)
73  160     VANKT=0.0-(TAH(I+J)/(12.0*BOC*TEMPK))
74  170     VAD=(Y/(X**2+(X*Y)+X))+(Y/(X**2+(X*Y)+X+Y))
75  180     VAD=VAD+(2.0*LOG(X**2+(X*Y)+X) /
      &                                     (X**2+(X*Y)+X+Y))
76  190     VAKT=VANKT*VAD
77
78  CC-----CALCULATING VR TERMS-----
79  200     TTWN=PIE*DIEL*APRM(I)*APRM(J) *
      &                                     (PSI(I)**2+PSI(J)**2)
80  210     TTWNKT=TTWN/(BOC*TEMPK)
81  220     TTWD=(APRM(I)+APRM(J))
82  230     TTWKT=TTWNKT/TTWD

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Line# Source Line

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83
84 240 IF (PSI(1).EQ.0.0 .OR. PSI(2).EQ.0.0) THEN
85 250     TTH = 0.0
86 260 ELSE
87 270     TTHN = 2*PSI(I)*PSI(J)
88 280     TTHD = PSI(I)**2+PSI(J)**2
89 290     TTH = TTHN/TTHD
90 300 END IF
91
92 310 KAPN = 2.0*CONCM*EC**2*NA
93 320 KAPD = DIEL*BOC*TEMPK
94 330 KAPS = KAPN/KAPD
95 340 KAP = SQRT(KAPS)
96
97 350 FRE = 0.0 -(KAP*SSEP)
98 360 IF (FRE.LT.EARGMN) THEN
99 370     FRE=EARGMN
100 C-----PREVENTING MATH OVERFLOW
100 C-----ERROR-----
101 380 ELSE IF (FRE.LT.1.0E-4 .AND.
      &                                     FRE.GT.-1.0E-4) THEN
102 390     IF (FRE.GE.0.0) THEN
103 400         FRE=1.0E-4
104 410     ELSE
105 420         FRE=-1.0E-4
106 430     END IF
107 440 END IF
108 450 FRN = 1.0 + EXP(FRE)
109 460 FRD = 1.0 - EXP(FRE)
110 470 FR = LOG(FRN/FRD)
111
112 480 FVNE =(0.0-(2.0*KAP*SSEP))
113 490 IF (FVNE.LT.EARGMN) THEN
114 500     FVNE=EARGMN
115 C-----PREVENTING MATH OVERFLOW
115 C-----ERROR-----
116 510 ELSE IF (FVNE.GT.-1.0E-16) THEN
117 520     FVNE=-1.0E-16
118 530 END IF
119 540 FVN = 1.0 - EXP(FVNE)
120 550 FV = LOG(FVN)
121
122 560 SI=TTH*FR
123
124 570 SE=SI+FV
125
126 CC-----RECOMBINING TERMS TO
126 C-----CALCULATE VR-----
127 580 VRKT=TTWKT*SE
128

```

## Line# Source Line

```

129 CC-----CALCULATING VT FROM VA & VR-
130 590   VTKT = VAKT+VRKT
131 600   VFCN=VTKT
132
133
134 CC-----CALCULATING VT OVER KT AND
135 C-----PREVENTING MATH OVERFLOW
136 C-----ERRORS-----
137 610   IF (VTKT.GT.EARGMX) THEN
138 620     EXW=EARGMX
139 630   ELSE IF (VTKT.LT.EARGMN) THEN
140 640     EXW=EARGMN
141 650   ELSE
142 660     EXW=VTKT
143 670   END IF
144 680   EXARG=EXP (EXW)
145
146 CC-----CALCULATING WFCN-----
147 690   RSEP = PSEP+APRM(I)+APRM(J)
148 700   RSEPSD=RSEP**2
149 710   EXAMAX=EXP (EARGMX) *RSEPSD
150 720   IF (EXARG.GT.EXAMAX) THEN
151 730     WFCN=EXP (EARGMX)
152 740   ELSE
153 750     WFCN=EXP (EXW) /RSEPSD
154 760   END IF
155
156 CC-----RETURNING FUNCTION TO
157 C-----SUBPROGRAM-----
158 998   RETURN
159 999   END

```

## WVFCN Local Symbols

Name	Class	Type	Size	Offset
TEMPK . . . . .	param			0006
HOA . . . . .	param			000a
CONCL . . . . .	param			000e
J . . . . .	param			0012
I . . . . .	param			0016
PSI . . . . .	param			001a
TAH . . . . .	param			001e
APR . . . . .	param			0022
SSEP. . . . .	param			0026
VFCN. . . . .	param			002a
WFCN. . . . .	param			002e

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## WVFCN Local Symbols

Name	Class	Type	Size	Offset
TTWD. . . . .	local	REAL*8	8	0000
VANKT . . . . .	local	REAL*8	8	0008
EXAMAX. . . . .	local	REAL*8	8	0010
EARGMX. . . . .	local	REAL*8	8	0018
VRKT. . . . .	local	REAL*8	8	0020
EC. . . . .	local	REAL*4	4	0028
VTKT. . . . .	local	REAL*8	8	002c
TTWN. . . . .	local	REAL*8	8	0034
NA. . . . .	local	REAL*4	4	003c
RSEPSD. . . . .	local	REAL*4	4	0040
BOC . . . . .	local	REAL*4	4	0044
SE. . . . .	local	REAL*8	8	0048
FR. . . . .	local	REAL*8	8	0050
X . . . . .	local	REAL*8	8	0058
Y . . . . .	local	REAL*8	8	0060
VAD . . . . .	local	REAL*8	8	0068
FRD . . . . .	local	REAL*8	8	0070
SI. . . . .	local	REAL*8	8	0078
KAP . . . . .	local	REAL*8	8	0080
FV. . . . .	local	REAL*8	8	0088
FRE . . . . .	local	REAL*8	8	0090
TTWK T . . . . .	local	REAL*8	8	0098
DIEL. . . . .	local	REAL*4	4	00a0
PIE . . . . .	local	REAL*4	4	00a4
KAPD. . . . .	local	REAL*8	8	00a8
FRN . . . . .	local	REAL*8	8	00b0
KAPN. . . . .	local	REAL*8	8	00b8
FVN . . . . .	local	REAL*8	8	00c0
DIELM . . . . .	local	REAL*8	8	00c8
TTWNKT. . . . .	local	REAL*8	8	00d0
KAPS. . . . .	local	REAL*8	8	00d8
FVNE. . . . .	local	REAL*8	8	00e0
TTH . . . . .	local	REAL*8	8	00e8
APRM. . . . .	local	REAL*4	8	00f0
CONCM . . . . .	local	REAL*4	4	00f8
TTHD. . . . .	local	REAL*8	8	00fc
EXW . . . . .	local	REAL*8	8	0104
DIELV . . . . .	local	REAL*8	8	010c
VAKT. . . . .	local	REAL*8	8	0114
EXARG . . . . .	local	REAL*8	8	011c
PSEP. . . . .	local	REAL*4	4	0124
EARGMN. . . . .	local	REAL*8	8	0128
RSEP. . . . .	local	REAL*4	4	0130
TTHN. . . . .	local	REAL*8	8	0134

## Global Symbols

Name	Class	Type	Size	Offset
WVFCN . . . . .	FSUBRT	***	***	0000

Code size = 086e (2158)

Data size = 0074 (116)

Bss size = 013c (316)

No errors detected



## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE WVFCN(WFCN, VFCN, SSEP, APR, TAH,
      & PSI, I, J, CONCL, HOA, TEMPK)
2
3      CCCCC-----CONSTANT CHARGE CALCULATIONS-----
4
5      CCCCC REV. 05-04-92
6
7      CCC-----EVALUATING THE FCN.S W AND V
8      CC-----AT GIVEN SEPERATIONS-----
9
10     IMPLICIT NONE
11     INTEGER I,J
12     REAL EC, BOC, SSEP, PIE, CONCL, CONCM, NA
13     REAL APRM, DIEL, PSEP
14     REAL APR,TAH,PSI,HOA,RSEP,RSEPSD,TEMPI
15     REAL*8 EARGMX,EARGMN,EXARG,EXAMAX,X,Y
16     REAL*8 TTWKT,TTH,FR,FV,KAP
17     REAL*8 DIELM,DIELV,EXW,WFCN,VFCN
18     REAL*8 TTWN,TTWNKT,TTWD,SI,SE,VRKT,FRE,FVNE
19     REAL*8 TTHN,TTHD,FRN,FRD,FVN,VTKT
20     REAL*8 VAKT,VANKT,VAD,KAPN,KAPD,KAPS
21     DIMENSION APR(2),PSI(2),APRM(2),TAH(2:4)
22
23     CCCCC EC=ELECTRON CHARGE (COUL)
24     CCCCC PIE=NUMERIC VALUE OF PIE (UNITLESS)
25     CCCCC DIELM=RELATIVE DIELECTRIC CONSTANT OF MEDIUM
26     CCCCC      (@25 C)(DIMENSIONLESS)
27     CCCCC DIELV=DIELECTRIC CONSTANT OF VACUUM (C^2/JM)
28     CCCCC DIEL=DIELECTRIC CONSTANT OF MEDIUM (C^2/JM)
29     CCCCC BOC=BOLTZMAN CONSTANT (J/ATOM K)
30     CCCCC NA=AVAGADRO'S CONSTANT (ATOMS/MOLE)
31     CCCCC CONCL=CONCENTRATION OF ELECTROLYTE (MOLE/L)
32     CCCCC CONCM=CONCENTRATION OF ELECTROLYTE (MOLE/M^3)
33     CCCCC APR=ATOMIC PARTICLE RADIUS (NM)
34     CCCCC APRM=ATOMIC PARTICLE RADIUS (M)
35     CCCCC SSEP=SEPERATION DISTANCE [BETWEEN STERN
36     CCCCC      SURFACES] (M)
37     CCCCC PSEP=SEPERATION DISTANCE [BETWEEN PARTICLE
38     CCCCC      SURFACES] (M)
39     CCCCC RSEP=SEPERATION DISTANCE [BETWEEN CENTERS] (M)
40     CCCCC RSEPSD=RSEP SQUARED (M^2)
41     CCCCC TAH=TOTAL HAMAKER CONSTANT (J)
42     CCCCC HOA=MINIMUM SURFACE SEPERATION FOR VAN DER
43     CCCCC      WAALS ATTRACTION (M)
44     CCCCC HOR=MINIMUM SURFACE SEPERATION FOR REPULSION
45     CCCCC      (M)
46     CCCCC VTKT=TOTAL INTERACTION POTENTIAL IN UNITS
47     CCCCC      OF KT
48     CCCCC VAKT=ATTRACTION INTERACTION POTENTIAL IN UNITS

```

Line# Source Line

```

      OF KT
39  CCCCC VRKT=REPULSION INTERACTION POTENTIAL IN UNITS
      OF KT
40  CCCCC KAP=KAPPA THE DEBYE-HUCKEL PARAMETER (1/M)
41  CCCCC X,Y,VAN,VAD=VARIABLES USED TO BREAK DOWN
42  CCCC      EQUATION FOR THE ATTRACTION
43  CCCC      INTERACTION POTENTIAL SO IT MAY BE
      CCCC      SOLVED IN FORTRAN CODE WITH
      CCCC      LIMITED LINE LENGTH
44  CCCCC TTWKT,TTWNKT,TTWN,TTWD,TTH,TTHN,TTHD,FR,FRN
45  CCCC & FRD,FRE,FV,FVN, SI,SE,KAP,KAPN,KAPD,KAPS
      CCC      = VARIABLES USED TO BREAK DOWN
46  CCC      LARGE EQUATION FOR THE REPULSION
47  CCC      INTERACTION POTENTIAL SO IT MAY
48  CCC      BE SOLVED IN FORTRAN CODE WITH
49  CCC      LIMITED LINE LENGTH
50
51
52  CC-----INITIALIZING THE CONSTANTS-
53  10      CONCM = CONCL*1.0E+3
54  20      EC = 1.602E-19
55  30      NA = 6.02E+23
56  40      PIE = 3.1416
57  50      DIELM = 78.54
58  60      DIELV = 8.8542E-12
59  70      DIEL = DIELM*DIELV
60  80      BOC = 1.381E-23
61  90      APRM(I) = APR(I)/1.0E+9
62  100     APRM(J) = APR(J)/1.0E+9
63  110     PSEP=SSEP+HOA
64  120     EARGMX=709.0
65  130     EARGMN=-745.0
66
67  CC-----EVALUATING FCN. BY BREAKING
68  C-----INTO SMALLER TERMS &
      C-----RECOMBINING THEM-----
69
70  CC-----CALCULATING VA-----
71  140     X=PSEP/(APRM(I)+APRM(J))
72  150     Y=APRM(I)/APRM(J)
73  160     VANKT=0.0-(TAH(I+J)/(12.0*BOC*TEMPK))
74  170     VAD=(Y/(X**2+(X*Y)+X))+(Y/(X**2+(X*Y)+X+Y))
75  180     VAD=VAD+(2.0*LOG(X**2+(X*Y)+X)/
      &      (X**2+(X*Y)+X+Y))
76  190     VAKT=VANKT*VAD
77
78  CC-----CALCULATING VR TERMS-----
79  200     TTWN=PIE*DIEL*APRM(I)*APRM(J) *
      &      (PSI(I)**2+PSI(J)**2)
80  210     TTWNKT=TTWN/(BOC*TEMPK)

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Line# Source Line

```

81 220 TTWD=(APRM(I)+APRM(J))
82 230 TTWKT=TTWNKT/TTWD
83
84 240 IF (PSI(1).EQ.0.0 .OR. PSI(2).EQ.0.0) THEN
85 250     TTH = 0.0
86 260 ELSE
87 270     TTHN = 2*PSI(I)*PSI(J)
88 280     TTHD = PSI(I)**2+PSI(J)**2
89 290     TTH = TTHN/TTHD
90 300 END IF
91
92 310 KAPN = 2.0*CONCM*EC**2*NA
93 320 KAPD = DIEL*BOC*TEMPK
94 330 KAPS = KAPN/KAPD
95 340 KAP = SQRT(KAPS)
96
97 350 FRE = 0.0 -(KAP*SSEP)
98 360 IF (FRE.LT.EARGMN) THEN
99 370     FRE=EARGMN
100 C-----PREVENTING MATH OVERFLOW
100 C-----ERROR-----
101 380 ELSE IF (FRE.LT.1.0E-4 .AND.
      &                                     FRE.GT.-1.0E-4) THEN
102 390     IF (FRE.GE.0.0) THEN
103 400         FRE=1.0E-4
104 410     ELSE
105 420         FRE=-1.0E-4
106 430     END IF
107 440 END IF
108 450 FRN = 1.0 + EXP(FRE)
109 460 FRD = 1.0 - EXP(FRE)
110 470 FR = LOG(FRN/FRD)
111
112 480 FVNE =(0.0-(2.0*KAP*SSEP))
113 490 IF (FVNE.LT.EARGMN) THEN
114 500     FVNE=EARGMN
115 C-----PREVENTING MATH OVERFLOW
115 C-----ERROR-----
116 510 ELSE IF (FVNE.GT.-1.0E-16) THEN
117 520     FVNE=-1.0E-16
118 530 END IF
119 540 FVN = 1.0 - EXP(FVNE)
120 550 FV = LOG(FVN)
121
122 560 SI=TTH*FR
123
124 570 SE=SI-FV
125
126 CC-----RECOMBINING TERMS TO
126 C----- CALCULATE VR-----

```

## Line# Source Line

```

127 580 VRKT=TTWKT*SE
128
129 CC-----CALCULATING VT FROM VA & VR-
130 590 VTKT = VAKT+VRKT
131 600 VFCN=VTKT
132
133
134 CC-----CALCULATING VT OVER KT AND
135 C-----PREVENTING MATH OVERFLOW
C-----ERRORS-----
136 610 IF (VTKT.GT.EARGMX) THEN
137 620 EXW=EARGMX
138 630 ELSE IF (VTKT.LT.EARGMN) THEN
139 640 EXW=EARGMN
140 650 ELSE
141 660 EXW=VTKT
142 670 END IF
143 680 EXARG=EXP(EXW)
144
145 CC-----CALCULATING WFCN-----
146 690 RSEP = PSEP+APRM(I)+APRM(J)
147 700 RSEPSD=RSEP**2
148 710 EXAMAX=EXP(EARGMX)*RSEPSD
149 720 IF (EXARG.GT.EXAMAX) THEN
150 730 WFCN=EXP(EARGMX)
151 740 ELSE
152 750 WFCN=EXP(EXW)/RSEPSD
153 760 END IF
154
155 CC-----RETURNING FUNCTION TO
C-----SUBPROGRAM-----
156 998 RETURN
157 999 END

```

## WVFCN Local Symbols

Name	Class	Type	Size	Offset
TEMPK . . . . .	param			0006
HOA . . . . .	param			000a
CONCL . . . . .	param			000e
J . . . . .	param			0012
I . . . . .	param			0016
PSI . . . . .	param			001a
TAH . . . . .	param			001e
APR . . . . .	param			0022
SSEP. . . . .	param			0026
VFCN. . . . .	param			002a
WFCN. . . . .	param			002e

## WVFCN Local Symbols

Name	Class	Type	Size	Offset
TTWD. . . . .	local	REAL*8	8	0000
VANKT . . . . .	local	REAL*8	8	0008
EXAMAX. . . . .	local	REAL*8	8	0010
EARGMX. . . . .	local	REAL*8	8	0018
VRKT. . . . .	local	REAL*8	8	0020
EC. . . . .	local	REAL*4	4	0028
VTKT. . . . .	local	REAL*8	8	002c
TTWN. . . . .	local	REAL*8	8	0034
NA. . . . .	local	REAL*4	4	003c
RSEPSD. . . . .	local	REAL*4	4	0040
BOC . . . . .	local	REAL*4	4	0044
SE. . . . .	local	REAL*8	8	0048
FR. . . . .	local	REAL*8	8	0050
X . . . . .	local	REAL*8	8	0058
Y . . . . .	local	REAL*8	8	0060
VAD . . . . .	local	REAL*8	8	0068
FRD . . . . .	local	REAL*8	8	0070
SI. . . . .	local	REAL*8	8	0078
KAP . . . . .	local	REAL*8	8	0080
FV. . . . .	local	REAL*8	8	0088
FRE . . . . .	local	REAL*8	8	0090
TTWKTT . . . . .	local	REAL*8	8	0098
DIEL. . . . .	local	REAL*4	4	00a0
PIE . . . . .	local	REAL*4	4	00a4
KAPD. . . . .	local	REAL*8	8	00a8
FRN . . . . .	local	REAL*8	8	00b0
KAPN. . . . .	local	REAL*8	8	00b8
FVN . . . . .	local	REAL*8	8	00c0
DIELM . . . . .	local	REAL*8	8	00c8
TTWNKT. . . . .	local	REAL*8	8	00d0
KAPS. . . . .	local	REAL*8	8	00d8
FVNE. . . . .	local	REAL*8	8	00e0
TTH . . . . .	local	REAL*8	8	00e8
APRM. . . . .	local	REAL*4	8	00f0
CONCM . . . . .	local	REAL*4	4	00f8
TTHD. . . . .	local	REAL*8	8	00fc
EXW . . . . .	local	REAL*8	8	0104
DIELV . . . . .	local	REAL*8	8	010c
VAKT. . . . .	local	REAL*8	8	0114
EXARG . . . . .	local	REAL*8	8	011c
PSEP. . . . .	local	REAL*4	4	0124
EARGMN. . . . .	local	REAL*8	8	0128
RSEP. . . . .	local	REAL*4	4	0130
TTHN. . . . .	local	REAL*8	8	0134

**Global Symbols**

Name	Class	Type	Size	Offset
WVFCN . . . . .	FSUBRT	***	***	0000

Code size = 086e (2158)

Data size = 0074 (116)

Bss size = 013c (316)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1      SUBROUTINE DATA STORAGE(V, APR, ZPQ, AHM, AHP,
2      & PHCZI, NZP1, NZP2, ZPPH1, ZPDP1, ZPPH2,
3      & ZPDP2, WT, PH, CONCL, WOO, WOT, WTT, CDATE,
4      & STIME, FTIME, TEMP)
5      CCCCC REV. 06-22-92
6
7      CCC-----SUBPROGRAM TO STORE INPUT &
8      CC-----CALCULATED DATA-----
9
10     IMPLICIT NONE
11     CHARACTER IFLNM*17,FLDSC*100,ZPQ*1,FLNME*20
12     CHARACTER FLXT*4,TEMPC*34,AHMC*33,CONCC*42
13     CHARACTER APRC*35,PHCZIC*28,RICS*16,AHPC*33
14     CHARACTER TFLNME*34
15     INTEGER K,L,NZP1,NZP2
16     INTEGER*2 CDATE,STIME,FTIME
17     DIMENSION CDATE(3),STIME(4),FTIME(4)
18     REAL PH,APR,PHCZI,AHP,AHM,ZPPH1,ZPDP1,CONCL
19     REAL ZPPH2,ZPDP2,TEMP,V
20     REAL*8 WT,WOO,WOT,WTT,WMAX
21     DIMENSION WT(200),PH(200),APR(2),AHP(2),
22     DIMENSION PHCZI(2), ZPPH1(200),ZPDP1(200)
23     DIMENSION ZPPH2(200), ZPDP2(200)
24     DIMENSION WOO(200),WOT(200),WTT(200)
25
26     CCCCC IFLNM=INPUT FILE NAME FOR DATA STORAGE
27     CCCCC FLXT=FILE EXTENSION FOR DATA STORAGE FILE
28     CCCCC FLNME=COMPLETE FILE NAME (I.E. FILE NAME &
29     CCCCC EXTENSION)
30     CCCCC TFLNME=TOTAL FILE NAME FOR DATA STORAGE
31     CCCCC (INCLUDES DIRECTORY)
32     CCCCC FLDSC=DESCRIPTION OF FILE
33     CCCCC WMAX=MAXIMUM W VALUE ALLOWABLE FOR PLOTTING
34     CCCCC PROGRAMS
35
36     CCC-----ASSIGNING CHARACTER
37     CC-----VARIABLES-----
38
39     05     APRC = 'ATOMIC PARTICLE RADIUS OF COMPONENT'
40     10     PHCZIC = 'POINT-OF-ZERO-CHARGE OF COMPONENT'
41     15     RICS = 'VALUE(S) INPUT : '
42     20     AHPC = 'HAMAKER CONSTANT OF COMPONENT'
43     25     AHMC = 'HAMAKER CONSTANT OF MEDIUM ='
44     30     CONCC = 'CONCENTRATION OF 1-1 ELECTROLYTE IN'
45     & 'SYSTEM'
46     35     TEMPC = 'TEMPERATURE OF SYSTEM (IN DEG. C.)'
47
48     CCC-----COLLECTING A FILE NAME AND

```

Line#	Source Line
40	C-----SYSTEM DESCRIPTION FOR THE
	C-----DATA FILE TO STORE
	C-----INFORMATION IN-----
41	40 READ(14,800)FLDSC
42	45 READ(14,810)IFLNM
43	50 TFLNME(1:14)='C:\JK\LL\DATA\'
44	
45	CCC-----WRITING DATA TO A PRINTABLE
	CC-----DATA FILE-----
46	55 FLXT = '.PDF'
47	60 FLNME(1:16)=IFLNM(2:17)
48	65 FLNME(17:20)=FLXT(1:4)
49	70 TFLNME(15:34)=FLNME(1:20)
50	75 OPEN(4,FILE=TFLNME,STATUS='UNKNOWN')
51	80 WRITE(4,875)
52	85 WRITE(4,880)
53	90 WRITE(4,885)
54	95 WRITE(4,890)FLNME,FLDSC
55	100 WRITE(4,895)CDATE(2),CDATE(3),CDATE(1)
56	105 WRITE(4,900)STIME(1),STIME(2),STIME(3),
	& STIME(4)
57	110 WRITE(4,905)FTIME(1),FTIME(2),FTIME(3),
	& FTIME(4)
58	115 WRITE(4,910)V,CONCC,CONCL,APRC,APR(1),
	& APRC,APR(2)
59	120 WRITE(4,915)TEMPC,TEMP
60	125 WRITE(4,930)AHMC,AHM,AHPC,AHP(1),AHPC,AHP(2)
61	130 IF (ZPQ.EQ.'P')THEN
62	135 WRITE(4,920)
63	140 WRITE(4,925)PHCZIC,PHCZI(1),PHCZIC,
	& PHCZI(2)
64	145 ELSE
65	150 WRITE(4,935)
66	155 WRITE(4,940)1
67	160 DO 170 K=1,NZP1,1
68	165 WRITE(4,945)ZPDP1(K),ZPPH1(K)
69	170 CONTINUE
70	175 WRITE(4,940)2
71	180 DO 190 K=1,NZP2,1
72	185 WRITE(4,945)ZPDP2(K),ZPPH2(K)
73	190 CONTINUE
74	195 END IF
75	200 WRITE(4,955)
76	205 DO 225 K=1,200,1
77	210 IF (PH(K).NE.0.0) THEN
78	215 WRITE(4,960)WOO(K),WOT(K),
	& WTT(K),WT(K),PH(K)
79	220 END IF
80	225 CONTINUE
81	230 CLOSE(4)



Line#	Source Line
82	
83	CCC-----WRITING DATA TO DATA FILE
	CC-----FOR PLOTTING-----
84	
85	CC-----WRITING DATA FILE WITH ALL W
	C-----VALUES-----
86	235 FLXT = '.DAT'
87	240 TFLNME(31:34)=FLXT
88	245 OPEN(3,FILE=TFLNME,STATUS='UNKNOWN')
89	250 WRITE(3,850)FLNME,FLDSC
90	255 DO 275 L=1,200,1
91	260 IF (PH(L).NE.0.0)THEN
92	265 WRITE(3,860)PH(L),WOO(L),WOT(L),WTT(L),
	& WT(L)
93	270 END IF
94	275 CONTINUE
95	280 CLOSE(3)
96	
97	CC-----WRITING DATA TO FILE WITH
98	C-----ALL W VALUES WITH A
	C-----MAXIMUM OF WMAX-----
99	285 FLXT=' .DAM'
100	290 TFLNME(31:34)=FLXT
101	295 OPEN(3,FILE=TFLNME,STATUS='UNKNOWN')
102	300 WRITE(3,850)FLNME,FLDSC
103	305 WMAX=9.9999E+30
104	310 DO 350 L=1,200,1
105	315 IF (PH(L).NE.0.0)THEN
106	320 IF(WOO(L).GT.WMAX)WOO(L)=WMAX
107	325 IF(WOT(L).GT.WMAX)WOT(L)=WMAX
108	330 IF(WTT(L).GT.WMAX)WTT(L)=WMAX
109	335 IF(WT(L).GT.WMAX)WT(L)=WMAX
110	340 WRITE(3,860)PH(L),WOO(L),WOT(L),WTT(L),
	& WT(L)
111	345 END IF
112	350 CONTINUE
113	355 CLOSE(3)
114	
115	
116	CC-----WRITING DATA FILE WITH ONLY
	C-----WT VALUES-----
117	360 FLXT=' .DWT'
118	365 TFLNME(31:34)=FLXT
119	370 OPEN(3,FILE=TFLNME,STATUS='UNKNOWN')
120	375 WRITE(3,850)FLNME,FLDSC
121	380 DO 400 L=1,200,1
122	385 IF (PH(L).NE.0.0)THEN
123	390 WRITE(3,860)PH(L),WT(L)
124	395 END IF
125	400 CONTINUE

Line#	Source Line
126	405 CLOSE(3)
127	
128	CC-----WRITING DATA FILE WITH ONLY
129	C-----WT VALUES WITH A MAXIMUM
	C-----OF WMAX-----
130	410 FLXT = '.DWM'
131	415 TFLNME(31:34)=FLXT
132	420 OPEN(3,FILE=TFLNME,STATUS='UNKNOWN')
133	425 WRITE(3,850)FLNME,FLDSC
134	430 DO 455 L=1,200,1
135	435 IF (PH(L).NE.0.0) THEN
136	440 IF (WT(L).GT.WMAX) WT(L)=WMAX
137	445 WRITE(3,860)PH(L),WT(L)
138	450 END IF
139	455 CONTINUE
140	460 CLOSE(3)
141	
142	CCC-----FORMATTING READ STATEMENTS--
143	800 FORMAT(A70)
144	810 FORMAT(A17)
145	
146	CCC-----FORMATTING WRITE STATEMENTS--
147	850 FORMAT(1X,A70)
148	855 FORMAT(1X,24(/),
149	& 1X,'TYPE IN A NAME FOR A FILE TO STORE DATA',
	& 'IN.'/,
150	& 1X,'(MUST BE 8 CHARACTERS IN LENGTH WITH NO',
	& 'SPACES.)',15(/))
151	860 FORMAT(1X,F5.2,1X,',',1X,E12.4,1X,',',1X,
	& E12.4,1X,',',1X,
152	& E12.4, 1X,',',1X,E12.4)
153	865 FORMAT(1X,24(/),
154	& 1X,'DO YOU WANT A PRINTED COPY OF DATA?(Y',
	& 'or N)',15(/))
155	870 FORMAT(1X,24(/),
156	& 1X,'READY PRINTER FOR PRINTING.'/,
157	& 1X,'WHEN PRINTER IS READY FOR PRINTING',
	& 'TYPE: "Y"'/,
158	& 1X,'IF PRINTER IS IN-OPERABLE TYPE:',
	& '"N"',13(/))
159	C-----FORMATTING TITLE BLOCK-----
160	875 FORMAT(/,/,/,/,/,/,/,/,11X, 58('C')/,
161	& 11X,'C',40X,'Rev. 06-22-92',3X,'C'/,
162	& 11X,'C',4X,'MASTERS THESIS RESEARCH',
	& 29X,'C'/,
163	& 11X,'C',4X,'BRETT A. WILSON',37X,'C'/,
164	& 11X,'C',4X,'MICHIGAN STATE UNIVERSITY',
	& 27X,'C'/,
165	& 11X,'C',4X,'COLLEGE OF ENGINEERING',30X,'C'/,
166	& 11X,'C',4X,'DEPARTMENT OF METALLURGY',,

Line# Source Line

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      & 'MECHANICS, ',16X,'C'//,
167      & 11X,'C',4X,5X,'AND MATERIAL SCIENCE',
      & 27X,'C'//,
168      & 11X,'C',56X,'C'//,
169      & 11X,58('C'),/,/,/,/,/,/,/)
170 C-----FORMATTING PROGRAM
      C-----DESCRIPTION-----
171 880  FORMAT(/,/,11X,58('C')//,
172      & 11X,'C',56X,'C'//,
173      & 11X,'C',4X,'THIS PROGRAM USES MEASURABLE',
      & 'MATERIAL DATA TO',
174      & 7X,'C'//,
175      & 11X,'C',4X,'CREATE INFORMATION WHICH SHOULD',
      & 'PREDICT THE',9X,'C'//
176      & 11X,'C',4X,'FLOCCULATION STATE OF TWO',
      & 'COMPONENT COLLOIDAL',
177      & 7X,'C'//,
178      & 11X,'C',4X,'SUSPENSIONS.',40X,'C'//,
179      & 11X,'C',56X,'C'//,
180      & 11X,'C',4X,'THE PROGRAM RELIES ON A METHOD',
      & 'WHICH IS A MOD-',
181      & 6X,'C'//,
182      & 11X,'C',4X,'IFICATION OF THE H.H.F. METHOD,',
      & 'WHICH IS BASED ON',
183      & 3X,'C'//,
184      & 11X,'C',4X,'THE DEBYE-HUCKEL APPROXIMATION',
      & 'FOR THE REPULSION',
185      & 4X,'C'//,
186      & 11X,'C',4X,'BETWEEN TWO PLATES OF CONSTANT',
      & 'POTENTIAL.',11X,'C'//,
187      & 11X,'C',56X,'C')
188 885  FORMAT(11X,'C',4X,'MODIFICATIONS INCLUDE:',
      & 30X,'C'//,
# 189      & 11X,'C',5X,'-USING AN EFFECTIVE HAMAKER',
      & 'CONSTANT FOR TWO',7X,'C'
190      & 11X,'C',6X,'PARTICLES IN A DISPERSING',
      & 'MEDIUM.',18X,'C'//,
191      & 11X,'C',5X,'-USING ZETA POTENTIAL DATA',
      & 'INSTEAD OF CALCULAT-',
192      & 4X,'C'//,
# 193      & 11X,'C',6X,'ING THE SURFACE POTNTIAL FROM',
      & 'POINT-OF-ZERO-',6X,'C'
194      & 11X,'C',6X,'CHARGE DATA.',38X,'C'//,
195      & 11X,'C',56X,'C'//,
196      & 11X,58('C'),/)
197 890  FORMAT(1X,'FILE NAME:',A12/,
198      & 1X,'FILE DESCRIPTION:',/,
199      & 1X,A70)
200 895  FORMAT(1X,'THIS DATA WAS AQUIRED ON:',
201      & 1X,I2.2,'/',I2.2,'/',I4.4)

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Line#	Source	Line
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202 900      FORMAT(1X,'AQUISITION BY THE PROGRAM STARTED',
      & 'AT...',
203      & 1X,I2.2,':',I2.2,':',I2.2,':',I2.2)
204 905      FORMAT(1X,21X,'AND FINISHED AT...',
205      & 1X,I2.2,':',I2.2,':',I2.2,':',I2.2)
206 910      FORMAT(1X,'OVERALL PROPORTION OF COMPONENT 1',
      & 'IN SYSTEM =',
207      & F4.3/,
208      & 1X,A42,1X,'=',1X,F7.5/,
209      & 1X,A35,1X,'1',1X,'=',1X,F7.1/,
210      & 1X,A35,1X,'2',1X,'=',1X,F7.1)
211 915      FORMAT(1X,A34,1X,'=',1X,F4.1)
212 920      FORMAT(1X,'ZERO-POINT-OF-CHARGE DATA WAS',
      & 'USED',
213      & ' FOR CALCULATIONS.')
214 925      FORMAT(1X,A33,1X,'1',1X,'=',1X,F5.2/,
215      & 1X,A33,1X,'2',1X,'=',1X,F5.2)
216 930      FORMAT(1X,A28,1X,E10.2/,
217      & 1X,A29,1X,'1 =',1X,E10.2/,
218      & 1X,A29,1X,'2 =',1X,E10.2)
219 935      FORMAT(1X,'ZETA POTENTIAL DATA WAS USED FOR',
220      & ' CALCULATIONS.')
221 940      FORMAT(1X,'ZETA POTENTIAL DATA FOR PARTICLE',
      & 1X,I1,':',
222      & 1X,'ZETA POTENTIAL VALUES:',10X,
      & 'CORESPONDING PH VALUES:')
223 945      FORMAT(23X,F5.1,29X,F5.1)
224 950      FORMAT(1X,'CALCULATED OVERALL STABILITY',
      & 'RATIO DATA:',
225      & 1X,'OVERALL STABILITY RATIO:',28X,
      & 'CORESPONDING PH',/,
226      & 1X'(W11,W12,W22,WT)',44X,'VALUES:')
227 955      FORMAT(1X,/,/,/,/,/,/,/,/, 'CALCULATED OVERALL',
      & 'STABILITY RATIO',
228      & 1X,'DATA:',/,
229      & 1X,'OVERALL STABILITY RATIO:',28X,
      & 'CORESPONDING PH',/,
230      & 1X'(W11,W12,W22,WT)',44X,'VALUES:')
231 960      FORMAT(1X,E12.4,',',E12.4,',',E12.4,',',
      & E12.4,8X,F5.2)
232
233      CCC-----RETURNING TO MAIN PROGRAM-----
234 998      RETURN
235 999      END

```

## DATASTORAGE Local Symbols

Name	Class	Type	Size	Offset
TEMP. . . . .	param			0006
FTIME . . . . .	param			000a
STIME . . . . .	param			000e
CDATE . . . . .	param			0012
WTT . . . . .	param			0016
WOT . . . . .	param			001a
WOO . . . . .	param			001e
CONCL . . . . .	param			0022
PH. . . . .	param			0026
WT. . . . .	param			002a
ZPDP2 . . . . .	param			002e
ZPPH2 . . . . .	param			0032
ZPDP1 . . . . .	param			0036
ZPPH1 . . . . .	param			003a
NZP2. . . . .	param			003e
NZP1. . . . .	param			0042
PHCZI . . . . .	param			0046
AHP . . . . .	param			004a
AHM . . . . .	param			004e
ZPQ . . . . .	param			0052
APR . . . . .	param			0056
V . . . . .	param			005a
PHCZIC. . . . .	local	CHAR*28	28	0002
TFILME. . . . .	local	CHAR*34	34	001e
K . . . . .	local	INTEGER*4	4	0040
L . . . . .	local	INTEGER*4	4	0044
AHMC. . . . .	local	CHAR*33	33	0048
AHPC. . . . .	local	CHAR*33	33	006a
CONCC . . . . .	local	CHAR*42	42	008c
APRC. . . . .	local	CHAR*35	35	00b6
FLDSC . . . . .	local	CHAR*100	100	00da
RI CS. . . . .	local	CHAR*16	16	013e
FLNME . . . . .	local	CHAR*20	20	014e
IFLNM . . . . .	local	CHAR*17	17	0162
TEMPC . . . . .	local	CHAR*34	34	0174
WMAX. . . . .	local	REAL*8	8	0196
FLXT. . . . .	local	CHAR*4	4	019e

## Global Symbols

Name	Class	Type	Size	Offset
DATASTORAGE . . . . .	FSUBRT	***	***	0000

Code size = 0c65 (3173)

Data size = 0311 (785)

Bss size = 01a2 (418)

No errors detected

## Microsoft FORTRAN Optimizing Compiler Version 5.00.03

Line# Source Line

```

1          PROGRAM VARYN
2
3  CCCCC REV. 07-07-92
4
5  CCC-----PROGRAM TO CALCULATE OVERALL STABILITY
6  C-----RATIO FOR VARYING VALUES OF V USING
7  C-----DATA FROM PROGRAM RUNS WITH V=0.5----
8
9          IMPLICIT NONE
10         CHARACTER NDIRNAME*7,NWFLNAME*34,TNFLNAME*34
11         CHARACTER A*70,B*70,PSC*1
12         INTEGER L,K,NFLS,I,J
13         REAL*8 WT,WOO,WOT,WTT,OOWT,WTN,AZP,AZN,AZ,WMAX
14
15         REAL N,PH,V,PR,OON,PRC
16         DIMENSION PH(200),WT(200),WTN(5),V(5)
17         DIMENSION N(5),PR(2),PRC(2)
18         DIMENSION WOO(200),WOT(200),WTT(200)
19
20 CCCCC N=OVERALL PROPORTION OF PARTICLES OF COMPONENT
21 CCCCC ONE IN SYSTEM
22 CCCCC V=VOLUME PERCENT OF COMPONENT ONE IN SYSTEM
23 CCCCC WT=OVERALL STABILTY RATIO
24 CCCCC OOWT=ONE OVER WT
25 CCCCC WOO,WOT,WTT=INVERSE OF THE PROBABILITY THAT A
26 CCCCC GIVEN PARTICLE COLLISION LEADS TO
27 CCCCC ADHESION
28 CCCCC NFLS=NUMBER OF FILES TO RUN PROGRAM ON
29 CCCCC NDIRNAME=NEW DIRECTORY NAME WHERE WILL FIND
30 CCCCC DATA FILE
31 CCCCC NWFLNAME=NEW FILE NAME
32 CCCCC TNFLNAME=TOTAL NEW FILE NAME INCLUDING DRIVE
33 CCCCC AND PATH
34 CCCCC K=INTEGER VARIABLE USED AS A COUNTER FOR DO
35 CCCCC LOOP WHICH CALCULATES OVERALL STABILITY AT
36 CCCCC EACH SPECIFIED PH
37 CCCCC L,I,J=INTEGERS USED AS COUNTER FOR VARIOUS DO
38 CCCCC LOOPS
39 CCCCC AZ=VARIABLE REPRESENTING ALMOST ZERO
40 CCCCC =(1.0E-309)
41 CCCCC AZP=POSITIVE VALUE OF AZ USED TO PREVENT AN
42 CCCCC INVERSE FROM GOING TO INFINITY WHICH
43 CCCCC CAUSES A MATH OVERFLOW ERROR RESULTING IN
44 CCCCC PROGRAM TERMINATION
45 CCCCC AZN=NEGATIVE VALUE OF AZ USED AS AZP IS
46 CCCCC PR=PARTICLE RADIUS
47 CCCCC PRC=PARTICLE RADIUS CUBED
48 CCCCC OON=ONE OVER N

```

Line# Source Line

```

39  CCCCC PSC=PARTICLE SIZE CHARACTER WHICH INDICATES
    CCCCC      PARTICLE SIZE
40  CCCCC WTN=NEW WT VALUES CALCULATED FOR DIFFERENT
    CCCCC      VALUES OF N (OR V)
41  CCCCC WMAX=MAXIMUM W VALUE ALLOWED BY PLOTTING
    CCCCC      PROGRAM
42
43
44  CC-----CALCULATING VALUES FOR
    C-----AZP,AZN-----
45  10      AZ = 1.0E-25
46  20      DO 40 K=1,11,1
47  30      AZ = AZ/1.0E+25
48  40      CONTINUE
49  50      AZP = AZ/1.E9
50  60      AZN = -1.0*AZP
51  70      WMAX=9.9999E+30
52
53  CC-----INITIALIZING DRIVE AND PATH
    C-----FOR TNFLNAME-----
54  80      TNFLNAME(1:14) = 'C:\JK\LL\DATA\'
55  90      TNFLNAME(22:23) = '\B'
56  100     TNFLNAME(31:34) = '.DAT'
57
58  CC-----INITIALIZING VALUES OF V FOR
    C-----CALCULATIONS-----
59  110     V(1) = 0.001
60  120     V(2) = 0.25
61  130     V(3) = 0.5
62  140     V(4) = 0.75
63  150     V(5) = 0.999
64
65  CC-----READING DATA FILE WITH LIST
    C-----OF FILES-----
66  160     OPEN(14,FILE='C:\JK\LL\DATA\FILELST',
        &                                     STATUS='OLD')
67  170     READ(14,800)NFLS
68
69
70  CC-----RUNNING CALCULATIONS FOR
    C-----EACH FILE-----
71  180     DO 670 I=1,NFLS,1
72
73  C-----READING NEW DIRECTORY NAME--
74  190     READ(14,810)NDIRNAME
75  200     TNFLNAME(15:21) = NDIRNAME
76  210     TNFLNAME(24:30) = NDIRNAME
77  220     NWFLNAME = TNFLNAME
78  230     NWFLNAME(20:21)='VN'
79  235     NWFLNAME(29:30)='VN'

```

Line# Source Line

```

80
81 C-----DETERMINING PARTICLE SIZE
82 C-----FROM DIRECTORY NAME-----
82 240 PSC = NDIRNAME(4:4)
83 250 PR(2) = 250
84 260 IF(PSC.EQ.'1')PR(1)=2750
85 270 IF(PSC.EQ.'2')PR(1)=900
86 280 IF(PSC.EQ.'3')PR(1)=400
87 290 PRC(1) = PR(1)**3
88 300 PRC(2) = PR(2)**3
89
90 C-----READING DATA FROM N=0.5 DATA
91 310 OPEN(15,FILE=TNFLNAME,STATUS='OLD')
92 320 READ(15,820)A
93 330 READ(15,820)B
94 340 OPEN(16,FILE=NWFLNAME,STATUS='NEW')
95 350 NWFLNAME(31:34)=' .DAM'
96 360 OPEN(17,FILE=NWFLNAME,STATUS='NEW')
97 370 WRITE(16,900)A,B
98 380 DO 630 K=1,15,1
99 390 READ(15,830)PH(K),WOO(K),WOT(K),WTT(K)
100
101 C-----CALCULATING N VALUES FROM V
102 C-----VALUES-----
102 400 DO 570 L=1,5,1
103 410 OON = ((PRC(1))-(V(L)*PRC(1))) /
      & (V(L)*PRC(2))
104 420 OON = OON + 1.00
105 430 N(L) = 1.00/(OON)
106
107 CC-----FINDING THE OVERALL
108 C-----STABILITY RATIO AT CURRENT
109 C-----PH-----
109 C-----PREVENTING MATH OVERFLOW
110 C-----ERRORS AND PROGRAM
110 C-----TERMINATION-----
111 440 IF(WOO(K).LE.AZP .AND.
      & WOO(K).GE.AZN) THEN
112 450 WT(K)=WOO(K)
113 460 ELSE IF(WOT(K).LE.AZP .AND.
      & WOT(K).GE.AZN) THEN
114 470 WT(K)=WOT(K)
115 480 ELSE IF(WTT(K).LE.AZP .AND.
      & WTT(K).GE.AZN) THEN
116 490 WT(K)=WTT(K)
117 500 ELSE
118 510 OOWT = (N(L)*N(L)/WOO(K))
119 520 OOWT=OOWT+
      & ((1.0-N(L))*(1.0-N(L))/WTT(K))
120 530 OOWT=OOWT+

```



## Line# Source Line

```

      &                                (2.0*N(L)*(1.0-N(L))/WOT(K))
121  540      WT(K)=1.0/OOWT
122  550      END IF
123  560      WTN(L) = WT(K)
124  570      CONTINUE
125
126  CCC-----WRITING NEW DATA TO A
      CC-----STORAGE FILE-----
127  580      WRITE(16,910) PH(K),WTN(1),WTN(2),WTN(3),
      &                                WTN(4),WTN(5)
128  590      DO 610 J=1,5,1
129  600      IF(WTN(J).GT.WMAX) WTN(J)=WMAX
130  610      CONTINUE
131  620      WRITE(17,910) PH(K),WTN(1),WTN(2),WTN(3),
      &                                WTN(4),WTN(5)
132  630      CONTINUE
133  640      CLOSE(17)
134  650      CLOSE(16)
135  660      CLOSE(15)
136  670      CONTINUE
137  680      CLOSE(14)
138
139  800      FORMAT(I2)
140  810      FORMAT(A7)
141  820      FORMAT(A70)
142  830      FORMAT(1X,F5.2,3X,E12.4,3X,E12.4,3X,E12.4)
143
144  900      FORMAT(1X,A70,/,1X,A70)
145  910      FORMAT(1X,F5.2,',',E12.4,',',E12.4,',',
146      & E12.4,',',E12.4,',',E12.4)
147
148  999      END

```

## main Local Symbols

Name	Class	Type	Size	Offset
PH. . . . .	local	REAL*4	800	0000
A . . . . .	local	CHAR*70	70	0002
B . . . . .	local	CHAR*70	70	0048
OOWT. . . . .	local	REAL*8	8	008e
I . . . . .	local	INTEGER*4	4	0096
J . . . . .	local	INTEGER*4	4	009a
K . . . . .	local	INTEGER*4	4	009e
L . . . . .	local	INTEGER*4	4	00a2
N . . . . .	local	REAL*4	20	00a6
NDIRNAME. . . . .	local	CHAR*7	7	00ba
TNFLNAME. . . . .	local	CHAR*34	34	00c2
V . . . . .	local	REAL*4	20	00e4

## main Local Symbols

Name	Class	Type	Size	Offset
NWFLNAME. . . . .	local	CHAR*34	34	00f8
AZ. . . . .	local	REAL*8	8	011a
PR. . . . .	local	REAL*4	8	0122
PRC . . . . .	local	REAL*4	8	012a
PSC . . . . .	local	CHAR*1	1	0132
AZN . . . . .	local	REAL*8	8	0134
AZP . . . . .	local	REAL*8	8	013c
OON . . . . .	local	REAL*4	4	0144
NFLS. . . . .	local	INTEGER*4	4	0148
WTN . . . . .	local	REAL*8	40	014c
WMAX. . . . .	local	REAL*8	8	0174
WT. . . . .	local	REAL*8	1600	0320
WOO . . . . .	local	REAL*8	1600	0960
WOT . . . . .	local	REAL*8	1600	0fa0
WTT . . . . .	local	REAL*8	1600	15e0

## Global Symbols

Name	Class	Type	Size	Offset
main. . . . .	FSUBRT	***	***	0000

Code size = 06ef (1775)

Data size = 016d (365)

Bss size = 017c (380)

No errors detected

FILE NAME:SS213SD\BSS213SD

FILE DESCRIPTION: RUN USING BMTHFWVB.EXE.

THIS DATA WAS ACQUIRED ON: 07/08/1992

AQUISITION BY THE PROGRAM STARTED AT... 00:21:33:16

AND FINISHED AT... 01:17:26:97

VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500

CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100

ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 2750.0

ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0

TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0

HAMAKER CONSTANT OF MEDIUM = .45E-19

HAMAKER CONSTANT OF COMPONENT 1 = .30E-18

HAMAKER CONSTANT OF COMPONENT 2 = .16E-18

ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.

ZETA POTENTIAL DATA FOR PARTICLE 1:

ZETA POTENTIAL VALUES:	CORRESPONDING PH VALUES:
5.8	2.0
-2.2	2.5
-15.0	3.0
-26.0	3.5
-34.0	4.0
-40.0	4.5
-44.0	5.0
-48.0	5.5
-51.0	6.0
-53.0	6.5
-54.0	7.0
-56.0	7.5
-57.0	8.0
-58.0	8.5
-59.0	9.0
-60.0	9.5
-60.0	10.0
-61.0	10.5
-61.0	11.0

ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES:	CORRESPONDING PH VALUES:
44.0	2.9
38.9	4.0
29.4	5.0
9.1	6.1
-24.0	7.1
-33.0	8.0
-43.0	9.0
-43.0	10.0
-45.0	11.0

## CALCULATED OVERALL STABILITY RATIO DATA:

## OVERALL STABILITY RATIO:

CORESPONDING PH (W11,W12,W22,WT)

## VALUES:

.1819+248,	.2738E+00,	.1105E+77,	.1825E+03	4.00
.4761+303,	.2738E+00,	.1257E+55,	.1825E+03	4.50
.4761+303,	.2738E+00,	.4842E+36,	.1825E+03	5.00
.4761+303,	.2738E+00,	.9557E+09,	.1825E+03	5.50
.4761+303,	.2738E+00,	.5053E+00,	.5047E+00	6.00
.4761+303,	.2738E+00,	.4998E+00,	.4992E+00	6.50
.4761+303,	.2738E+00,	.4468E+13,	.1825E+03	7.00
.4761+303,	.2738E+00,	.4563E+31,	.1825E+03	7.50
.4761+303,	.2738E+00,	.7460E+49,	.1825E+03	8.00
.4761+303,	.3677E-04,	.6029E+72,	.2451E-01	8.50
.4761+303,	.8836E+18,	.6955E+99,	.5889E+21	9.00
.4761+303,	.8792E+22,	.3959+101,	.5860E+25	9.50
.4761+303,	.8792E+22,	.3959+101,	.5860E+25	10.00
.4761+303,	.2195E+30,	.4755+107,	.1463E+33	10.50
.4761+303,	.1257E+35,	.8488+113,	.8378E+37	11.00

FILE NAME:SS213ES\BSS213ES  
 FILE DESCRIPTION: RUN USING BMTHFWVB.EXE.  
 THIS DATA WAS AQUIED ON: 07/08/1992  
 AQUISITION BY THE PROGRAM STARTED AT... 14:43:32:87  
 AND FINISHED AT... 16:38:15:92  
 VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500  
 CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100  
 ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 2750.0  
 ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0  
 TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0  
 HAMAKER CONSTANT OF MEDIUM = .45E-19  
 HAMAKER CONSTANT OF COMPONENT 1 = .30E-18  
 HAMAKER CONSTANT OF COMPONENT 2 = .16E-18  
 ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.  
 ZETA POTENTIAL DATA FOR PARTICLE 1:  
 ZETA POTENTIAL VALUES:      CORESPONDING PH VALUES:

-13.0	3.9
-14.0	4.0
-15.0	4.1
-16.0	4.2
-18.0	4.3
-19.0	4.4
-20.0	4.5
-21.0	4.6
-23.0	4.7
-23.0	4.8
-23.0	4.8
-25.0	4.9
-26.0	5.0
-27.0	5.1
-28.0	5.2
-28.0	5.3
-30.0	5.4
-31.0	5.6
-32.0	5.7
-33.0	5.9
-34.0	6.1
-35.0	6.2
-35.0	6.4
-36.0	6.6
-37.0	6.7
-38.0	6.9
-38.0	7.0
-39.0	7.2
-40.0	7.3
-40.0	7.4
-41.0	7.6
-41.0	7.7
-42.0	7.8
-42.0	7.9
-44.0	8.1
-45.0	8.3

-47.0	8.4
-48.0	8.6
-48.0	8.6
-48.0	8.8
-49.0	8.9
-49.0	9.0
-49.0	9.1
-50.0	9.2
-50.0	9.3
-50.0	9.4
-50.0	9.5
-51.0	9.6
-51.0	9.7
-51.0	9.8
-52.0	9.9
-52.0	10.0
-52.0	10.2
-53.0	10.3
-53.0	10.4
-54.0	10.5
-55.0	10.7
-56.0	10.8
-57.0	10.9
-59.0	11.1
-61.0	11.2

## ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES:      CORRESPONDING PH VALUES:

8.0	3.9
8.0	4.0
7.8	4.1
7.5	4.2
7.4	4.3
7.0	4.4
6.8	4.6
6.6	4.7
6.4	4.8
6.1	4.9
5.7	5.0
5.5	5.1
5.4	5.1
5.2	5.2
4.8	5.3
4.4	5.4
4.1	5.5
3.8	5.7
3.3	5.8
2.7	5.9
2.1	6.1
1.5	6.2
.8	6.3
.2	6.4
-.7	6.6

-1.5	6.7
-2.3	6.8
-2.9	6.9
-3.5	7.0
-4.0	7.2
-4.4	7.3
-4.8	7.5
-5.2	7.8
-5.3	8.0
-5.5	8.2
-5.7	8.4
-5.9	8.6
-6.0	8.7
-6.2	8.8
-6.2	8.9
-6.5	8.9
-6.5	9.0
-6.7	9.1
-6.9	9.2
-7.0	9.3
-7.1	9.4
-7.1	9.5
-7.3	9.6
-7.5	9.7
-7.5	9.8
-7.7	9.9
-7.7	9.9
-8.0	10.1
-8.0	10.2
-8.1	10.3
-8.5	10.4
-8.6	10.5
-8.9	10.6
-8.9	10.7
-9.4	10.8
-9.6	10.9
-9.7	11.0
-10.0	11.1

## CALCULATED OVERALL STABILITY RATIO DATA:

OVERALL STABILITY RATIO: (W11,W12,W22,WT)			CORESPONDING PH VALUES:	
.2269E+00,	.2738E+00,	.5009E+00,	.5003E+00	4.00
.2269E+00,	.2738E+00,	.5004E+00,	.4998E+00	4.50
.5914E+21,	.2738E+00,	.5000E+00,	.4994E+00	5.00
.7792+134,	.2738E+00,	.4997E+00,	.4991E+00	5.50
.1725+236,	.2738E+00,	.4994E+00,	.4988E+00	6.00
.4761+303,	.2738E+00,	.4993E+00,	.4987E+00	6.50
.4761+303,	.2738E+00,	.4996E+00,	.4989E+00	7.00
.4761+303,	.2738E+00,	.4998E+00,	.4992E+00	7.50
.4761+303,	.2738E+00,	.4999E+00,	.4993E+00	8.00
.4761+303,	.2738E+00,	.5000E+00,	.4994E+00	8.50
.4761+303,	.2738E+00,	.5003E+00,	.4996E+00	9.00
.4761+303,	.2738E+00,	.5005E+00,	.4999E+00	9.50
.4761+303,	.2738E+00,	.5009E+00,	.5002E+00	10.00
.4761+303,	.2738E+00,	.5014E+00,	.5008E+00	10.50
.4761+303,	.2738E+00,	.5027E+00,	.5020E+00	11.00



FILE NAME:SS213CC\BSS213CC  
 FILE DESCRIPTION: RUN USING BMTHFWVB.EXE.  
 THIS DATA WAS AQUIED ON: 07/08/1992  
 AQUISITION BY THE PROGRAM STARTED AT... 11:04:37:77  
 AND FINISHED AT... 11:51:44:57  
 VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500  
 CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100  
 ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 2750.0  
 ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0  
 TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0  
 HAMAKER CONSTANT OF MEDIUM = .45E-19  
 HAMAKER CONSTANT OF COMPONENT 1 = .30E-18  
 HAMAKER CONSTANT OF COMPONENT 2 = .16E-18  
 ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.  
 ZETA POTENTIAL DATA FOR PARTICLE 1:  
 ZETA POTENTIAL VALUES:           CORESPONDING PH VALUES:

5.8	2.0
-2.2	2.5
-15.0	3.0
-26.0	3.5
-34.0	4.0
-40.0	4.5
-44.0	5.0
-48.0	5.5
-51.0	6.0
-53.0	6.5
-54.0	7.0
-56.0	7.5
-57.0	8.0
-58.0	8.5
-59.0	9.0
-60.0	9.5
-60.0	10.0
-61.0	10.5
-61.0	11.0

ZETA POTENTIAL DATA FOR PARTICLE 2:  
 ZETA POTENTIAL VALUES:           CORESPONDING PH VALUES:

44.0	2.9
38.9	4.0
29.4	5.0
9.1	6.1
-24.0	7.1
-33.0	8.0
-43.0	9.0
-43.0	10.0
-45.0	11.0

## CALCULATED OVERALL STABILITY RATIO DATA:

OVERALL STABILITY RATIO:

(W11,W12,W22,WT)

CORESPONDING PH

VALUES:

.4761+303,	.2738E+00,	.4336+302,	.1825E+03	4.00
.4761+303,	.2738E+00,	.4336+302,	.1825E+03	4.50
.4761+303,	.2738E+00,	.4336+302,	.1825E+03	5.00
.4761+303,	.2738E+00,	.7502+144,	.1825E+03	5.50
.4761+303,	.2738E+00,	.6674E+00,	.6660E+00	6.00
.4761+303,	.2738E+00,	.4998E+00,	.4992E+00	6.50
.4761+303,	.9751E-07,	.5189+181,	.6499E-04	7.00
.4761+303,	.2597+303,	.4336+302,	.4341+302	7.50
.4761+303,	.2597+303,	.4336+302,	.4341+302	8.00
.4761+303,	.2597+303,	.4336+302,	.4341+302	8.50
.4761+303,	.2597+303,	.4336+302,	.4341+302	9.00
.4761+303,	.2597+303,	.4336+302,	.4341+302	9.50
.4761+303,	.2597+303,	.4336+302,	.4341+302	10.00
.4761+303,	.2597+303,	.4336+302,	.4341+302	10.50
.4761+303,	.2597+303,	.4336+302,	.4341+302	11.00

FILE NAME:SS223SD\BSS223SD  
 FILE DESCRIPTION: RUN USING BNHTFWVB.EXE.  
 THIS DATA WAS AQUIRED ON: 07/08/1992  
 AQUISITION BY THE PROGRAM STARTED AT... 01:17:28:56  
 AND FINISHED AT... 01:48:04:33  
 VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500  
 CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100  
 ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 900.0  
 ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0  
 TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0  
 HAMAKER CONSTANT OF MEDIUM = .45E-19  
 HAMAKER CONSTANT OF COMPONENT 1 = .30E-18  
 HAMAKER CONSTANT OF COMPONENT 2 = .16E-18  
 ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.  
 ZETA POTENTIAL DATA FOR PARTICLE 1:  
 ZETA POTENTIAL VALUES:           CORESPONDING PH VALUES:

5.8	2.0
-2.2	2.5
-15.0	3.0
-26.0	3.5
-34.0	4.0
-40.0	4.5
-44.0	5.0
-48.0	5.5
-51.0	6.0
-53.0	6.5
-54.0	7.0
-56.0	7.5
-57.0	8.0
-58.0	8.5
-59.0	9.0
-60.0	9.5
-60.0	10.0
-61.0	10.5
-61.0	11.0

ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES:           CORESPONDING PH VALUES:

44.0	2.9
38.9	4.0
29.4	5.0
9.1	6.1
-24.0	7.1
-33.0	8.0
-43.0	9.0
-43.0	10.0
-45.0	11.0

## CALCULATED OVERALL STABILITY RATIO DATA:

OVERALL STABILITY RATIO: (W11,W12,W22,WT)			CORESPONDING PH VALUES:	
.1185E+85,	.2926E+00,	.1105E+77,	.7121E+01	4.00
.1126+168,	.2926E+00,	.1257E+55,	.7121E+01	4.50
.7627+235,	.2926E+00,	.4842E+36,	.7121E+01	5.00
.1559+303,	.2926E+00,	.9557E+09,	.7121E+01	5.50
.1559+303,	.2926E+00,	.5053E+00,	.4909E+00	6.00
.1559+303,	.2926E+00,	.4998E+00,	.4859E+00	6.50
.1559+303,	.1057E+12,	.4468E+13,	.1658E+13	7.00
.1559+303,	.1524E+39,	.4563E+31,	.4760E+31	7.50
.1559+303,	.4540E+63,	.7460E+49,	.7783E+49	8.00
.1559+303,	.9818E+91,	.6029E+72,	.6290E+72	8.50
.1559+303,	.7745+122,	.6955E+99,	.7257E+99	9.00
.1559+303,	.4593+127,	.3959+101,	.4131+101	9.50
.1559+303,	.4593+127,	.3959+101,	.4131+101	10.00
.1559+303,	.7530+136,	.4755+107,	.4961+107	10.50
.1559+303,	.1342+143,	.8488+113,	.8855+113	11.00

FILE NAME:SS223ES\BSS223es  
 FILE DESCRIPTION: RUN USING BNHTFWVB.EXE.  
 THIS DATA WAS AQUIED ON: 07/08/1992  
 AQUISITION BY THE PROGRAM STARTED AT... 16:38:17:89  
 AND FINISHED AT... 18:02:57:18  
 OVERALL PROPORTION OF COMPONENT 1 IN SYSTEM =.500  
 CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100  
 ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 900.0  
 ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0  
 TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0  
 HAMAKER CONSTANT OF MEDIUM = .45E-19  
 HAMAKER CONSTANT OF COMPONENT 1 = .30E-18  
 HAMAKER CONSTANT OF COMPONENT 2 = .16E-18  
 ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.  
 ZETA POTENTIAL DATA FOR PARTICLE 1:  
 ZETA POTENTIAL VALUES:                      CORESPONDING PH VALUES:

-10.0	4.0
-11.0	4.1
-12.0	4.2
-13.0	4.3
-14.0	4.4
-15.0	4.5
-16.0	4.6
-17.0	4.7
-18.0	4.8
-19.0	4.8
-20.0	5.0
-21.0	5.0
-22.0	5.1
-22.0	5.3
-23.0	5.3
-24.0	5.4
-25.0	5.5
-25.0	5.6
-27.0	5.7
-29.0	5.8
-30.0	6.0
-31.0	6.1
-32.0	6.2
-33.0	6.3
-35.0	6.4
-36.0	6.5
-36.0	6.6
-37.0	6.7
-38.0	6.9
-39.0	7.0
-39.0	7.1
-40.0	7.2
-41.0	7.3
-42.0	7.4
-43.0	7.5
-43.0	7.6

-44.0	7.7
-45.0	7.8
-47.0	7.9
-48.0	8.0
-49.0	8.1
-49.0	8.2
-51.0	8.3
-50.0	8.4
-51.0	8.4
-52.0	8.5
-53.0	8.6
-53.0	8.7
-55.0	8.8
-54.0	8.8
-55.0	8.9
-55.0	8.9
-55.0	9.1
-56.0	9.1
-57.0	9.3
-57.0	9.3
-57.0	9.5
-59.0	9.6
-59.0	9.6
-59.0	9.8
-61.0	10.0
-61.0	10.1
-62.0	10.2
-63.0	10.3
-63.0	10.4
-64.0	10.6
-65.0	10.7
-68.0	10.8
-70.0	11.1
-70.0	11.1

## ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES:

CORRESPONDING PH VALUES:

8.0	3.9
8.0	4.0
7.8	4.1
7.5	4.2
7.4	4.3
7.0	4.4
6.8	4.6
6.6	4.7
6.4	4.8
6.1	4.9
5.7	5.0
5.5	5.1
5.4	5.1
5.2	5.2
4.8	5.3
4.4	5.4

4.1	5.5
3.8	5.7
3.3	5.8
2.7	5.9
2.1	6.1
1.5	6.2
.8	6.3
.2	6.4
-.7	6.6
-1.5	6.7
-2.3	6.8
-2.9	6.9
-3.5	7.0
-4.0	7.2
-4.4	7.3
-4.8	7.5
-5.2	7.8
-5.3	8.0
-5.5	8.2
-5.7	8.4
-5.9	8.6
-6.0	8.7
-6.2	8.8
-6.2	8.9
-6.5	8.9
-6.5	9.0
-6.7	9.1
-6.9	9.2
-7.0	9.3
-7.1	9.4
-7.1	9.5
-7.3	9.6
-7.5	9.7
-7.5	9.8
-7.7	9.9
-7.7	9.9
-8.0	10.1
-8.0	10.2
-8.1	10.3
-8.5	10.4
-8.6	10.5
-8.9	10.6
-8.9	10.7
-9.4	10.8
-9.6	10.9
-9.7	11.0
-10.0	11.1

## CALCULATED OVERALL STABILITY RATIO DATA:

OVERALL STABILITY RATIO: (W11,W12,W22,WT)			CORESPONDING PH VALUES:	
.2285E+00,	.2926E+00,	.5009E+00,	.4865E+00	4.00
.2285E+00,	.2926E+00,	.5004E+00,	.4860E+00	4.50
.2285E+00,	.2926E+00,	.5000E+00,	.4856E+00	5.00
.1357E+02,	.2926E+00,	.4997E+00,	.4858E+00	5.50
.1510E+46,	.2926E+00,	.4994E+00,	.4856E+00	6.00
.8030+108,	.2926E+00,	.4993E+00,	.4855E+00	6.50
.4518+152,	.2926E+00,	.4996E+00,	.4857E+00	7.00
.3056+214,	.2926E+00,	.4998E+00,	.4859E+00	7.50
.1559+303,	.2926E+00,	.4999E+00,	.4860E+00	8.00
.1559+303,	.2926E+00,	.5000E+00,	.4861E+00	8.50
.1559+303,	.2926E+00,	.5003E+00,	.4863E+00	9.00
.1559+303,	.2926E+00,	.5005E+00,	.4865E+00	9.50
.1559+303,	.2926E+00,	.5009E+00,	.4868E+00	10.00
.1559+303,	.2926E+00,	.5014E+00,	.4873E+00	10.50
.1559+303,	.2926E+00,	.5027E+00,	.4885E+00	11.00



FILE NAME:SS223CC\BSS2223CC  
 FILE DESCRIPTION: RUN USING BNHTFWVB.EXE.  
 THIS DATA WAS AQUIRED ON: 07/08/1992  
 AQUISITION BY THE PROGRAM STARTED AT... 11:51:46:16  
 AND FINISHED AT... 12:22:28:47  
 VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500  
 CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100  
 ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 900.0  
 ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0  
 TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0  
 HAMAKER CONSTANT OF MEDIUM = .45E-19  
 HAMAKER CONSTANT OF COMPONENT 1 = .30E-18  
 HAMAKER CONSTANT OF COMPONENT 2 = .16E-18  
 ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.  
 ZETA POTENTIAL DATA FOR PARTICLE 1:  
 ZETA POTENTIAL VALUES: CORESPONDING PH VALUES:

5.8	2.0
-2.2	2.5
-15.0	3.0
-26.0	3.5
-34.0	4.0
-40.0	4.5
-44.0	5.0
-48.0	5.5
-51.0	6.0
-53.0	6.5
-54.0	7.0
-56.0	7.5
-57.0	8.0
-58.0	8.5
-59.0	9.0
-60.0	9.5
-60.0	10.0
-61.0	10.5
-61.0	11.0

ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES: CORESPONDING PH VALUES:

44.0	2.9
38.9	4.0
29.4	5.0
9.1	6.1
-24.0	7.1
-33.0	8.0
-43.0	9.0
-43.0	10.0
-45.0	11.0

## CALCULATED OVERALL STABILITY RATIO DATA:

OVERALL STABILITY RATIO:

CORESPONDING PH

(W11,W12,W22,WT)

VALUES:

.1559+303,	.2926E+00,	.4336+302,	.7121E+01	4.00
.1559+303,	.2926E+00,	.4336+302,	.7121E+01	4.50
.1559+303,	.2926E+00,	.4336+302,	.7121E+01	5.00
.1559+303,	.2926E+00,	.7502+144,	.7121E+01	5.50
.1559+303,	.2926E+00,	.6674E+00,	.6343E+00	6.00
.1559+303,	.2450+161,	.4998E+00,	.5215E+00	6.50
.1559+303,	.9961+302,	.5189+181,	.5414+181	7.00
.1559+303,	.9961+302,	.4336+302,	.4440+302	7.50
.1559+303,	.9961+302,	.4336+302,	.4440+302	8.00
.1559+303,	.9961+302,	.4336+302,	.4440+302	8.50
.1559+303,	.9961+302,	.4336+302,	.4440+302	9.00
.1559+303,	.9961+302,	.4336+302,	.4440+302	9.50
.1559+303,	.9961+302,	.4336+302,	.4440+302	10.00
.1559+303,	.9961+302,	.4336+302,	.4440+302	10.50
.1559+303,	.9961+302,	.4336+302,	.4440+302	11.00

FILE NAME:SS233SD\BSS233SD

FILE DESCRIPTION: RUN USING BMTHFWVB.EXE.

THIS DATA WAS AQUIRED ON: 07/08/1992

AQUISITION BY THE PROGRAM STARTED AT... 01:48:06:04

AND FINISHED AT... 02:12:19:64

VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500

CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100

ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 400.0

ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0

TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0

HAMAKER CONSTANT OF MEDIUM = .45E-19

HAMAKER CONSTANT OF COMPONENT 1 = .30E-18

HAMAKER CONSTANT OF COMPONENT 2 = .16E-18

ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.

ZETA POTENTIAL DATA FOR PARTICLE 1:

ZETA POTENTIAL VALUES: CORESPONDING PH VALUES:

5.8	2.0
-2.2	2.5
-15.0	3.0
-26.0	3.5
-34.0	4.0
-40.0	4.5
-44.0	5.0
-48.0	5.5
-51.0	6.0
-53.0	6.5
-54.0	7.0
-56.0	7.5
-57.0	8.0
-58.0	8.5
-59.0	9.0
-60.0	9.5
-60.0	10.0
-61.0	10.5
-61.0	11.0

ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES: CORESPONDING PH VALUES:

44.0	2.9
38.9	4.0
29.4	5.0
9.1	6.1
-24.0	7.1
-33.0	8.0
-43.0	9.0
-43.0	10.0
-45.0	11.0

CALCULATED OVERALL STABILITY RATIO DATA:  
OVERALL STABILITY RATIO:

(W11,W12,W22,WT)

CORRESPONDING PH  
VALUES:

.1765E+40,	.3193E+00,	.1105E+77,	.1012E+01	4.00
.1920E+77,	.3193E+00,	.1257E+55,	.1012E+01	4.50
.3301+107,	.3193E+00,	.4842E+36,	.1012E+01	5.00
.1497+142,	.3193E+00,	.9557E+09,	.1012E+01	5.50
.1161+171,	.3193E+00,	.5053E+00,	.4412E+00	6.00
.5052+191,	.3194E+00,	.4998E+00,	.4385E+00	6.50
.2729+202,	.1514E+29,	.4468E+13,	.6917E+13	7.00
.5347+224,	.7590E+55,	.4563E+31,	.7062E+31	7.50
.1938+236,	.1654E+79,	.7460E+49,	.1155E+50	8.00
.1324+248,	.4834+105,	.6029E+72,	.9332E+72	8.50
.1707+260,	.1116+134,	.6955E+99,	.1077+100	9.00
.4147+272,	.1254+138,	.3959+101,	.6128+101	9.50
.4147+272,	.1254+138,	.3959+101,	.6128+101	10.00
.1900+285,	.1611+146,	.4755+107,	.7360+107	10.50
.1900+285,	.8486+151,	.8488+113,	.1314+114	11.00

FILE NAME:SS233ES\BSS233ES  
 FILE DESCRIPTION: RUN USING BMTHFWVB.EXE.  
 THIS DATA WAS AQUIED ON: 07/08/1992  
 AQUISITION BY THE PROGRAM STARTED AT... 09:27:50:39  
 AND FINISHED AT... 11:04:35:90  
 VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500  
 CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100  
 ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 400.0  
 ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0  
 TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0  
 HAMAKER CONSTANT OF MEDIUM = .45E-19  
 HAMAKER CONSTANT OF COMPONENT 1 = .30E-18  
 HAMAKER CONSTANT OF COMPONENT 2 = .16E-18  
 ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.  
 ZETA POTENTIAL DATA FOR PARTICLE 1:  
 ZETA POTENTIAL VALUES: CORESPONDING PH VALUES:

-2.2	4.0
-2.6	4.1
-2.9	4.2
-3.2	4.3
-3.6	4.4
-3.9	4.5
-4.5	4.6
-4.7	4.7
-5.0	4.8
-5.3	4.9
-5.5	5.0
-6.0	5.1
-6.3	5.2
-6.4	5.2
-6.6	5.3
-6.9	5.4
-7.2	5.5
-7.3	5.6
-7.4	5.6
-7.7	5.7
-8.0	5.8
-8.1	5.8
-8.2	5.9
-8.6	6.0
-8.8	6.1
-8.9	6.1
-9.1	6.2
-9.3	6.3
-9.5	6.3
-9.8	6.4
-10.0	6.5
-10.0	6.6
-10.0	6.7
-11.0	6.8
-11.0	6.8
-11.0	6.9

-11.0	7.0
-12.0	7.1
-12.0	7.2
-12.0	7.2
-12.0	7.3
-13.0	7.4
-13.0	7.4
-13.0	7.5
-13.0	7.6
-14.0	7.6
-14.0	7.7
-14.0	7.8
-14.0	7.8
-15.0	7.9
-15.0	8.0
-15.0	8.0
-15.0	8.1
-15.0	8.1
-15.0	8.2
-15.0	8.3
-16.0	8.3
-16.0	8.4
-16.0	8.5
-16.0	8.6
-16.0	8.7
-17.0	8.8
-17.0	8.9
-17.0	9.0
-17.0	9.1
-17.0	9.2
-17.0	8.3
-17.0	9.4
-18.0	9.5
-18.0	9.6
-18.0	9.7
-18.0	9.9
-18.0	9.9
-19.0	10.0
-19.0	10.1
-19.0	10.2
-19.0	10.4
-20.0	10.5
-20.0	10.6
-21.0	10.7
-21.0	10.9
-21.0	11.0
-21.0	11.1

## ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES:      CORRESPONDING PH VALUES:

8.0	3.9
8.0	4.0
7.8	4.1
7.5	4.2
7.4	4.3
7.0	4.4
6.8	4.6
6.6	4.7
6.4	4.8
6.1	4.9
5.7	5.0
5.5	5.1
5.4	5.1
5.2	5.2
4.8	5.3
4.4	5.4
4.1	5.5
3.8	5.7
3.3	5.8
2.7	5.9
2.1	6.1
1.5	6.2
.8	6.3
.2	6.4
-.7	6.6
-1.5	6.7
-2.3	6.8
-2.9	6.9
-3.5	7.0
-4.0	7.2
-4.4	7.3
-4.8	7.5
-5.2	7.8
-5.3	8.0
-5.5	8.2
-5.7	8.4
-5.9	8.6
-6.0	8.7
-6.2	8.8
-6.2	8.9
-6.5	8.9
-6.5	9.0
-6.7	9.1
-6.9	9.2
-7.0	9.3
-7.1	9.4
-7.1	9.5
-7.3	9.6
-7.5	9.7
-7.5	9.8

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-7.7	9.9
-7.7	9.9
-8.0	10.1
-8.0	10.2
-8.1	10.3
-8.5	10.4
-8.6	10.5
-8.9	10.6
-8.9	10.7
-9.4	10.8
-9.6	10.9
-9.7	11.0
-10.0	11.1



## CALCULATED OVERALL STABILITY RATIO DATA:

OVERALL STABILITY RATIO:

(W11,W12,W22,WT)

CORESPONDING PH  
VALUES:

.2293E+00,	.3193E+00,	.5009E+00,	.4089E+00	4.00
.2293E+00,	.3193E+00,	.5004E+00,	.4087E+00	4.50
.2293E+00,	.3193E+00,	.5000E+00,	.4085E+00	5.00
.2293E+00,	.3193E+00,	.4997E+00,	.4084E+00	5.50
.2293E+00,	.3193E+00,	.4994E+00,	.4083E+00	6.00
.2293E+00,	.3193E+00,	.4993E+00,	.4082E+00	6.50
.2293E+00,	.3193E+00,	.4996E+00,	.4083E+00	7.00
.2293E+00,	.3193E+00,	.4998E+00,	.4084E+00	7.50
.2293E+00,	.3193E+00,	.4999E+00,	.4085E+00	8.00
.2293E+00,	.3193E+00,	.5000E+00,	.4085E+00	8.50
.2293E+00,	.3193E+00,	.5003E+00,	.4086E+00	9.00
.2293E+00,	.3193E+00,	.5005E+00,	.4088E+00	9.50
.2293E+00,	.3193E+00,	.5009E+00,	.4089E+00	10.00
.2293E+00,	.3193E+00,	.5014E+00,	.4091E+00	10.50
.2293E+00,	.3193E+00,	.5027E+00,	.4097E+00	11.00

FILE NAME:SS233CC\BSS233CC  
 FILE DESCRIPTION: RUN USING BMTHFWVB.EXE.  
 THIS DATA WAS AQUIED ON: 07/08/1992  
 AQUISITION BY THE PROGRAM STARTED AT... 12:22:30:01  
 AND FINISHED AT... 12:49:50:91  
 VOLUME FRACTION OF COMPONENT 1 IN SYSTEM =.500  
 CONCENTRATION OF 1-1 ELECTROLYTE IN SYSTEM = .00100  
 ATOMIC PARTICLE RADIUS OF COMPONENT 1 = 400.0  
 ATOMIC PARTICLE RADIUS OF COMPONENT 2 = 250.0  
 TEMPERATURE OF SYSTEM (IN DEG. C.) = 25.0  
 HAMAKER CONSTANT OF MEDIUM = .45E-19  
 HAMAKER CONSTANT OF COMPONENT 1 = .30E-18  
 HAMAKER CONSTANT OF COMPONENT 2 = .16E-18  
 ZETA POTENTIAL DATA WAS USED FOR CALCULATIONS.  
 ZETA POTENTIAL DATA FOR PARTICLE 1:  
 ZETA POTENTIAL VALUES:                      CORESPONDING PH VALUES:

5.8	2.0
-2.2	2.5
-15.0	3.0
-26.0	3.5
-34.0	4.0
-40.0	4.5
-44.0	5.0
-48.0	5.5
-51.0	6.0
-53.0	6.5
-54.0	7.0
-56.0	7.5
-57.0	8.0
-58.0	8.5
-59.0	9.0
-60.0	9.5
-60.0	10.0
-61.0	10.5
-61.0	11.0

ZETA POTENTIAL DATA FOR PARTICLE 2:

ZETA POTENTIAL VALUES:	CORESPONDING PH VALUES:
44.0	2.9
38.9	4.0
29.4	5.0
9.1	6.1
-24.0	7.1
-33.0	8.0
-43.0	9.0
-43.0	10.0
-45.0	11.0

## CALCULATED OVERALL STABILITY RATIO DATA:

OVERALL STABILITY RATIO: (W11,W12,W22,WT)			CORESPONDING PH VALUES:	
.6932+302,	.3193E+00,	.4336+302,	.1012E+01	4.00
.6932+302,	.3193E+00,	.4336+302,	.1012E+01	4.50
.6932+302,	.3193E+00,	.4336+302,	.1012E+01	5.00
.6932+302,	.3193E+00,	.7502+144,	.1012E+01	5.50
.6932+302,	.3193E+00,	.6674E+00,	.5113E+00	6.00
.6932+302,	.2417+283,	.4998E+00,	.7737E+00	6.50
.6932+302,	.5634+302,	.5189+181,	.8032+181	7.00
.6932+302,	.5634+302,	.4336+302,	.4750+302	7.50
.6932+302,	.5634+302,	.4336+302,	.4750+302	8.00
.6932+302,	.5634+302,	.4336+302,	.4750+302	8.50
.6932+302,	.5634+302,	.4336+302,	.4750+302	9.00
.6932+302,	.5634+302,	.4336+302,	.4750+302	9.50
.6932+302,	.5634+302,	.4336+302,	.4750+302	10.00
.6932+302,	.5634+302,	.4336+302,	.4750+302	10.50
.6932+302,	.5634+302,	.4336+302,	.4750+302	11.00

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